

MPC5645S



Qorivva MPC5645S Microcontroller Data Sheet

The Qorivva MPC5645S represents a new generation of 32-bit microcontrollers targeting single-chip automotive instrument cluster applications. MPC5645S devices are part of the MPC56xxS family of Power Architecture®-based devices. This family has been designed with an emphasis on providing cost-effective and high quality graphics capabilities in order to satisfy the increasing market demand for color Thin Film Transistor (TFT) displays within the vehicle cockpit. Traditional cluster functions, such as gauge drive, real time counter, and sound generation are also integrated on each device.

Devices in the MPC56xxS family contain between 256 KB and 2 MB internal flash memory. The family allows for easy expansion and covers a broad range of cluster applications from low to high-end enabling users to design a complete platform around one common architecture. Serial flash memory and DRAM interfaces are provided to allow even greater system flexibility.

The MPC5645S is designed to reduce development and production costs of TFT-based instrument cluster displays by providing a single-chip solution with the processing and storage capacity to host and execute real-time application software and drive TFT displays directly.

The MPC5645S features a 2D OpenVG graphics accelerator, Video Input Unit (VIU2) and two on-chip display control units (DCU3 and DCULite) designed to drive two color TFT displays simultaneously. The MPC5645S includes an enhanced QuadSPI Serial Flash Controller and an optional DRAM controller allowing graphics RAM expansion externally.

The MPC5645S is compatible with the existing development infrastructure of current Power Architecture devices and are supported with software drivers, operating systems and configuration code to assist with application development.

| | | |
|------|--|-----|
| 1 | Overview | 2 |
| 1.1 | Device comparison | 2 |
| 1.2 | Block diagram | 4 |
| 1.3 | Feature list | 5 |
| 1.4 | Feature details | 7 |
| 2 | Pinout and signal descriptions | 24 |
| 2.1 | 176 LQFP package pinout | 24 |
| 2.2 | 208 LQFP package pinout | 25 |
| 2.3 | 416 TEPBGA package pinout | 26 |
| 2.4 | Signal description | 27 |
| 3 | System design information | 59 |
| 3.1 | Power-up sequencing | 59 |
| 4 | Electrical characteristics | 59 |
| 4.1 | Introduction | 59 |
| 4.2 | Parameter classification | 60 |
| 4.3 | Absolute maximum ratings | 60 |
| 4.4 | Recommended operating conditions | 61 |
| 4.5 | Thermal characteristics | 63 |
| 4.6 | EMI (electromagnetic interference) characteristics | 68 |
| 4.7 | Power management | 68 |
| 4.8 | DC electrical specifications | 73 |
| 4.9 | RESET electrical characteristics | 81 |
| 4.10 | Fast external crystal oscillator (4–16 MHz) electrical characteristics | 84 |
| 4.11 | Slow external crystal oscillator (32 KHz) electrical characteristics | 85 |
| 4.12 | FMPLL electrical characteristics | 86 |
| 4.13 | Fast internal RC oscillator (16 MHz) electrical characteristics | 87 |
| 4.14 | Slow internal RC oscillator (128 kHz) electrical characteristics | 87 |
| 4.15 | Flash memory electrical characteristics | 88 |
| 4.16 | ADC parameters | 88 |
| 4.17 | AC specifications | 95 |
| 4.18 | AC timing | 101 |
| 5 | Package mechanical data | 130 |
| 5.1 | 176 LQFP | 131 |
| 5.2 | 208 LQFP | 133 |
| 5.3 | 416 TEPBGA | 137 |
| 6 | Ordering information | 139 |
| 7 | Revision history | 140 |

This document contains information on a product under development. Freescale reserves the right to change or discontinue this product without notice.

1 Overview

1.1 Device comparison

Table 1. MPC5645S device comparison

| Feature | MPC5645S | | |
|---|--|---------------------|------------|
| Package | 176 LQFP | 208 LQFP | 416 TEPBGA |
| CPU | e200z4d 4 KB Instruction-Cache 16-entry Memory Management Unit (MMU) Floating Point Unit (FPU) Signal Processing Extension (SPE) | | |
| Execution speed | Static-125 MHz | | |
| Flash memory (ECC) | 2 MB | | |
| RAM (ECC) | 64 KB | | |
| On-chip graphics RAM (no ECC) | 1 MB | | |
| MPU | 16 entry | | |
| eDMA | 16 channels | | |
| DRAM controller | No | | Yes |
| OpenVG Graphics Accelerator (GFX2D) | Yes (OpenVG 1.1) | | |
| Display Control Unit (DCU3) | Yes | | |
| Display Control Unit Lite (DCULite) | No | Yes | |
| Timing Controller (TCON) and RSDS interface | No | Yes | |
| Video Input Unit (VIU2) | Yes | | |
| QuadSPI serial flash interface | Yes | | |
| Stepper Motor Controller (SMC) | 4 motors | 6 motors | |
| Stepper Stall Detect (SSD) | Yes | | |
| Sound Generator Module (SGM) | Yes | | |
| 32 kHz external crystal oscillator | Yes | | |
| Real Time Counter and Autonomous Periodic Interrupt (RTC/API) | Yes | | |
| Periodic interrupt timer (PIT) | 8 ch, 32-bit | | |
| Software Watchdog Timer (SWT) | Yes | | |
| System Timer Module (STM) | 4 ch, 32-bit | | |
| Timed I/O ¹ | 20 ch, 16-bit: IC / OC / OPWM 8 ch, 16-bit: IC / OC 4 ch, 16-bit: IC / OC / OPWM / QDEC | | |
| Analog-to-Digital Converter (ADC) ² | 16 channels, 10-bit | 20 channels, 10-bit | |

Table 1. MPC5645S device comparison (continued)

| Feature | MPC5645S | | |
|--------------------------------|------------------------------------|-------------|------------------------|
| | 176 LQFP | 208 LQFP | 416 TEPBGA |
| Package | 176 LQFP | 208 LQFP | 416 TEPBGA |
| CAN (64 mailboxes) | 3 x FlexCAN | | |
| CAN sampler | Yes | | |
| Serial communication interface | 3 x LINFlex | 4 x LINFlex | |
| SPI | 2 x DSPI | 3 x DSPI | |
| I ² C | 4 | | |
| GPIO | 128 | 150 | 177 ³ |
| Debug | Nexus Class 3 (4×MDO) ⁴ | | Nexus Class 3 (12×MDO) |

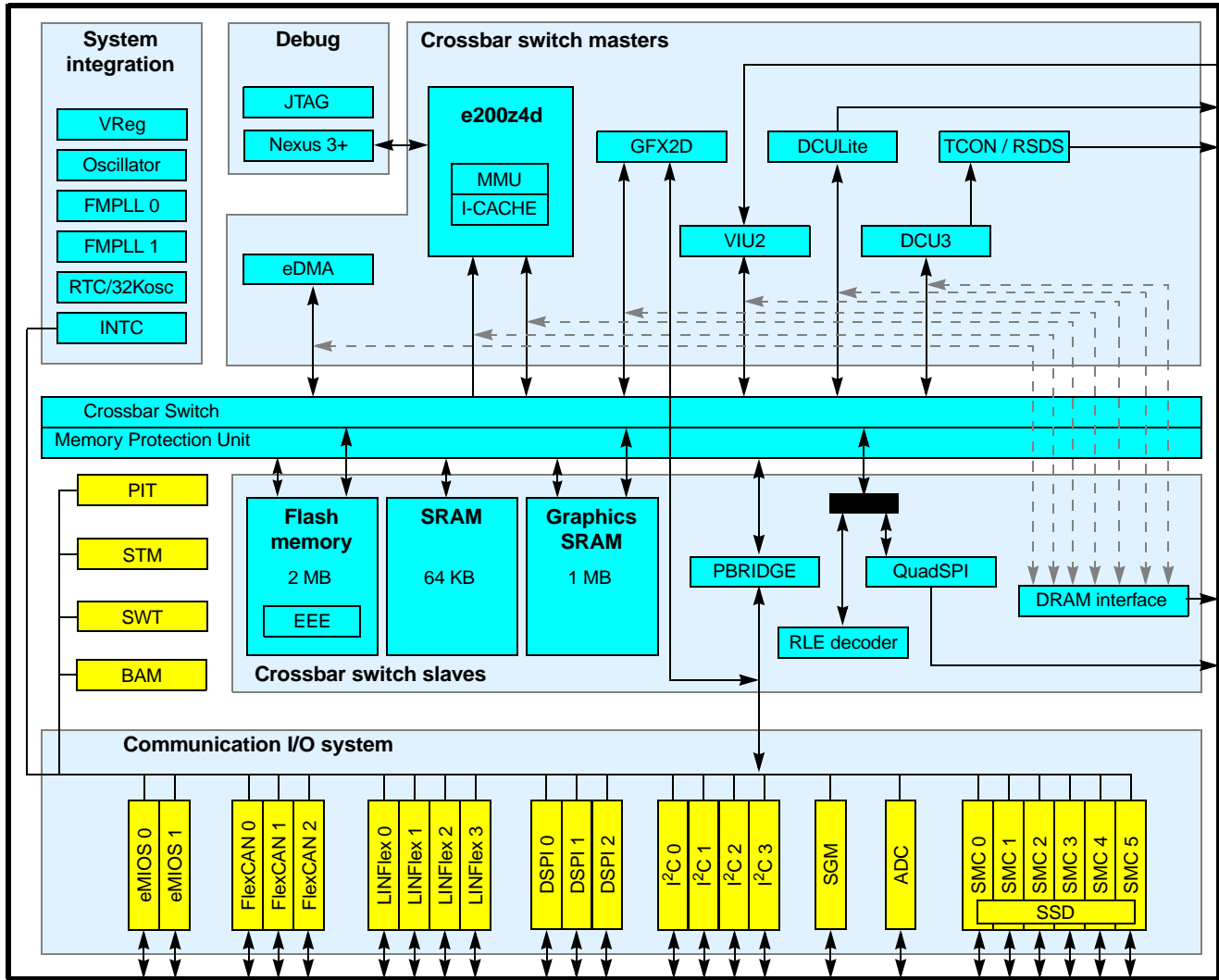
¹ IC-Input Capture, OC-Output Compare, OPWM-Output Pulse Width Modulation, QDEC- Quadrature Decode Mode.

² Support for external multiplexer enabling up to 8 channels.

³ The 416-pin GPIO count does not include the DRAM interface, which is dedicated to DRAM only.

⁴ Nexus pins are multiplexed with other functional pins on 176 LQFP and 208 LQFP package options.

1.2 Block diagram



| | | | |
|----------------|--|----------------|---|
| ADC | – Analog-to-Digital Converter | PBRIDGE | – Peripheral Bridge |
| BAM | – Boot Assist Module | PIT | – Periodic Interrupt Timer |
| eDMA | – Enhanced Direct Memory Access Controller | RLE | – Run Length Encoding |
| DCU3 | – Display Control Unit | RSDS | – Reduced-Swing Differential Signal interface |
| DCULite | – Display Control Unit Lite | RTC | – Real Time Clock |
| DSPI | – Serial Peripherals Interface | SGM | – Sound Generator Module |
| eMIOS | – Enhanced Modular Input/Output System | SMC | – Stepper Motor Controller |
| FlexCAN | – Controller Area Network Controller | SSD | – Stepper Stall Detect |
| FMPLL | – Frequency-Modulated Phase-Locked Loop | STM | – System Timer Module |
| GFX2D | – OpenVG Graphics Accelerator | SWT | – Software Watchdog Timer |
| INTC | – Interrupt Controller | TCON | – Timing Controller |
| JTAG | – Joint Test Action Group interface | VIU2 | – Video Input Unit |
| MMU | – Memory Management Unit | VReg | – Voltage regulator |
| QuadSPI | – Quad IO serial flash interface | | |

Figure 1. MPC5645S block diagram

1.3 Feature list

- Dual-issue, 32-bit Power Architecture Book E compliant CPU core complex (e200z4d)
 - Memory Management Unit (MMU)
 - 4 KB, 2/4-way instruction cache
- 2 MB on-chip ECC flash memory with:
 - Flash memory controller
 - Prefetch buffers
- 64 KB on-chip ECC SRAM
- 1 MB on-chip non-ECC graphics SRAM with two-port graphics SRAM controller
- Memory Protection Unit (MPU) with up to 16 region descriptors and 32-byte region granularity to provide basic memory access permission and ensure separation between different codes and data
- Interrupt Controller (INTC) with 181 peripheral interrupt sources and eight software interrupts
- Two Frequency-Modulated Phase-Locked Loops (FMPLLs)
 - Primary FMPLL (FMPLL0) provides a system clock up to 125 MHz
 - Auxiliary FMPLL (FMPLL1) is available for use as an alternate, modulated or non-modulated clock source to eMIOS modules, QuadSPI and as alternate clock to the DCU and DCU-Lite for pixel clock generation
- Crossbar switch architecture enables concurrent access of peripherals, flash memory or RAM from multiple bus masters
- 16-channel Enhanced Direct Memory Access controller (eDMA) with multiple transfer request sources using a DMA channel multiplexer
- Boot Assist Module (BAM) with 8 KB dedicated ROM for embedded boot code supports boot options including download of boot code via a serial link (CAN or SCI)
- Two Display Control Units (DCU3 and DCULite) for direct drive of up to two TFT LCD displays up to XGA resolution
- Timing Controller (TCON) and RSDS interface for the DCU3 module
- 2D OpenVG 1.1 and raster graphics accelerator (GFX2D)
- Video Input Unit (VIU2) supporting 8/10-bit ITU656 video input, YUV to RGB conversion, video down-scaling, de-interlacing, contrast adjustment and brightness adjustment.
- DRAM controller supporting DDR1, DDR2, and LPDDR1 DRAMs
- Stepper Motor Controller (SMC)
 - High-current drivers for up to six instrument cluster gauges driven in full dual H-bridge configuration
 - Stepper motor return-to-zero and stall detection module
 - Stepper motor short circuit detection
- Sound Generator Module (SGM)
 - 4-channel mixer
 - Supports PCM wave playback and synthesized tones
 - Optional PWM or I²S outputs
- Two 16-channel Enhanced Modular Input Output System (eMIOS) modules
 - Support a range of 16-bit Input Capture, Output Compare, Pulse Width Modulation and Quadrature Decode functions
- 10-bit Analog-to-Digital Converter (ADC) with a maximum conversion time of 1 μ s
 - Up to 20 internal channels
 - Up to 8 external channels
- Three Deserial Serial Peripheral Interface (DSPI) modules for full-duplex, synchronous, communications with external devices
- QuadSPI serial flash memory controller

- Supports single, dual and quad IO serial flash memory
- Interfaces to external, memory-mapped serial flash memories
- Supports simultaneous addressing of 2 external serial flashes to achieve up to 80 MB/s read bandwidth
- RLE decoder supporting memory to memory decoding of RLE data in conjunction with eDMA
- Four local interconnect network (LINFlex) controller modules
 - Capable of autonomous message handling (master), autonomous header handling (slave mode), and UART support
 - Compliant with LIN protocol rev 2.1
- Three controller-area network (FlexCAN) modules
 - Compliant with the CAN protocol version 2.0 C
 - 64 configurable buffers
 - Programmable bit rate of up to 1 Mb/s
- Four Inter-Integrated Circuit (I²C) internal bus controllers with master/slave bus interface
- Low-power loop controlled pierce crystal oscillator supporting 4–16MHz external crystal or resonator
- Real Time Counter (RTC) with clock source from internal 128 kHz or 16 MHz oscillator supporting autonomous wake-up with 1 ms resolution with maximum timeout of 2 seconds
 - Support for real time counter (RTC) with clock source from external 32 KHz crystal oscillator, supporting wake-up with 1 s resolution and maximum timeout of one hour
 - RTC optionally clocked by fast 4–16 MHz external oscillator
- System timers:
 - Four-channel 32-bit System Timer Module (STM)
 - Eight-channel 32-bit Periodic Interrupt Timer (PIT) module (including ADC trigger)
 - Software Watchdog Timer (SWT)
- System Integration Unit Lite (SIUL) module to manage external interrupts, GPIO and pad control
- System Status and Configuration Module (SSCM)
 - Provides information for identification of the device, last boot mode, or debug status
 - Provides an entry point for the censorship password mechanism
- Clock Generation Module (MC_CGM) to generate system clock sources and provide a unified register interface, enabling access to all clock sources
- Clock Monitor Unit (CMU)
 - Monitors the integrity of the fast (4–16 MHz) external crystal oscillator and the primary FMPLL (FMPLL0)
 - Acts as a frequency meter, measuring the frequency of one clock source and comparing it to a reference clock
- Mode Entry Module (MC_ME)
 - Controls the device power mode, i.e., RUN, HALT, STOP, or STANDBY
 - Controls mode transition sequences
 - Manages the power control, voltage regulator, clock generation and clock management modules
- Power Control Unit (MC_PCU) to implement standby mode entry/exit and control connections to power domains
- Reset Generation Module (MC_RGM) to manage reset assertion and release to the device at initial power-up
- Nexus Development Interface (NDI) per IEEE-ISTO 5001-2008 Class 3 standard with additional Class 4 features:
 - Watchpoint Triggering
 - Processor Overrun Control
- Device/board boundary-scan testing supported per Joint Test Action Group (JTAG) of IEEE (IEEE 1149.1)
- On-chip voltage regulator controller for regulating the 3.3–5 V supply voltage down to 1.2 V for core logic (requires external ballast transistor)
- Package:¹
 - 176 LQFP, 0.5 mm pitch, 24 mm × 24 mm outline

- 208 LQFP, 0.5 mm pitch, 28 mm × 28 mm outline
- 416 TEPBGA, 1mm ball pitch, 27 mm × 27 mm outline

1.4 Feature details

1.4.1 Low-power operation

The MPC5645S is designed for optimized low-power operation and dynamic power management of the CPU and peripherals. Power management features include software-controlled clock gating of peripherals and multiple power domains to minimize leakage in low-power modes.

There are three low-power modes:

- STANDBY
- STOP
- HALT

and five dynamic power modes — RUN[0..3] and DRUN. All low-power modes use clock gating to halt the clock for all or part of the device.

STANDBY mode turns off the power to the majority of the chip to offer the lowest power consumption mode.

The device can be awakened from STANDBY mode via from any of up to 23 I/O pins, a reset or from a periodic wake-up using a low power oscillator. If required, it is possible to enable the internal 16 MHz oscillator, the external 4–16 MHz oscillator, and the external 32 KHz oscillator.

In STANDBY mode the contents of the CPU, on-chip peripheral registers, and potentially some of the volatile memory are lost. The two possible configurations in STANDBY mode are:

- The device retains 64 KB of the on-chip SRAM, but the content of the graphics SRAM is lost.
- The device retains 8 KB of the on-chip SRAM, but the content of the graphics SRAM is lost.

STOP mode maintains power to the entire device allowing the retention of all on-chip registers and memory, and providing a faster recovery low power mode than the lowest-power STANDBY mode. There is no need to reconfigure the device before executing code. The clocks to the CPU and peripherals are halted and can be optionally stopped to the oscillator or PLL at the expense of a slower start-up time.

STOP is entered from RUN mode only. Wake-up from STOP mode is triggered by an external event or by the internal periodic wake-up, if enabled.

RUN modes are the main operating modes where the entire device can be powered and clocked and from which most processing activity is done. Four dynamic RUN modes are supported—RUN0 - RUN3. The ability to configure and select different RUN modes enables different clocks and power configurations to be supported with respect to each other and to allow switching between different operating conditions. The necessary peripherals, clock sources, clock speed, and system clock prescalers can be independently configured for each of the four RUN modes of the device.

HALT mode is a reduced activity, low power mode intended for moderate periods of lower processing activity. In this mode the CPU system clocks are stopped but user-selected peripheral tasks can continue to run. It can be configured to provide more efficient power management features (switch-off PLL, flash memory, main regulator, etc.) at the cost of longer wake up latency. The system returns to RUN mode as soon as an event or interrupt is pending.

[Table 2](#) summarizes the operating modes of the MPC5645S.

1. See the device comparison table for package offerings for each device in the family.

Table 2. Operating mode summary

| Operating mode | SoC features | | | | | | Clock sources | | | | | | Wake-up time ¹ | | | | | | | | |
|----------------|---|-------------|-------|------------------|--------------|-------------|---------------|-----------|-------------|------------|-------------|------------------|---------------------------|-----------|---------------|-------------|----------------|-------------------|----------|--------------|--------------------|
| | CPU GFX accelerator DRAM controller | Peripherals | Flash | SRAM | Graphics RAM | Primary PLL | Auxiliary PLL | 16MHz IRC | 4-16MHz OSC | 128KHz IRC | 32KHz X OSC | Periodic Wake-up | Wake-up input | VREG mode | VREG start-up | IRC Wake-up | Flash Recovery | OSC Stabilization | PLL Lock | S/W Reconfig | Mode switch over |
| RUN | On | OP | OP | OP ² | On | OP | OP | On | OP | On | OP | — | — | FP | — | — | — | — | — | — | — |
| HALT | CG | OP | OP | OP ² | On | OP | OP | On | OP | On | OP | OP | OP | FP | — | — | — | — | — | — | 30 μs ³ |
| STOP | CG | CG | CG | OP ² | CG | CG | CG | OP | OP | On | OP | OP | OP | LP | 350 μs | 4 μs | 20 μs | 1 ms | 200 μs | — | 30 μs ³ |
| STAN DBY | Off | Off | Off | 64K ⁴ | Off | Off | Off | OP | OP | On | OP | OP | OP | LP | 350 μs | 8 μs | 100 μs | 1 ms | 200 μs | Var | 28 μs |
| | Off | Off | Off | 8K ⁵ | Off | Off | Off | OP | OP | On | OP | OP | OP | LP | 200 μs | 8 μs | 100 μs | 1 ms | 200 μs | Var | 28 μs |
| POR | — | — | — | — | — | — | — | — | — | — | — | — | — | — | 500 μs | 8 μs | 100 μs | 1 ms | 200 μs | — | BAM ⁶ |

Table key:

- On — Powered and clocked
- OP — Optionally configurable to be enabled or disabled (clock gated)
- CG — Clock Gated, Powered but clock stopped
- Off — Powered off and clock gated
- FP — VREG Full Performance mode
- LP — VREG Low Power mode, reduced output capability of VREG but lower power consumption
- Var — Variable duration, based on the required reconfiguration and execution clock speed
- BAM — Boot Assist Module Software and Hardware used for device start-up and configuration

¹ A high level summary of some key durations that need to be considered when recovering from low power modes. This does not account for all durations at wake up. Other delays will be necessary to consider including, but not limited to the external supply start-up time.

IRC Wake-up time must not be added to the overall wake-up time as it starts in parallel with the VREG.

All other wake-up times must be added to determine the total start-up time.

² Either 64 KB or 8 KB available.

³ Flash configured in disabled mode.

⁴ 64 KB of the RAM contents is retained, but not accessible in STANDBY mode.

⁵ 8 KB of the RAM contents is retained, but not accessible in STANDBY mode.

⁶ Dependent on boot option after reset.

Additional notes on low power operation:

- Fast wake-up using the on-chip 16 MHz internal RC oscillator allows rapid execution from RAM on exit from low power modes
- The 16 MHz internal RC oscillator supports low speed code execution and clocking of peripherals when it is selected as the system clock and can also be used as the PLL input clock source to provide fast start-up without the external oscillator delay
- The device includes an internal voltage regulator that includes the following features:
 - Regulates input to generate all internal supplies
 - Manages power gating
 - External ballast transistor for high power regulator
 - Low-Power and Ultra-Low-Power regulators support operation when in STOP and STANDBY modes, respectively, to minimize power consumption

- Startup on-chip regulators in <math><350\mu\text{s}</math> for rapid exit of STOP and STANDBY modes
- Low voltage detection on main supply and 1.2 V regulated supplies

1.4.2 e200z4d core

The e200z4d Power Architecture[®] core provides the following features:

- Dual issue, 32-bit *Power Architecture Book E* compliant CPU
- Implements the VLE APU for reduced code footprint
- In-order execution and retirement
- Precise exception handling
- Branch processing unit
 - Dedicated branch address calculation adder
 - Branch target prefetching using 8-entry BTB
- Supports independent instruction and data accesses to different memory subsystems, such as SRAM and Flash memory via independent Instruction and Data BIUs.
- Load/store unit
 - 2 cycle load latency
 - Fully pipelined
 - Big and Little endian support
 - Misaligned access support
- 64-bit General Purpose Register file
- Dual AHB 2.v6 64-bit System buses
- Memory Management Unit (MMU) with 16-entry fully-associative TLB and multiple page size support
- 4 KB, 2/4-Way Set Associative Instruction Cache
- Signal Processing Extension (SPE1.1) APU supporting SIMD fixed-point operations using the 64-bit General Purpose Register file
- Embedded Floating-Point (EFP2) APU supporting scalar and vector SIMD single-precision floating-point operations, using the 64-bit General Purpose Register file
- Nexus Class 3 real-time Development Unit
- Dynamic power management of execution units, cache and MMU

1.4.3 Crossbar switch (XBAR)

The XBAR multi-port crossbar switch supports simultaneous connections between seven master ports and eight slave ports. The crossbar supports a 32-bit address bus width and a 64-bit data bus width.

The crossbar allows concurrent transactions to occur from any master port to any slave port but one of those transfers must be an instruction fetch from internal flash. If a slave port is simultaneously requested by more than one master port, arbitration logic selects the higher priority master and grants it ownership of the slave port. All other masters requesting that slave port are stalled until the higher priority master completes its transactions. Requesting masters having equal priority are granted access to a slave port in round-robin fashion, based upon the ID of the last master to be granted access.

The crossbar provides the following features:

- Seven master ports:
 - e200z4d core instruction port
 - e200z4d core complex load/store data port
 - eDMA controller
 - DCU

- DCULite
- VIU
- 2D Graphics Accelerator (GFX2D)
- Seven slave ports:
 - Platform Flash Controller (2 Ports)
 - Platform SRAM Controller
 - Graphics SRAM Controller (2 Ports)
 - QuadSPI serial flash Controller and RLE Decoder
 - Peripheral Bridge
- 32-bit internal address bus, 64-bit internal data bus
- Programmable Arbitration Priority
 - Requesting masters can be treated with equal priority and will be granted access to a slave port in round-robin fashion, based upon the ID of the last master to be granted access, or a priority order can be assigned by software at application run time
- Temporary dynamic priority elevation of masters

1.4.4 Enhanced Direct Memory Access (eDMA)

The eDMA module is a controller capable of performing complex data movements via 16 programmable channels, with minimal intervention from the host processor. The hardware micro architecture includes a DMA engine which performs source and destination address calculations, and the actual data movement operations, along with an SRAM-based memory containing the transfer control descriptors (TCD) for the channels. This implementation is utilized to minimize the overall block size. The eDMA module provides the following features:

- 16 channels support independent 8-, 16-, or 32-bit single value or block transfers
- Supports variable sized queues and circular queues
- Source and destination address registers are independently configured to post-increment or remain constant
- Each transfer is initiated by a peripheral, CPU, periodic timer interrupt or eDMA channel request
- Each DMA channel can optionally send an interrupt request to the CPU on completion of a single value or block transfer
- DMA transfers possible between system memories, QuadSPI, RLE Decoder, DSPIs, I²C, ADC, eMIOS, and General Purpose I/Os (GPIOs)
- Programmable DMA Channel Mux allows assignment of any DMA source to any available DMA channel with up to a total of 64 potential request sources

1.4.5 Interrupt Controller (INTC)

The INTC (interrupt controller) provides priority-based preemptive scheduling of interrupt requests, suitable for statically scheduled hard real-time systems.

For high priority interrupt requests, the time from the assertion of the interrupt request from the peripheral to when the processor is executing the interrupt service routine (ISR) has been minimized. The INTC provides a unique vector for each interrupt request source for quick determination of which ISR needs to be executed. It also provides an ample number of priorities so that lower priority ISRs do not delay the execution of higher priority ISRs. To allow the appropriate priorities for each source of interrupt request, the priority of each interrupt request is software configurable.

When multiple tasks share a resource, coherent accesses to that resource need to be supported. The INTC supports the priority ceiling protocol for coherent accesses. By providing a modifiable priority mask, the priority can be raised temporarily so that all tasks which share the resource can not preempt each other.

Multiple processors can assert interrupt requests to each other through software settable interrupt requests. These same software settable interrupt requests also can be used to break the work involved in servicing an interrupt request into a high priority portion and a low priority portion. The high priority portion is initiated by a peripheral interrupt request, but then the ISR asserts a software settable interrupt request to finish the servicing in a lower priority ISR. Therefore these software settable interrupt requests can be used instead of the peripheral ISR scheduling a task through the RTOS. The INTC provides the following features:

- Unique 9-bit vector for each of the possible 128 separate interrupt sources
- Eight software triggerable interrupt sources
- 16 priority levels with fixed hardware arbitration within priority levels for each interrupt source
- Ability to modify the ISR or task priority
 - Modifying the priority can be used to implement the Priority Ceiling Protocol for accessing shared resources
- External non maskable interrupt directly accessing the main CPU critical interrupt mechanism
- 32 external interrupts

1.4.6 QuadSPI serial flash memory controller

The QuadSPI module enables use of external serial flash memories supporting single, dual, and quad modes of operation. It features the following:

- Maximum serial clock frequency 80 MHz
- Memory mapped read access for AHB crossbar switch masters
- Automatic serial flash read command generation by CPU, eDMA, DCU, or DCULite read access on AHB bus
- Supports single, dual, and quad serial flash read commands
- Simultaneous mode:
 - Supports concurrent read of two external serial flashes
 - The quad data streams from the two flashes can be recombined in the QuadSPI to achieve up to 80 MB/s read bandwidth with 80 MHz serial flash
- 16×64-bit buffer with speculative fetch and buffer flush mechanisms to maximize read bandwidth of serial flash
- DMA support
- All Serial Flash program, erase, read, and configuration commands available via IP bus interface

1.4.7 System Integration Unit Lite (SIUL)

The SIUL controls MCU reset configuration, pad configuration, external interrupt, general purpose I/O (GPIO), internal peripheral multiplexing, and the system reset operation.

The GPIO features the following:

- Up to four levels of internal pin multiplexing, allowing exceptional flexibility in the allocation of device functions for each package
- Centralized general purpose input output (GPIO) control
- All GPIO pins can be independently configured to support pull-up, pull down, or no pull
- Reading and writing to GPIO supported both as individual pins and 16-bit wide ports
- All peripheral pins can be alternatively configured as both general purpose input or output pins except ADC channels which support alternative configuration as general purpose inputs
- Direct readback of the pin value supported on all digital output pins through the SIU
- Configurable digital input filter that can be applied to up to 24 general purpose input pins for noise elimination on external interrupts
- Register configuration protected against change with soft lock for temporary guard or hard lock to prevent modification until next reset

1.4.8 On-chip flash memory with ECC

The MPC5645S microcontroller has the following flash memory features:

- 2 MB of flash memory
 - Typical flash memory access time: 0 wait-state for buffer hits, 3 wait-states for page buffer miss at 125 MHz
 - Two 4×128-bit page buffers with programmable prefetch control
 - One set of page buffers can be allocated for code-only, fixed partitions of code and data, all available for any access
 - One set of page buffers allocated to Display Controller Units, Graphics Accelerator, and the eDMA
 - 64-bit ECC with single-bit correction, double-bit detection for data integrity
- Small block flash arrangement to support features such as boot block, EEPROM Emulation, operating system block
 - 8×16 KB
 - 2×64 KB
 - 2×128 KB
 - 6×256 KB
- Hardware managed flash writes, erase and verify sequence
- Censorship protection scheme to prevent Flash content visibility

1.4.9 SRAM

The MPC5645S microcontroller has 64 KB general-purpose on-chip SRAM with the following features:

- Typical SRAM access time: 1 wait-state for reads and 32-bit writes
- 32-bit ECC with single-bit correction, double bit detection for data integrity
- Supports byte (8-bit), half word (16-bit), word (32-bit), and double-word (64-bit) writes for optimal use of memory
- User transparent ECC encoding and decoding for byte, half word, and word accesses
- Separate internal power domains applied to 56 KB and 8 KB SRAM blocks during STANDBY modes to retain contents during low power mode

1.4.10 On-chip graphics SRAM

The MPC5645S microcontroller has 1 MB on-chip graphics SRAM with the following features:

- Two crossbar slave ports:
 - One dedicated to the 2D Graphics Accelerator (GFX2D) access
 - One dedicated to all other crossbar masters
- Usable as general purpose SRAM
- Supports byte (8-bit), half word (16-bit), word (32-bit), and double-word (64-bit) writes for optimal use of memory
- RAM controller with hardware RAM fill function supporting all-zeroes or all-ones SRAM initialization
- Independent data buffers (one per AHB port) for maximum system performance
 - Optimized for burst transfers (read + write)
 - Programmable read prefetch capabilities

1.4.11 Memory Protection Unit (MPU)

The MPU features the following:

- Sixteen region descriptors for per master protection
- Start and end address defined with 32-byte granularity

- Overlapping regions supported
- Protection attributes can optionally include process ID
- Protection offered for 4 concurrent read ports
- Read and write attributes for all masters
- Execute and supervisor/user mode attributes for processor masters

1.4.12 2D Graphics Accelerator (GFX2D)

- Native vector graphics rendering
 - Compatible with OpenVG1.1
 - Complete hardware OpenVG 1.1 rendering pipeline
 - Both geometry and pixel processing
 - Adaptive processing of Bezier curves and strokes
- 16-sample edge anti-aliasing
 - High image quality, font scalability, etc.
 - 4× Rotated Grid Supersampling (RGSS) AA for Flash
- 3D perspective texturing, reflections, and shadowing
- Shading (linear or radial gradient)
- Separate 2D engine for BitBlt, fill, and ROP operations
- Significant performance improvement when compared to software or 3D GPU-based OpenVG implementations

1.4.13 Display Control Unit (DCU3)

The DCU3 is a display controller designed to drive TFT LCD displays up to WVGA resolution using direct blit graphics and video.

The DCU3 generates all the necessary signals required to drive the TFT LCD displays: up to 24-bit RGB data bus, Pixel Clock, Data Enable, Horizontal-Sync, and Vertical-Sync.

The flexible architecture of the DCU3 enables the display of OpenVG-rendered frame buffer content and direct blit rendered graphics simultaneously.

An optional Timing Controller (TCON) and RSDS interface is available to directly drive the row and column drivers of a display panel.

Internal memory resource of the device allows to easily handle complex graphics contents (pictures, icons, languages, fonts).

The DCU3 supports 4-plane blending and 16 graphics layers. Control Descriptors (CDs) associated with each of the 16 layers enable effective merging of different resolutions into one plane to optimize use of internal memory buffers. A layer may be constructed from graphic content of various resolutions including indexed colors of 1, 2, 4, and 8 bpp, direct colors of 16, 24, and 32 bpp, and a YUV 4:2:2 color space. The ability of the DCU3 to handle input data in resolutions as low as 1bpp, 2bpp, and 4bpp enables a highly efficient use of internal memory resources of the MPC5645S. A special tiled mode can be enabled on any of the 16 layers to repeat a pattern optimizing graphic memory usage.

A hardware cursor can be managed independently of the layers at blending level increasing the efficient use of the internal DCU3 resources.

To secure the content of all critical information to be displayed, a safety mode can be activated to check the integrity of critical data along the whole system data path from the memory to the TFT pads.

The DCU3 features the following:

- Display color depth: up to 24 bpp
- Generation of all RGB and control signals for TFT
- Four-plane blending

- Maximum number of Input Layers: 16 (fixed priority)
- Dynamic Look-Up-Table (Color and Gamma Look-Up)
- α -blending range: up to 256 levels
- Transparency Mode
- Gamma Correction
- Tiled mode on all the layers
- Hardware Cursor
- Supports YCrCb 4:2:2 input data format
- RLE decode inline supporting direct read of RLE compressed images from system memory
- Critical display content integrity monitoring for Functional Safety support
- Internal Direct Memory Access (DMA) module to transfer data from internal and / or external memory
- Can drive a maximum of 2048 x 2048 hardware capable resolution and a recommended maximum of 800 x 480 resolution

The DCU3 also features a Parallel Data Interface (PDI) to receive external digital video or graphic content into the DCU3. The PDI input is directly injected into the DCU3 background plane FIFO. When the PDI is activated, all the DCU3 synchronization is extracted from the external video stream to guarantee the synchronization of the two video sources.

The PDI can be used to:

- Connect a video camera output directly to the PDI
- Connect a secondary display driver as slave with a minimum of extra cost
- Connect a device gathering various Video sources
- Provide flexibility to allow the DCU to be used in slave mode (external synchronization)

The PDI features the following:

- Supported color modes:
 - 8-bit mono
 - 8-bit color multiplexed
 - RGB565
 - 16-bit/18-bit RAW color
- Supported synchronization modes:
 - embedded ITU-R BT.656-4 (RGB565 mode 2)
 - HSYNC, VSYNC
 - Data Enable
- Direct interface with DCU3 background plane FIFO
- Synchronization generation for the DCU3

1.4.14 Display Control Unit Lite (DCULite)

The DCULite is a display controller designed to enable the MPC5645S to drive a second TFT LCD display up to XGA resolution using direct blit graphics and video. The DCULite includes all features of the DCU3, including the PDI with the following exceptions:

- Reduced from 4-plane to 2-plane blending
- Reduced from 16 layers to 4 layers
- Reduced CLUT size

1.4.15 Timing Controller (TCON) and RSDS interface

The TCON enables direct drive of the row and column drivers of display panels enabling emulation of TCON ICs used in display panels.

- Programmable Timing Generation unit featuring 12 waveform generators allowing high degree of flexibility in panel waveform generation
- Reduced Swing Differential Signaling (RSDS) interface for RGB data and pixel clock
- Conforms to “RSDS ‘Intra Panel’ Interface Specification” Rev. 1.0 (National Semiconductor)

1.4.16 RLE decoder

The RLE decoder is a crossbar slave sharing a slave port with the QuadSPI module. The platform eDMA is used to stream compressed image data into and extract decompressed data out of the RLE Decoder.

- Lossless decompression
- Pixel formats supported: 8 bpp, 16 bpp, 24 bpp, and 32 bpp
- AHB mapped read and write registers in RLE_DEC to achieve higher throughput
- Programmable fill levels of read and write buffers for initiating burst transfers
- Crop feature: Support for selectively reading out a part of decompressed image data taking complete compressed data for the full image as input

1.4.17 DRAM controller

The DRAM controller is a multi-port DRAM controller supporting LPDDR1, DDR-1, and DDR-2 memories. The DRAM controller listens to the incoming requests to the seven buses in parallel and then sends commands to the DRAM from the highest priority bus at the current time

The seven incoming 64-bit buses are:

- DCU3
- DCULite
- e200z4d core — instruction bus
- e200z4d core — data bus
- VIU2
- GFX2D
- eDMA

The DRAM controller features the following:

- Supports CAS latency of 2, 3, and 4 clock cycles
- Master buses
 - 7 incoming master buses
 - Supports 16-byte and 32-byte bursts
 - Supports byte enables
 - Supports 4-bit priority signal for each bus
- Write buffer contains five 32-byte entries
- Supports 16-wide and 32-wide DDR1, DDR2, and LPDDR1 DRAM devices
- Controller supports one chip select, 8-bank DRAM system
- Supports dynamic on-die termination in the host device and in the DRAM
- Supports memory sizes as small as 64 Mbit

1.4.18 Video Input Unit (VIU2)

The VIU2 is a crossbar master module accepting an ITU656 compatible video input stream on a parallel interface, converting the pixel data to RGB or YUV format and transferring the video image to internal frame buffer memory or external DRAM if available.

- Supports 8-bit/10-bit ITU656 video input
- Output formats:
 - RGB888
 - RGB565
 - 8-bit monochrome
 - YCrCb 4:2:2
- Video downscaling
- Contrast and Brightness adjustment
- De-interlace for interlaced video image
- Internal DMA engine for data transfer to memory

1.4.19 Boot Assist Module (BAM)

The BAM is a block of read-only memory that is programmed once by Freescale. The BAM program is executed every time the MCU is powered-on or reset in normal mode. The BAM supports different modes of booting. They are:

- Booting from internal flash memory
- Serial boot loading (A program is downloaded into RAM via FlexCAN or LINFlex and then executed)
- Booting from external memory

Additionally the BAM:

- Enables and manages the transition of the MCU from reset to user code execution
- Configures device for serial bootloader
- Enables multiple bootcode starting locations out of reset through implementation of search for valid Reset Configuration Halfword

1.4.20 Enhanced Modular Input/Output System (eMIOS)

This device has two eMIOS modules, each with 16 channels supporting a range of 16-bit Input Capture, Output Compare, Pulse Width Modulation, and Quadrature Decode functions.

- Selectable clock source from primary FMPLL, secondary FMPLL, external 4 - 16 MHz oscillator or 16 MHz Internal RC oscillator on a per module basis
- Timed I/O channels with 16-bit counter resolution
- Buffered updates
- Support for shifted PWM outputs to minimize occurrence of concurrent edges
- Edge aligned output pulse width modulation
 - Programmable pulse period and duty cycle
 - Supports 0% and 100% duty cycle
 - Shared or independent time bases
- Programmable phase shift between channels
- 4 channels of Quadrature Decode
- DMA transfer support

1.4.21 Analog-to-Digital Converter (ADC)

The ADC features the following:

- 10-bit A/D resolution
- 0–5 V or 0–3.3 V common mode conversion range
- Supports conversions speeds of up to 1 μ s
- 20 internal and 8 external channels support
- Up to 20 single-ended inputs channels
 - 10 channels configured as input only pins
 - 10-bit \pm 2 counts accuracy (TUE)
 - 10 channels configured to have alternate function as general purpose input/output pins
 - 10-bit \pm 3 counts accuracy (TUE)
- External multiplexer support to increase up to 27 channels
 - Automatic 1 \times 8 multiplexer control
 - External multiplexer connected to a dedicated input channel
 - Shared register between the 8 external channels
- Result register available for every non-multiplexed channel
- Configurable Left or Right aligned result format
- Supports for one-shot, scan, and injection conversion modes
- Injection mode status bit implemented on adjacent 16-bit register for each result
 - Supports Access to Result and injection status with single 32-bit read
- Independently enabling of function for channels:
 - Pre-sampling
 - Offset error cancellation
 - Offset Refresh
- Conversion Triggering support
 - Internal conversion triggering from periodic interrupt timer (PIT)
- Four configurable analog comparator channels offering range comparison with triggered alarm
 - Greater than
 - Less than
 - Out of range
- All unused analog pins available as general purpose input pins
- Selected unused analog pins available as general purpose pins
- Power Down mode
- Optional support for DMA transfer of results

1.4.22 Deserial Serial Peripheral Interface (DSPI)

The DSPI modules provide a synchronous serial interface for communication between the MCU and external devices.

The DSPI features:

- Full duplex, synchronous transfers
- Master or slave operation
- Programmable master bit rates
- Programmable clock polarity and phase
- End-of-transmission interrupt flag
- Programmable transfer baud rate

- Programmable data frames from 4 to 16 bits
- Up to 3 chip select lines available, depending on package and pin multiplexing, enable 8 external devices to be selected using external muxing from a single DSPI
- Eight clock and transfer attributes registers
- Chip select strobe available as alternate function on one of the chip select pins for de-glitching
- FIFOs for buffering up to 4 transfers on the transmit and receive side
- General purpose I/O functionality on pins when not used for SPI
- Queuing operation possible through use of eDMA

1.4.23 FlexCAN

The MPC5645S includes up to three controller area network (FlexCAN) modules. The FlexCAN module is a communication controller implementing the CAN protocol according to Bosch Specification version 2.0B. The CAN protocol was designed to be used primarily as a vehicle serial data bus, meeting the specific requirements of this field: real-time processing, reliable operation in the EMI environment of a vehicle, cost-effectiveness, and required bandwidth.

Each FlexCAN module offers the following:

- Compliant with CAN protocol specification, Version 2.0B active
- 64 mailboxes, each configurable as transmit or receive
 - Mailboxes configurable while module remains synchronized to CAN bus
- Transmit features
 - Supports configuration of multiple mailboxes to form message queues of scalable depth
 - Arbitration scheme according to message ID or message buffer number
 - Internal arbitration to guarantee no inner or outer priority inversion
 - Transmit abort procedure and notification
- Receive features
 - Individual programmable filters for each mailbox
 - 8 mailboxes configurable as a 6-entry receive FIFO
 - 8 programmable acceptance filters for receive FIFO
- Programmable clock source
 - System clock
 - Direct oscillator clock to avoid PLL jitter
- Listen only mode capabilities
- CAN Sampler
 - Can catch the 1st message sent on the CAN network while the MCU is stopped, which guarantees a clean startup of the system without missing messages on the CAN network
 - The CAN sampler is connected to one of the CAN RX pins

1.4.24 Serial communication interface module (LINFlex)

The MPC5645S devices include up to four LINFlex modules and support for LIN Master mode, LIN Slave mode, and UART mode. The modules are LIN state machine compliant to the LIN 1.3, 2.0, and 2.1 Specifications and handle LIN frame transmission and reception without CPU intervention.

Other features include:

- Autonomous LIN frame handling
- Message buffer to store identifier and up to eight data bytes
- Supports message length of up to 64 bytes

- Detection and flagging of LIN errors
- Sync field; Delimiter; ID parity; Bit, Framing; Checksum and Timeout errors
- Classic or extended checksum calculation
- Configurable Break duration of up to 36-bit times
- Programmable Baud rate prescalers (13-bit mantissa, 4-bit fractional)
- Diagnostic features
 - Loop back
 - Self Test
 - LIN bus stuck dominant detection
- Interrupt driven operation with 16 interrupt sources
- LIN slave mode features
 - Autonomous LIN header handling
 - Autonomous LIN response handling
 - Discarding of irrelevant LIN responses using up to 16 ID filters
- UART mode
 - Full-duplex operation
 - Standard non return-to-zero (NRZ) mark/space format
 - Data buffers with 4-byte receive, 4-byte transmit
 - Configurable word length (8-bit or 9-bit words)
 - Error detection and flagging
 - Parity, noise, and framing errors
 - Interrupt driven operation with 4 interrupts sources
 - Separate transmitter and receiver CPU interrupt sources
 - 16-bit programmable baud-rate modulus counter and 16-bit fractional
 - Two receiver wakeup methods

1.4.25 Inter-Integrated Circuit (I²C) controller modules

The MPC5645S includes four I²C modules. Each module features the following:

- Two-wire bi-directional serial bus for on-board communications
- Compatibility with I²C bus standard
- Multi-master operation
- Software-programmable for one of 256 different serial clock frequencies
- Software-selectable acknowledge bit
- Interrupt-driven, byte-by-byte data transfer
- Arbitration-lost interrupt with automatic mode switching from master to slave
- Calling address identification interrupt
- Start and stop signal generation/detection
- Repeated START signal generation
- Acknowledge bit generation/detection
- Bus-busy detection

1.4.26 System clocks and clock generation modules

The system clock on the MPC5645S can be derived from an external oscillator, an on-chip FMPLL, or the internal 16 MHz oscillator.

The source system clock frequency can be changed via an on-chip programmable clock divider ($\div 1$ to $\div 32$). An additional programmable peripheral bus clock divider (ratios $\div 1$ to $\div 15$) is also available.

The MPC5645S has two on-chip FMPLLs (primary and secondary). Each features the following:

- Input clock frequency from 4 MHz to 16 MHz
- Lock detect circuitry continuously monitors lock status
- Loss Of Clock (LOC) detection for reference and feedback clocks
- On-chip loop filter (for improved electromagnetic interference performance and reduction of number of external components required)
- Support for frequency ramping from PLL

The primary FMPLL module is for use as a system clock source. The secondary FMPLL is available for use as an alternate, modulated or non-modulated clock source to eMIOS modules and as alternate clock to the DCU for pixel clock generation.

The fast external oscillator provides the following features:

- Input frequency range 4–16 MHz
- Square-wave input mode
- Oscillator input mode 3.3 V (5.0 V)
- Automatic level control
- Low power consumption
- PLL reference

The MPC5645S also includes the following oscillators:

- 32 KHz low power external oscillator for slow execution, low power, and RTC
- Dedicated internal 128 kHz RC oscillator for low power mode operation and self wake-up
 - $\pm 10\%$ accuracy across voltage and temperature (after factory trimming)
 - Trimming registers to support improved accuracy with in-application calibration
- Dedicated 16 MHz internal RC oscillator
 - Used as default clock source out of reset
 - Provides a clock for rapid start-up from low power modes
 - Provides a back-up clock in the event of PLL or External Oscillator clock failure
 - Offers an independent clock source for the SWT
 - $\pm 5\%$ accuracy across voltage and temperature (after factory trimming)
 - Trimming registers to support frequency adjustment with in-application calibration

1.4.27 Periodic Interrupt Timer (PIT)

The PIT features the following:

- Eight general purpose interrupt timers
- Two dedicated interrupt timers for triggering ADC conversions
- 32-bit counter resolution
- Clocked by system clock frequency

1.4.28 Real Time Counter (RTC)

The Real Time Counter supports wake-up from Low Power modes or Real Time Clock generation

- Configurable resolution for different timeout periods
 - 1 s resolution for >1 hour period
 - 1 ms resolution for 2 second period

- Selectable clock sources from external 32 KHz crystal, external 4–16 MHz crystal, internal 128 kHz RC oscillator or divided internal 16 MHz RC oscillator

1.4.29 System Timer Module (STM)

The STM is a 32-bit timer designed to support commonly required system and application software timing functions. The STM includes a 32-bit up counter and four 32-bit compare channels with a separate interrupt source for each channel. The counter is driven by the system clock divided by an 8-bit prescale value (1 to 256).

- One 32-bit up counter with 8-bit prescaler
- Four 32-bit compare channels
- Independent interrupt source for each channel
- Counter can be stopped in debug mode

1.4.30 Software Watchdog Timer (SWT)

The SWT features the following:

- Watchdog supporting software activation or enabled out of Reset
- Supports normal or windowed mode
- Watchdog timer value writable once after reset
- Watchdog supports optional halting during low power modes
- Configurable response on timeout: reset, interrupt, or interrupt followed by reset
- Clock source: 128 kHz RC oscillator

1.4.31 Stepper Motor Controller (SMC)

The SMC module is a PWM motor controller suitable to drive instruments in a cluster configuration or any other loads requiring a PWM signal. The motor controller has twelve PWM channels associated with two pins each (24 pins in total) driving up to 6 stepper motors.

The SMC module includes the following features:

- 10/11-bit PWM counter
- 11-bit resolution with selectable PWM dithering function
- Left, right, or center aligned PWM
- Output slew rate control
- Output Short Circuit Detection

This module is suited for, but not limited to, driving small stepper and air core motors used in instrumentation applications. This module can be used for other motor control or PWM applications that match the frequency, resolution, and output drive capabilities of the module.

1.4.32 Stepper Stall Detect (SSD)

The SSD module provides a circuit to measure and integrate the induced voltage on the non-driven coil of a stepper motor using full steps when the gauge pointer is returning to zero (RTZ).

The SSD module features the following:

- Programmable full step state
- Programmable integration polarity
- Blanking (recirculation) state
- 16-bit integration accumulator register

- 16-bit modulus down counter with interrupt

1.4.33 Sound Generator Module (SGM)

The SGM features the following:

- 4-channel audio mixer
- Each channel capable of independent Tone generation or Wave playback
- Individual channel volume control (8-bit resolution)
- Tone Mode:
 - Programmable Tone frequency
 - Programmable amplitude envelope: attack, duration, and decay
 - Programmable number of tone pulses and inter-tone duration
- Wave Mode:
 - One FIFO per channel working in conjunction with eDMA
 - Supports standard audio sampling rates (4 kHz, 8 kHz, 11.025 kHz, 16 kHz, 22.050 kHz, 32 kHz, 44.100 kHz, 48 kHz)
 - Same sample rate applies to all channels
 - 8-bit, 12-bit, 16-bit input data formats
 - Programmable wave duration and inter-wave duration
 - Repeat mode with programmable number of wave playbacks
- SGM Output:
 - 16-bit PWM channel
 - Integrated I²S master interface for connection to external audio DAC

1.4.34 IEEE 1149.1 JTAG controller (JTAGC)

JTAGC features the following:

- Backward compatible to standard JTAG IEEE 1149.1-2001 test access port (TAP) interface
- Support for boundary scan testing

1.4.35 Nexus Development Interface (NDI)

The Nexus 3 module is compliant with Class 3 of the IEEE-ISTO 5001-2008 standard, with additional Class 4 features available. The following features are implemented:

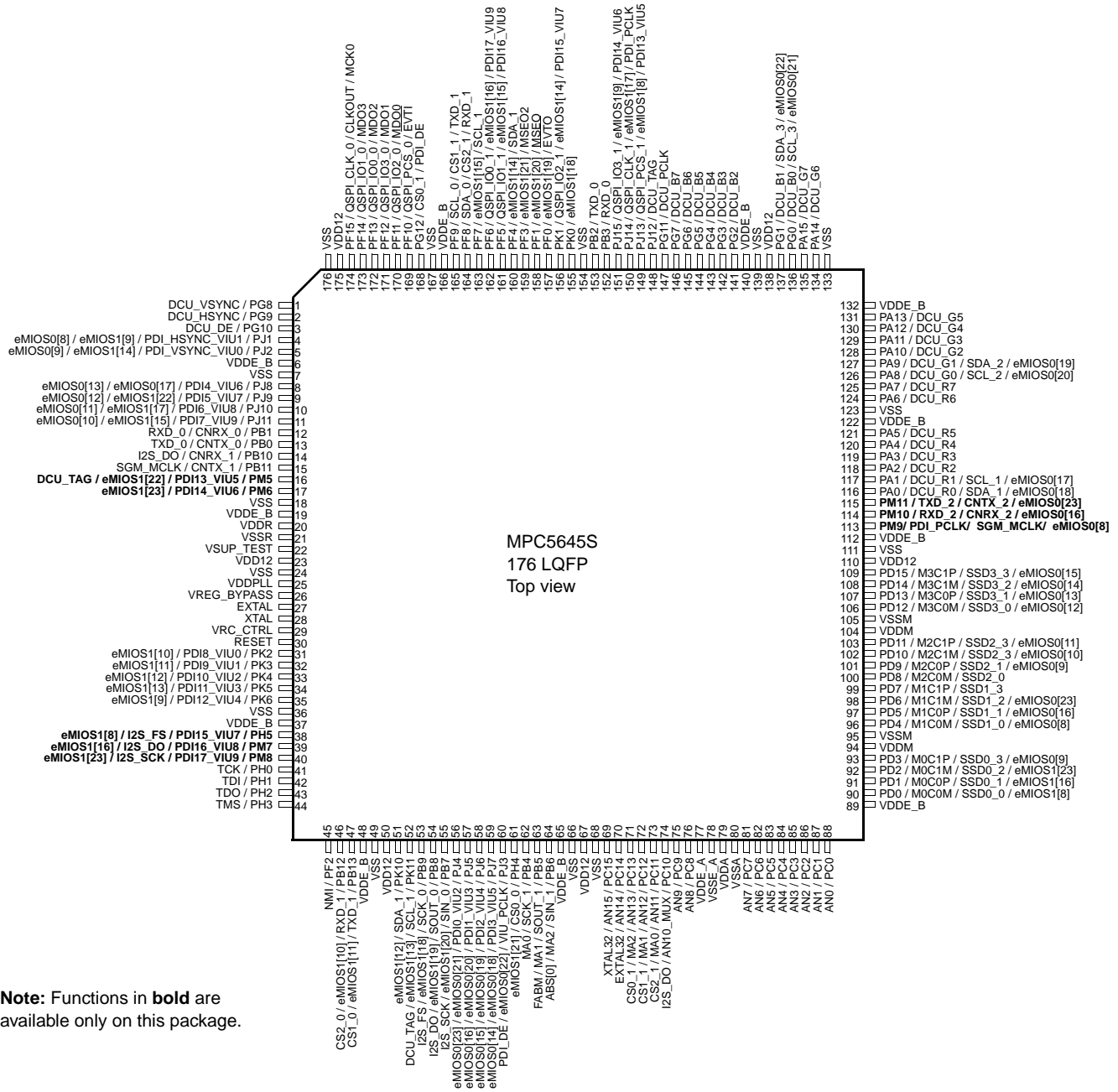
- Program Trace via Branch Trace Messaging (BTM). Branch trace messaging displays program flow discontinuities (direct and indirect branches, exceptions, etc.), allowing the development tool to interpolate what transpires between the discontinuities. Thus static code may be traced.
- Data Trace via Data Write Messaging (DWM) and Data Read Messaging (DRM). This provides the capability for the development tool to trace reads and/or writes to selected internal memory resources.
- Ownership Trace via Ownership Trace Messaging (OTM). OTM facilitates ownership trace by providing visibility of which process ID or operating system task is activated. An Ownership Trace Message is transmitted when a new process/task is activated, allowing the development tool to trace ownership flow.
- Run-time access to embedded processor memory map via the JTAG port. This allows for enhanced download/upload capabilities.
- Watchpoint Messaging via the auxiliary pins provides visibility when debugging.
- Watchpoint Trigger enablement of Program and/or Data Trace Messaging enhances debug capability.

- Data Acquisition Messaging (DQM) allows code to be instrumented to export customized information to the Nexus Auxiliary Output Port.
- Address Translation Messaging via program correlation messages displays updates to the TLB for use by the debugger in correlating virtual and physical address information.
- Auxiliary interface for higher data input/output.
- Registers for Program Trace, Data Trace, Ownership Trace, and Watchpoint Trigger.
- All features are controllable and configurable via the JTAG port.
- Nexus Auxiliary port is supported on the 416BGA package.

2 Pinout and signal descriptions

2.1 176 LQFP package pinout

Figure 2 shows the pinout for the 176-pin LQFP package.



Note: Functions in bold are available only on this package.

Figure 2. 176-pin LQFP pinout

2.2 208 LQFP package pinout

Figure 3 shows the pinout for the 208-pin LQFP package.

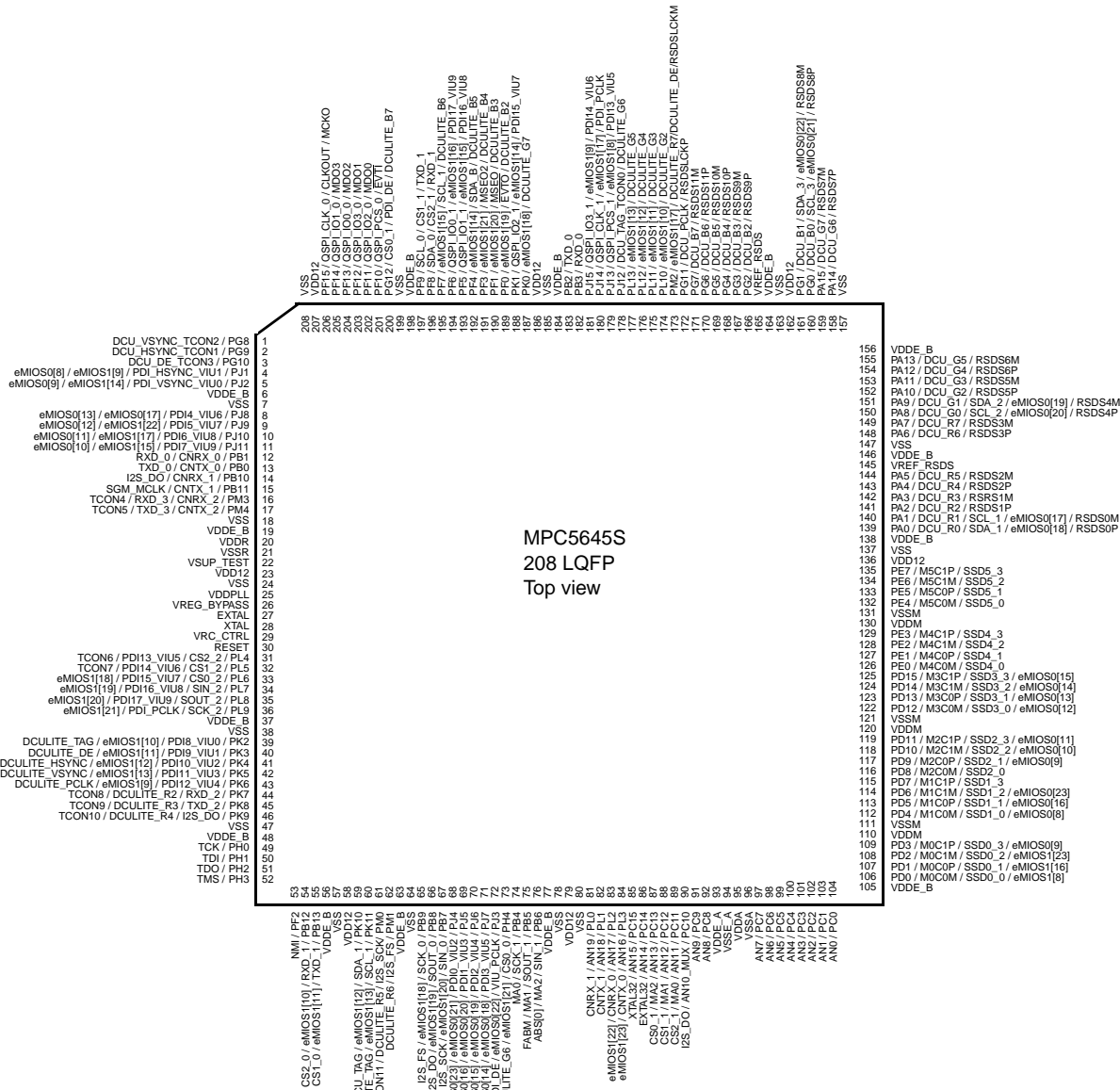


Figure 3. 208-pin LQFP pinout

2.3 416 TEPBGA package pinout

Figure 4 shows the pinout for the 416 TEPBGA package.

| | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | | |
|----|------------|--------------|------------|------------|----------|----------|---------------|-----------|-----------|-----------------|-----------------|-----------------|------------------|------------------|------------------|-------|-------|-------|-------|-------|-------|------|-----------|------------|------|------|----|--|-----|------|------|------|------|-----|---|
| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 | 16 | 17 | 18 | 19 | 20 | 21 | 22 | 23 | 24 | 25 | 26 | | | | | | | | | |
| A | ddr_dq[26] | ddr_dq[27] | ddr_dq[28] | ddr_dq[29] | 30] | 31] | ddr_ba[0] | ddr_ba[1] | ddr_ba[2] | ddr_addr_ess[0] | ddr_addr_ess[4] | ddr_addr_ess[6] | ddr_addr_ess[8] | ddr_addr_ess[12] | PG12 | PF14 | PF10 | PF8 | PF5 | PF3 | PK0 | PB3 | PJ12 | PL11 | PG7 | PG6 | A | | | | | | | | |
| B | ddr_dq[25] | VSS | ddr_dqs[3] | ddr_dm[3] | VSS | ddr_cas | ddr_ras | VSS | ddr_web | ddr_addr_ess[1] | VSS | ddr_addr_ess[7] | ddr_addr_ess[9] | VSS | ddr_addr_ess[15] | PF13 | VDDE | PF15 | VSS | PF1 | VDDE | PJ15 | PL13 | VDDE | VSS | PG5 | B | | | | | | | | |
| C | ddr_dq[23] | VDDE_DDR | VSS | ddr_dq[24] | VDDE_DDR | VSS | ddr_dram_clk | VDDE_DDR | VSS | ddr_addr_ess[2] | VDDE_DDR | VSS | ddr_addr_ess[10] | VDDE_DDR | VSS | PF12 | VSS | PF7 | VDDE | PF0 | VSS | PJ14 | PL12 | PL10 | PG3 | PG4 | C | | | | | | | | |
| D | ddr_dq[21] | ddr_dq[20] | ddr_dq[21] | ddr_dq[22] | ddr_odt | VDD33_DR | ddr_dram_clkb | ddr_cke | ddr_cs | ddr_addr_ess[3] | ddr_addr_ess[5] | VDD33_DR | ddr_addr_ess[11] | ddr_addr_ess[13] | ddr_addr_ess[14] | PF11 | PF9 | PF6 | PF4 | PK1 | PB2 | PJ13 | PM2 | VREF_RSDS2 | PG2 | PG1 | D | | | | | | | | |
| E | ddr_dq[17] | VSS | VDDE_DDR | ddr_dq[18] | | | | | | | | | | | | | | | | | | | PG11 | VSS | VDDE | PG0 | E | | | | | | | | |
| F | ddr_dq[16] | MVTT3 | VSS | VDD33_DR | | | | | | | | | | | | | | | | | | | PA15 | PA14 | PA13 | PA12 | F | | | | | | | | |
| G | ddr_dq[15] | ddr_dqs[2] | ddr_dm[2] | ddr_dq[14] | | | | | | | | | | | | | | | | | | | PA11 | PA9 | PA8 | PA7 | G | | | | | | | | |
| H | ddr_dq[13] | VSS | VDDE_DDR | ddr_dq[12] | | | | | | | | | | | | | | | | | | | PA10 | VDDE | VSS | VA6 | H | | | | | | | | |
| J | ddr_dq[11] | MVTT2 | VSS | MVREF | | | | | | | | | | | | | | | | | | | PA3 | VREF_RSDS1 | PA5 | PA4 | J | | | | | | | | |
| K | ddr_dq[9] | ddr_dqs[1] | ddr_dm[1] | ddr_dq[10] | VDD12 | | | | | | | | VSS | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | | | | | | | | | PA2 | VSS | PA1 | PA0 | K | |
| L | ddr_dq[8] | VSS | VDDE_DDR | ddr_dq[7] | VSS | | | | | | | | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | | | | | | | | | PM13 | PM12 | VDDE | PJ0 | L |
| M | ddr_dq[5] | MVTT1 | VSS | ddr_dq[6] | VDD12 | | | | | | | | VSS | VSS | VSS | VSS | VSS | VSS | VDD12 | VSS | | | | | | | | | PO7 | PO6 | PO5 | PO4 | M | | |
| N | ddr_dq[3] | ddr_dqs[0] | VDDE_DDR | ddr_dq[4] | VSS | | | | | | | | VDD12 | VSS | VSS | VSS | VSS | VSS | VSS | VDD12 | | | | | | | | | PO3 | VDDE | PO2 | PO1 | N | | |
| P | ddr_dq[1] | VSS | ddr_dm[0] | ddr_dq[2] | VDD12 | | | | | | | | VSS | VSS | VSS | VSS | VSS | VSS | VDD12 | VSS | | | | | | | | | PO0 | PN15 | VSS | PN14 | P | | |
| R | ddr_dq[0] | MVTT0 | VSS | VDD33_DR | VSS | | | | | | | | VDD12 | VSS | VSS | VSS | VSS | VSS | VSS | VDD12 | | | | | | | | | PE7 | PE6 | PN13 | PN12 | R | | |
| T | PG10 | PG9 | VDDE_DDR | PG8 | VDD12 | | | | | | | | VSS | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | | | | | | | | | PE5 | PE4 | PE3 | PE2 | T | |
| U | PJ9 | PJ8 | PJ2 | PJ1 | VSS | | | | | | | | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | VDD12 | VSS | VDD12 | | | | | | | | | PE1 | VSSM | VDDM | PE0 | U | |
| V | PB1 | VSS | PJ11 | PJ10 | | | | | | | | | | | | | | | | | | | PD15 | PD14 | PD13 | PD12 | V | | | | | | | | |
| W | RESET | PB10 | VDDE | PB0 | | | | | | | | | | | | | | | | | | | PD11 | VDDM | VSSM | PD10 | W | | | | | | | | |
| Y | VSS | PM4 | PM3 | PB11 | | | | | | | | | | | | | | | | | | | PD9 | PD8 | PD7 | PD6 | Y | | | | | | | | |
| AA | XTAL | VREG_BY_PASS | VRC_CTRL | VDDREG | | | | | | | | | | | | | | | | | | | PD5 | VSSM | VDDM | PD4 | AA | | | | | | | | |
| AB | EXTAL | PL4 | VSS | VDDPLL | | | | | | | | | | | | | | | | | | | PD3 | PD2 | PD1 | PD0 | AB | | | | | | | | |
| AC | VSUP_TEST | PL5 | PN0 | PK4 | PK6 | PH0 | PF2 | PB13 | PK11 | PN2 | PN4 | PN8 | PB9 | PB7 | PJ7 | PB5 | MCKO | MDO6 | MDO10 | MVO0 | PC0 | VDDA | VSSEH_ADC | PC3 | PC1 | PC2 | AC | | | | | | | | |
| AD | PL6 | VDDE | PN1 | VSS | PK7 | PH1 | VDDE | EVT1 | MSEO | VSS | PN5 | PN9 | VDDE | PJ4 | PJ3 | VSS | MSEO2 | MDO7 | VDDE | MDO1 | PC6 | VSSA | VDDEH_ADC | PC4 | PC7 | PC5 | AD | | | | | | | | |
| AE | PL7 | VSS | PK2 | VDDE | PK8 | PH2 | VSS | EVTO | PM0 | VDDE | PN6 | PN10 | VSS | PJ5 | PH4 | VDDE | MDO4 | MDO8 | VSS | MDO2 | PL1 | PL0 | PC10 | PC11 | PC9 | PC8 | AE | | | | | | | | |
| AF | PL8 | PL9 | PK3 | PK5 | PK9 | PH3 | PB12 | PK10 | PM1 | PN3 | PN7 | PN11 | PB8 | PJ6 | PB4 | PB6 | MDO5 | MDO9 | MDO11 | MDO3 | PL3 | PL2 | PC15 | PC14 | PC13 | PC12 | AF | | | | | | | | |
| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 | 16 | 17 | 18 | 19 | 20 | 21 | 22 | 23 | 24 | 25 | 26 | | | | | | | | | |

Figure 4. 416 TEPBGA pinout

2.4 Signal description

The following sections provide signal descriptions and related information about the signals' functionality and configuration.

2.4.1 Pad configuration during reset phases

All pads have a fixed configuration under reset.

During the power-up phase, all pads are forced to tristate.

After power-up phase, all pads are floating with the following exceptions:

- PB[5] (FAB) is pull-down. Without external strong pull-up the device starts fetching from flash memory.
- RESET pad is driven low. This is released only after PHASE2 reset completion.
- Fast (4-16 MHz) external oscillator pads (EXTAL, XTAL) are tristate.
- The following pads are pull-up:
 - PB[6]
 - PH[0]
 - PH[1]
 - PH[3]

2.4.2 Voltage supply pins

Voltage supply pins are used to provide power to the device. Two dedicated pins are used for 1.2 V regulator stabilization.

Table 3. Voltage supply pin descriptions

| Supply pin | Function | Pin number | | |
|----------------|--|--|--|---|
| | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| V_{DD12}^1 | 1.2 V core supply (1.08 V - 1.32 V) | 23, 50, 67, 110, 138, 175 | 23, 58, 79, 136, 162, 186, 207 | K10,K12,K14,K16,L11,L13,L15,L17,M10,M16,N11,N17,P10,P16,R11,R17,T10,T12,T14,T16,U11,U13,U15,U17 |
| V_{SS} | 1.2 V ground | 7, 18, 36, 49, 66, 68, 111, 123, 133, 139, 154, 167, 176 | 7, 18, 38, 47, 57, 64, 78, 80, 137, 147, 157, 163, 185, 199, 208 | AB3,AD10,AD16,AD4,AE13,AE19,AE2,AE7,B11,B14,B19,B2,B25,B5,B8,C12,C15,C17,C21,C3,C6,C9,E2,E24,F3,H2,H25,J3,K11,K13,K15,K17,K24,L10,L12,L14,L16,L2,M11,M12,M13,M14,M15,M17,M3,N10,N12,N13,N14,N15,N16,P11,P12,P13,P14,P15,P17,P2,P25,R10,R12,R13,R14,R15,R16,R3,T11,T13,T15,T17,U10,U12,U14,U16,V2,Y1 |
| | VDD12 ground and VDDPLL ground (VSSPLL) | 24 | 24 | — |
| V_{DDE_B} | 3.3 V I/O supply This supply is shared with internal flash, 16 MHz IRC oscillator and 4–16MHz crystal oscillator. | 6, 19, 37, 48, 65, 89, 112, 122, 132, 140, 166 | 6, 19, 37, 48, 56, 63, 77, 105, 138, 146, 156, 164, 184, 198 | AD13,AD19,AD2,AD7,AE10,AE16,AE4,B17,B21,B24,C19,E25,H24,L25,N24,W3 |
| V_{DDA}^2 | 3.3 V/5 V reference voltage and analog supply for A/D converter This supply is shared with the SXOSC. | 79 | 95 | AC22 |
| V_{SSA} | Reference ground and analog ground for A/D converter | 80 | 96 | AD22 |
| V_{DDR} | Voltage regulator VREG supply | 20 | 20 | AA4 |
| V_{SSR} | Voltage regulator ground | 21 | 21 | — |
| $V_{DDE_A}^2$ | 3.3 V/5 V I/O supply This supply is shared with the SXOSC. | 77 | 93 | AD23 |
| V_{SSE_A} | 3.3 V/5 V I/O supply ground | 78 | 94 | AC23 |

Table 3. Voltage supply pin descriptions (continued)

| Supply pin | Function | Pin number | | |
|------------------------------------|---|------------|---------------|-------------------------------------|
| | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| V _{DDM} | Stepper motor 3.3 V/5 V pad supply SSD shares this supply. | 94, 104 | 110, 120, 130 | U25,W24,AA25 |
| V _S SM | Stepper motor ground | 95, 105 | 111, 121, 131 | U24,W24,AA24 |
| V _{DD} PLL | 1.2 V PLL supply | 25 | 25 | AB4 |
| V _{SUP_TEST} ³ | 9 – 12 V flash test analog write signal | 22 | 22 | AC1 |
| V _{DD} _DR | 1.8 V, 2.5 V, and 3.3 V DDR SDRAM supply | — | — | C2,C5,C8,C11,C14, E3,H3,L3,N3,T3 |
| V _{DD33} _DR | Functional supply for SDRAM pads (where available must be >= V _{DD} _DR) | — | — | D6, D12, F4, R4 |

¹ Decoupling capacitors must be connected between these pins and the nearest V_{SS} pin.

² V_{DDA} must be at the same voltage as V_{DD}E_A.

³ This signal needs to be connected to ground during normal operation.

2.4.3 System pins

The system pins are listed in [Table 4](#).

Table 4. System pin descriptions

| System pin | Function | I/O direction | Pad type | RESET configuration ¹ | Pin number | | |
|---------------------------|--|---------------|----------|----------------------------------|------------|----------|------------|
| | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| $\overline{\text{RESET}}$ | Bidirectional reset with Schmitt-Trigger characteristics and noise filter. | I/O | M | Input, weak pull up | 30 | 30 | W1 |
| EXTAL | Analog input to the oscillator amplifier circuit. Input for the clock generator in bypass mode. | I | X | — | 27 | 27 | AB1 |
| XTAL | Analog output of the oscillator amplifier circuit. Needs to be grounded if oscillator bypass mode is used. | O | X | — | 28 | 28 | AA1 |
| EXTAL32 | Analog input of the 32KHz oscillator amplifier circuit. | O | S | — | 70 | 86 | AF24 |
| XTAL32 | Analog output of the 32 KHz oscillator amplifier circuit. Input for the clock generator in bypass mode. | I | S | — | 69 | 85 | AF23 |

Table 4. System pin descriptions (continued)

| System pin | Function | I/O direction | Pad type | RESET configuration ¹ | Pin number | | |
|--------------------------|---|---------------|----------|----------------------------------|------------|----------|------------|
| | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| NMI | Non-Maskable Interrupt | I/O | S | Input, none | 45 | 53 | AC7 |
| VRC_CTRL | Voltage Regulator external NPN Ballast base control pin | | Analog | — | 29 | 29 | AA3 |
| VREF_RSDS ² | RSDS interface reference voltage | | Analog | — | — | 145, 165 | J24,D24 |
| VREG_BYPASS ³ | Pin used for factory testing | I | — | — | 26 | 26 | AA2 |

¹ Reset configuration is given as I/O direction and pull direction (for example, “Input, pullup”).

² Although this signal is not a supply for RSDS pads, it needs to be terminated in an external capacitor with a value of 47 pF.

³ VREG_BYPASS should be connected to ground during normal operation.

2.4.4 Nexus pins

On the 176 LQFP and the 208 LQFP package options a reduced set of Nexus pins are optionally available, multiplexed with GPIO pins.

On the 416 TEPBGA package option all Nexus pins are dedicated to Nexus only.

Table 5. Nexus pins

| System pin | Function | Pad type | PCR | Pin number ¹ | | |
|------------|-------------------------|----------|----------|-------------------------|----------|------------|
| | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| EVTI | Nexus Event In | M | PCR[80] | 169 | 201 | A17 |
| EVTO | Nexus Event Out | M | PCR[70] | 157 | 189 | C20 |
| MCKO | Nexus Msg Clock Out | F | PCR[85] | 174 | 206 | B18 |
| MSEO[0] | Nexus Msg Start/End Out | M | PCR[71] | 158 | 190 | B20 |
| MSEO[2] | Nexus Msg Start/End Out | M | PCR[73] | 159 | 191 | A20 |
| MDO[0] | Nexus Msg Data Out | M | PCR[81] | 170 | 202 | D16 |
| MDO[1] | Nexus Msg Data Out | M | PCR[82] | 171 | 203 | C16 |
| MDO[2] | Nexus Msg Data Out | M | PCR[83] | 172 | 204 | B16 |
| MDO[3] | Nexus Msg Data Out | M | PCR[84] | 173 | 205 | A16 |
| EVTI | Nexus Event In | M | PCR[197] | n/a | n/a | AD8 |
| EVTO | Nexus Event Out | M | PCR[198] | n/a | n/a | AE8 |
| MCKO | Nexus Msg Clock Out | F | PCR[200] | n/a | n/a | AC17 |
| MSEO[0] | Nexus Msg Start/End Out | M | PCR[199] | n/a | n/a | AD9 |
| MSEO[2] | Nexus Msg Start/End Out | M | PCR[201] | n/a | n/a | AD17 |
| MDO[0] | Nexus Msg Data Out | M | PCR[185] | n/a | n/a | AC20 |

Table 5. Nexus pins (continued)

| System pin | Function | Pad type | PCR | Pin number ¹ | | |
|------------|--------------------|----------|----------|-------------------------|----------|------------|
| | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| MDO[1] | Nexus Msg Data Out | M | PCR[186] | n/a | n/a | AD20 |
| MDO[2] | Nexus Msg Data Out | M | PCR[187] | n/a | n/a | AE20 |
| MDO[3] | Nexus Msg Data Out | M | PCR[188] | n/a | n/a | AF20 |
| MDO[4] | Nexus Msg Data Out | M | PCR[189] | n/a | n/a | AE17 |
| MDO[5] | Nexus Msg Data Out | M | PCR[190] | n/a | n/a | AF17 |
| MDO[6] | Nexus Msg Data Out | M | PCR[191] | n/a | n/a | AC18 |
| MDO[7] | Nexus Msg Data Out | M | PCR[192] | n/a | n/a | AD18 |
| MDO[8] | Nexus Msg Data Out | M | PCR[193] | n/a | n/a | AE18 |
| MDO[9] | Nexus Msg Data Out | M | PCR[194] | n/a | n/a | AF18 |
| MDO[10] | Nexus Msg Data Out | M | PCR[195] | n/a | n/a | AC19 |
| MDO[11] | Nexus Msg Data Out | M | PCR[196] | n/a | n/a | AF19 |

¹ On the 176 LQFP and 208 LQFP package options the Nexus pins are multiplexed with other GPIO. On the 416 TEPBGA package, there are additional dedicated Nexus pins.

2.4.5 DRAM interface

The DRAM interface pins are listed in [Table 6](#).

Table 6. DRAM interface pin summary

| Port pin ¹ | Function | I/O direction | Pad type | PCR | RESET config ² | Pin number |
|-----------------------|--------------------|---------------|----------|----------|---------------------------|------------|
| | | | | | | 416 TEPBGA |
| DRAM Data Bus | | | | | | |
| DDR_DQ[31] | DRAM Data Bus [31] | I/O | DDR | PCR[237] | None, None | A6 |
| DDR_DQ[30] | DRAM Data Bus [30] | I/O | DDR | PCR[238] | None, None | A5 |
| DDR_DQ[29] | DRAM Data Bus [29] | I/O | DDR | PCR[239] | None, None | A4 |
| DDR_DQ[28] | DRAM Data Bus [28] | I/O | DDR | PCR[240] | None, None | A3 |
| DDR_DQ[27] | DRAM Data Bus [27] | I/O | DDR | PCR[241] | None, None | A2 |
| DDR_DQ[26] | DRAM Data Bus [26] | I/O | DDR | PCR[242] | None, None | A1 |
| DDR_DQ[25] | DRAM Data Bus [25] | I/O | DDR | PCR[243] | None, None | B1 |
| DDR_DQ[24] | DRAM Data Bus [24] | I/O | DDR | PCR[244] | None, None | C4 |
| DDR_DQ[23] | DRAM Data Bus [23] | I/O | DDR | PCR[245] | None, None | C1 |
| DDR_DQ[22] | DRAM Data Bus [22] | I/O | DDR | PCR[246] | None, None | D4 |
| DDR_DQ[21] | DRAM Data Bus [21] | I/O | DDR | PCR[247] | None, None | D3 |
| DDR_DQ[20] | DRAM Data Bus [20] | I/O | DDR | PCR[248] | None, None | D2 |
| DDR_DQ[19] | DRAM Data Bus [19] | I/O | DDR | PCR[249] | None, None | D1 |

Table 6. DRAM interface pin summary (continued)

| Port pin ¹ | Function | I/O direction | Pad type | PCR | RESET config ² | Pin number |
|--------------------------|----------------------|---------------|----------|----------|---------------------------|------------|
| | | | | | | 416 TEPBGA |
| DDR_DQ[18] | DRAM Data Bus [18] | I/O | DDR | PCR[250] | None, None | E4 |
| DDR_DQ[17] | DRAM Data Bus [17] | I/O | DDR | PCR[251] | None, None | E1 |
| DDR_DQ[16] | DRAM Data Bus [16] | I/O | DDR | PCR[252] | None, None | F1 |
| DDR_DQ[15] | DRAM Data Bus [15] | I/O | DDR | PCR[253] | None, None | G1 |
| DDR_DQ[14] | DRAM Data Bus [14] | I/O | DDR | PCR[254] | None, None | G4 |
| DDR_DQ[13] | DRAM Data Bus [13] | I/O | DDR | PCR[255] | None, None | H1 |
| DDR_DQ[12] | DRAM Data Bus [12] | I/O | DDR | PCR[256] | None, None | H4 |
| DDR_DQ[11] | DRAM Data Bus [11] | I/O | DDR | PCR[257] | None, None | J1 |
| DDR_DQ[10] | DRAM Data Bus [10] | I/O | DDR | PCR[258] | None, None | K4 |
| DDR_DQ[9] | DRAM Data Bus [9] | I/O | DDR | PCR[259] | None, None | K1 |
| DDR_DQ[8] | DRAM Data Bus [8] | I/O | DDR | PCR[260] | None, None | L1 |
| DDR_DQ[7] | DRAM Data Bus [7] | I/O | DDR | PCR[261] | None, None | L4 |
| DDR_DQ[6] | DRAM Data Bus [6] | I/O | DDR | PCR[262] | None, None | M4 |
| DDR_DQ[5] | DRAM Data Bus [5] | I/O | DDR | PCR[263] | None, None | M1 |
| DDR_DQ[4] | DRAM Data Bus [4] | I/O | DDR | PCR[264] | None, None | N4 |
| DDR_DQ[3] | DRAM Data Bus [3] | I/O | DDR | PCR[265] | None, None | N1 |
| DDR_DQ[2] | DRAM Data Bus [2] | I/O | DDR | PCR[266] | None, None | P4 |
| DDR_DQ[1] | DRAM Data Bus [1] | I/O | DDR | PCR[267] | None, None | P1 |
| DDR_DQ[0] | DRAM Data Bus [0] | I/O | DDR | PCR[268] | None, None | R1 |
| DRAM Data Strobes | | | | | | |
| DDR_DQS[3] | DRAM Data Strobe [3] | I/O | DDR | PCR[232] | None, None | B3 |
| DDR_DQS[2] | DRAM Data Strobe [2] | I/O | DDR | PCR[231] | None, None | G2 |
| DDR_DQS[1] | DRAM Data Strobe [1] | I/O | DDR | PCR[230] | None, None | K2 |
| DDR_DQS[0] | DRAM Data Strobe [0] | I/O | DDR | PCR[229] | None, None | N2 |
| DRAM Data Enables | | | | | | |
| DDR_DM[3] | DRAM Data Enable [3] | Output | DDR | PCR[236] | Output, None | B4 |
| DDR_DM[2] | DRAM Data Enable [2] | Output | DDR | PCR[235] | Output, None | G3 |
| DDR_DM[1] | DRAM Data Enable [1] | Output | DDR | PCR[234] | Output, None | K3 |
| DDR_DM[0] | DRAM Data Enable [0] | Output | DDR | PCR[233] | Output, None | P3 |
| DRAM Address | | | | | | |

Table 6. DRAM interface pin summary (continued)

| Port pin ¹ | Function | I/O direction | Pad type | PCR | RESET config ² | Pin number |
|--------------------------|----------------------|---------------|----------|----------|---------------------------|------------|
| | | | | | | 416 TEPBGA |
| DDR_A[15] | DRAM address [15] | Output | DDR | PCR[217] | Output, None | B15 |
| DDR_A[14] | DRAM address [14] | Output | DDR | PCR[216] | Output, None | D15 |
| DDR_A[13] | DRAM address [13] | Output | DDR | PCR[215] | Output, None | D14 |
| DDR_A[12] | DRAM address [12] | Output | DDR | PCR[214] | Output, None | A14 |
| DDR_A[11] | DRAM address [11] | Output | DDR | PCR[213] | Output, None | D13 |
| DDR_A[10] | DRAM address [10] | Output | DDR | PCR[212] | Output, None | C13 |
| DDR_A[9] | DRAM address [9] | Output | DDR | PCR[211] | Output, None | B13 |
| DDR_A[8] | DRAM address [8] | Output | DDR | PCR[210] | Output, None | A13 |
| DDR_A[7] | DRAM address [7] | Output | DDR | PCR[209] | Output, None | B12 |
| DDR_A[6] | DRAM address [6] | Output | DDR | PCR[208] | Output, None | A12 |
| DDR_A[5] | DRAM address [5] | Output | DDR | PCR[207] | Output, None | D11 |
| DDR_A[4] | DRAM address [4] | Output | DDR | PCR[206] | Output, None | A11 |
| DDR_A[3] | DRAM address [3] | Output | DDR | PCR[205] | Output, None | D10 |
| DDR_A[2] | DRAM address [2] | Output | DDR | PCR[204] | Output, None | C10 |
| DDR_A[1] | DRAM address [1] | Output | DDR | PCR[203] | Output, None | B10 |
| DDR_A[0] | DRAM address [0] | Output | DDR | PCR[202] | Output, None | A10 |
| DRAM Bank Address | | | | | | |
| DDR_BA[2] | DRAM Bank Address[2] | Output | DDR | PCR[220] | Output, None | A9 |
| DDR_BA[1] | DRAM Bank Address[1] | Output | DDR | PCR[219] | Output, None | A8 |
| DDR_BA[0] | DRAM Bank Address[0] | Output | DDR | PCR[218] | Output, None | A7 |
| DRAM Control | | | | | | |

Table 6. DRAM interface pin summary (continued)

| Port pin ¹ | Function | I/O direction | Pad type | PCR | RESET config ² | Pin number |
|-----------------------|--------------------------|---------------|----------|----------|---------------------------|-------------|
| | | | | | | 416 TEPBGA |
| DDR_CAS | Column Address Strobe | Output | DDR | PCR[221] | Output, None | B6 |
| DDR_RAS | Row Address Strobe | Output | DDR | PCR[227] | Output, None | B7 |
| DDR_WEB | Write Enable | Output | DDR | PCR[228] | Output, None | B9 |
| DDR_ODT | DRAM On-die termination | Output | DDR | PCR[226] | Output, Pull Down | D5 |
| DDR_CLK | DRAM Clock | Output | DDR | PCR[225] | Output, None | C7 |
| DDR_CLKB | DRAM Clock bar | Output | DDR | NA | Output, None | D7 |
| DDR_CK | DRAM Clock Enable | Output | DDR | PCR[222] | Output, Pull Down | D8 |
| DDR_CS | DRAM Chip Select | Output | DDR | PCR[223] | Output, None | D9 |
| MVREF | DDR Reference Voltage | Input | — | NA | — | J4 |
| MVTT | DRAM Termination Voltage | Input | — | NA | — | F2,J2,M2,R2 |

¹ These port pins are disabled and unpowered on packages where the DRAM interface is not bonded out.

² Reset configuration is given as I/O direction and pull direction (for example, “Input, pullup”).

2.4.6 VIU muxing

The DCU3, DCULite, and VIU2 modules share the same pins for input video. It is, however, possible to feed independent video streams to VIU2 and DCU3 (operating in narrow mode). [Figure 5](#) explains the pin sharing arrangement.

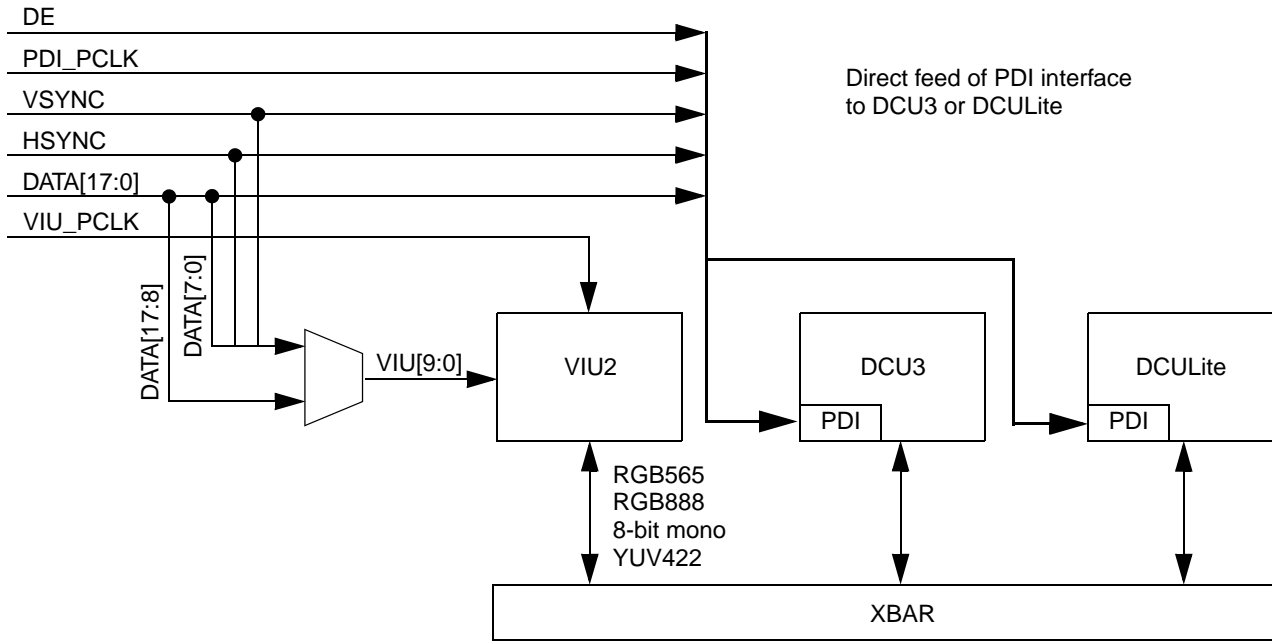


Figure 5. VIU2, DCU3, and DCULite pin sharing

VIU input data selection is done based on select bit (bit 0) of Miscellaneous control register (0xC3FE0340).

- VIU pix data: VIU[9:0]
- Select bit 1'b0: PDI[7:0], HSYNC, VSYNC
- Select bit 1'b1: PDI[17:8]

2.4.7 SGM muxing

The SGM shares pins between the PWM output signals and the I2S bus signals as shown in the [Table 9](#). “Port pin summary table. When the PWM function is enabled in the SGM (SGMCTL[PWME]) the PWM (PWMO, PWMOA) signals are available. When the PWM function is disabled the I2S bus signals (I2S_DO, I2S_SCK) are available.

2.4.8 RSDS special function muxing

Ports PA[0:15], PG[0:7], PG[11] and PM[2] have the RSDS signalling option as a special function. The SIUL allocates pad control registers to these functions (PCR[270:282]), but because these pads share a common pin with the normal GPIO pins they do not operate in the same way as the normal GPIO ports. PG[11] in particular has a special configuration separate from the other pads.

The special-function pads are output-only, and the associated PCR[OBE] bit is controlled by the TCON_CTRL1 register (TCON_BYPASS and RSDS_MODE bits). However, the alternate function selection is taken from the associated normal GPIO pad. This allows selection of the DCU3 function as the alternate function of the pad and then the TCON module to select if the output style is TCON/RSDS or digital RGB format.

Therefore, when the TCON bypass is active (bypass disabled with or without RSDS active), it is important not to configure the normal GPIO ports for output operation with a non-DCU3 alternate function on ports PA[0:15] and PG[0:7].

For PG[11], the PCR[282] OBE bit is fully controlled by the TCON module and will become an output whenever the DCU3 alternate option is selected. Therefore, only select the DCU3 function on this pin when ready to configure it as a clock for a TFT panel.

2.4.9 Functional ports

The functional port pins are listed in [Table 7](#).

Table 7. Port pin summary

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|--------|--|--|-------------------------------|---|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PORT A | | | | | | | | | | | |
| PA[0] | PCR[0] | Option 0 Option 1 Option 2 Option 3 | GPIO[0] DCU_R0 SDA_1 eMIOS0[18] | RSDS0P | SIUL DCU3 I ² C_1 PWM/Timer | I/O | M / RSDS | None, none | 116 | 139 | K26 |
| PA[1] | PCR[1] | Option 0 Option 1 Option 2 Option 3 | GPIO[1] DCU_R1 SCL_1 eMIOS0[17] | RSDS0M | SIUL DCU3 I ² C_1 PWM/Timer | I/O | M / RSDS | None, none | 117 | 140 | K25 |
| PA[2] | PCR[2] | Option 0 Option 1 Option 2 Option 3 | GPIO[2] DCU_R2 — — | RSDS1P | SIUL DCU3 — — | I/O | M / RSDS | None, none | 118 | 141 | K23 |
| PA[3] | PCR[3] | Option 0 Option 1 Option 2 Option 3 | GPIO[3] DCU_R3 — — | RSDS1M | SIUL DCU3 — — | I/O | M / RSDS | None, none | 119 | 142 | J23 |
| PA[4] | PCR[4] | Option 0 Option 1 Option 2 Option 3 | GPIO[4] DCU_R4 — — | RSDS2P | SIUL DCU3 — — | I/O | M / RSDS | None, none | 120 | 143 | J26 |
| PA[5] | PCR[5] | Option 0 Option 1 Option 2 Option 3 | GPIO[5] DCU_R5 — — | RSDS2M | SIUL DCU3 — — | I/O | M / RSDS | None, none | 121 | 144 | J25 |
| PA[6] | PCR[6] | Option 0 Option 1 Option 2 Option 3 | GPIO[6] DCU_R6 — — | RSDS3P | SIUL DCU3 — — | I/O | M / RSDS | None, none | 124 | 148 | H26 |
| PA[7] | PCR[7] | Option 0 Option 1 Option 2 Option 3 | GPIO[7] DCU_R7 — — | RSDS3M | SIUL DCU3 — — | I/O | M / RSDS | None, none | 125 | 149 | G26 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|---------|--|--|-------------------------------|---|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PA[8] | PCR[8] | Option 0 Option 1 Option 2 Option 3 | GPIO[8] DCU_G0 SCL_2 eMIOS0[20] | RSDS4P | SIUL DCU3 I ² C_2 PWM/Timer | I/O | M / RSDS | None, none | 126 | 150 | G25 |
| PA[9] | PCR[9] | Option 0 Option 1 Option 2 Option 3 | GPIO[9] DCU_G1 SDA_2 eMIOS0[19] | RSDS4M | SIUL DCU3 I ² C_2 PWM/Timer | I/O | M / RSDS | None, none | 127 | 151 | G24 |
| PA[10] | PCR[10] | Option 0 Option 1 Option 2 Option 3 | GPIO[10] DCU_G2 — — | RSDS5P | SIUL DCU3 — — | I/O | M / RSDS | None, none | 128 | 152 | H23 |
| PA[11] | PCR[11] | Option 0 Option 1 Option 2 Option 3 | GPIO[11] DCU_G3 — — | RSDS5M | SIUL DCU3 — — | I/O | M / RSDS | None, none | 129 | 153 | G23 |
| PA[12] | PCR[12] | Option 0 Option 1 Option 2 Option 3 | GPIO[12] DCU_G4 — — | RSDS6P | SIUL DCU3 — — | I/O | M / RSDS | None, none | 130 | 154 | F26 |
| PA[13] | PCR[13] | Option 0 Option 1 Option 2 Option 3 | GPIO[13] DCU_G5 — — | RSDS6M | SIUL DCU3 — — | I/O | M / RSDS | None, none | 131 | 155 | F25 |
| PA[14] | PCR[14] | Option 0 Option 1 Option 2 Option 3 | GPIO[14] DCU_G6 — — | RSDS7P | SIUL DCU3 — — | I/O | M / RSDS | None, none | 134 | 158 | F24 |
| PA[15] | PCR[15] | Option 0 Option 1 Option 2 Option 3 | GPIO[15] DCU_G7 — — | RSDS7M | SIUL DCU3 — — | I/O | M / RSDS | None, none | 135 | 159 | F23 |
| PORT B | | | | | | | | | | | |
| PB[0] | PCR[16] | Option 0 Option 1 Option 2 Option 3 | GPIO[16] CANTX_0 TXD_0 — | — | SIUL FlexCAN_0 LINFlex_0 — | I/O | S | None, none | 13 | 13 | W4 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|---------|--|--|-------------------------------|-------------------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PB[1] | PCR[17] | Option 0 Option 1 Option 2 Option 3 | GPIO[17] CANRX_0 RXD_0 — | — | SIUL FlexCAN_0 LINFlex_0 — | I/O | S | None, none | 12 | 12 | V1 |
| PB[2] | PCR[18] | Option 0 Option 1 Option 2 Option 3 | GPIO[18] TXD_0 — — | — | SIUL LINFlex_0 — — | I/O | S | None, none | 153 | 183 | D21 |
| PB[3] | PCR[19] | Option 0 Option 1 Option 2 Option 3 | GPIO[19] RXD_0 — — | — | SIUL LINFlex_0 — — | I/O | S | None, none | 152 | 182 | A22 |
| PB[4] | PCR[20] | Option 0 Option 1 Option 2 Option 3 | GPIO[20] SCK_1 MA0 — | — | SIUL DSPI_1 ADC — | I/O | S | None, none | 62 | 74 | AF15 |
| PB[5] | PCR[21] | Option 0 Option 1 Option 2 Option 3 | GPIO[21] SOUT_1 MA1 FABM | — | SIUL DSPI_1 ADC Control | I/O | S | Input, pull- down | 63 | 75 | AC16 |
| PB[6] | PCR[22] | Option 0 Option 1 Option 2 Option 3 | GPIO[22] SIN_1 MA2 ABS[0] | — | SIUL DSPI_1 ADC Control | I/O | S | Input, pull- up | 64 | 76 | AF16 |
| PB[7] | PCR[23] | Option 0 Option 1 Option 2 Option 3 | GPIO[23] SIN_0 eMIOS1[20] I2S_SCK/PWMOA | — | SIUL DSPI_0 PWM/Timer SGM | I/O | S | None, none | 55 | 67 | AC14 |
| PB[8] | PCR[24] | Option 0 Option 1 Option 2 Option 3 | GPIO[24] SOUT_0 eMIOS1[19] I2S_DO/PWMO | — | SIUL DSPI_0 PWM/Timer SGM | I/O | S | None, none | 54 | 66 | AF13 |
| PB[9] | PCR[25] | Option 0 Option 1 Option 2 Option 3 | GPIO[25] SCK_0 eMIOS1[18] I2S_FS | — | SIUL DSPI_0 PWM/Timer SGM | I/O | M | None, none | 53 | 65 | AC13 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|---------|--|--|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PB[10] | PCR[26] | Option 0 Option 1 Option 2 Option 3 | GPIO[26] CANRX_1 I2S_DO/PWMO — | — | SIUL FlexCAN_1 SGM — | I/O | S | None, none | 14 | 14 | W2 |
| PB[11] | PCR[27] | Option 0 Option 1 Option 2 Option 3 | GPIO[27] CANTX_1 SGM_MCLK — | — | SIUL FlexCAN_1 SGM — | I/O | S | None, none | 15 | 15 | Y4 |
| PB[12] | PCR[28] | Option 0 Option 1 Option 2 Option 3 | GPIO[28] RXD_1 eMIOS1[10] CS2_0 | — | SIUL LINFlex_1 PWM/Timer DSPI_0 | I/O | S | None, none | 46 | 54 | AF7 |
| PB[13] | PCR[29] | Option 0 Option 1 Option 2 Option 3 | GPIO[29] TXD_1 eMIOS1[11] CS1_0 | — | SIUL LINFlex_1 PWM/Timer DSPI_0 | I/O | S | None, none | 47 | 55 | AC8 |
| PB[14] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PB[15] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PORT C | | | | | | | | | | | |
| PC[0] | PCR[30] | Option 0 Option 1 Option 2 Option 3 | GPIO[30] — — — | ANS[0] | SIUL — — — | I/O | J | None, none | 88 | 104 | AC21 |
| PC[1] | PCR[31] | Option 0 Option 1 Option 2 Option 3 | GPIO[31] — — — | ANS[1] | SIUL — — — | I/O | J | None, none | 87 | 103 | AC25 |
| PC[2] | PCR[32] | Option 0 Option 1 Option 2 Option 3 | GPIO[32] — — — | ANS[2] | SIUL — — — | I/O | J | None, none | 86 | 102 | AC26 |
| PC[3] | PCR[33] | Option 0 Option 1 Option 2 Option 3 | GPIO[33] — — — | ANS[3] | SIUL — — — | I/O | J | None, none | 85 | 101 | AC24 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|---------|--|-----------------------------------|-------------------------------|----------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PC[4] | PCR[34] | Option 0 Option 1 Option 2 Option 3 | GPIO[34] — — — | ANS[4] | SIUL — — — | I/O | J | None, none | 84 | 100 | AD24 |
| PC[5] | PCR[35] | Option 0 Option 1 Option 2 Option 3 | GPIO[35] — — — | ANS[5] | SIUL — — — | I/O | J | None, none | 83 | 99 | AD26 |
| PC[6] | PCR[36] | Option 0 Option 1 Option 2 Option 3 | GPIO[36] — — — | ANS[6] | SIUL — — — | I/O | J | None, none | 82 | 98 | AD21 |
| PC[7] | PCR[37] | Option 0 Option 1 Option 2 Option 3 | GPIO[37] — — — | ANS[7] | SIUL — — — | I/O | J | None, none | 81 | 97 | AD25 |
| PC[8] | PCR[38] | Option 0 Option 1 Option 2 Option 3 | GPIO[38] — — — | ANS[8] | SIUL — — — | I/O | J | None, none | 76 | 92 | AE26 |
| PC[9] | PCR[39] | Option 0 Option 1 Option 2 Option 3 | GPIO[39] — — — | ANS[9] | SIUL — — — | I/O | J | None, none | 75 | 91 | AE25 |
| PC[10] | PCR[40] | Option 0 Option 1 Option 2 Option 3 | GPIO[40] — I2S_DO/PWMO — | ANS[10] | SIUL — SGM — | I/O | J | None, none | 74 | 90 | AE23 |
| PC[11] | PCR[41] | Option 0 Option 1 Option 2 Option 3 | GPIO[41] — MA0 CS2_1 | ANS[11] | SIUL — ADC DSPI_1 | I/O | J | None, None | 73 | 89 | AE24 |
| PC[12] | PCR[42] | Option 0 Option 1 Option 2 Option 3 | GPIO[42] — MA1 CS1_1 | ANS[12] | SIUL — ADC DSPI_1 | I/O | J | None, None | 72 | 88 | AF26 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|---------|--|---|-------------------------------|---------------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PC[13] | PCR[43] | Option 0 Option 1 Option 2 Option 3 | GPIO[43] — MA2 CS0_1 | ANS[13] | SIUL — ADC DSPI_1 | I/O | J | None, None | 71 | 87 | AF25 |
| PC[14] | PCR[44] | Option 0 Option 1 Option 2 Option 3 | GPIO[44] — — — | ANS[14] EXTAL32 | SIUL — — — | I/O | J | None, None | 70 | 86 | AF24 |
| PC[15] | PCR[45] | Option 0 Option 1 Option 2 Option 3 | GPIO[45] — — — | ANS[15] XTAL32 | SIUL — — — | I/O | J | None, None | 69 | 85 | AF23 |
| PORT D | | | | | | | | | | | |
| PD[0] | PCR[46] | Option 0 Option 1 Option 2 Option 3 | GPIO[46] M0C0M SSD0_0 eMIOS1[8] | — | SIUL SMD SSD PWM/Timer | I/O | SMD | None, None | 90 | 106 | AB26 |
| PD[1] | PCR[47] | Option 0 Option 1 Option 2 Option 3 | GPIO[47] M0C0P SSD0_1 eMIOS1[16] | — | SIUL SMC SSD PWM/Timer | I/O | SMD | None, None | 91 | 107 | AB25 |
| PD[2] | PCR[48] | Option 0 Option 1 Option 2 Option 3 | GPIO[48] M0C1M SSD0_2 eMIOS1[23] | — | SIUL SMC SSD PWM/Timer | I/O | SMD | None, None | 92 | 108 | AB24 |
| PD[3] | PCR[49] | Option 0 Option 1 Option 2 Option 3 | GPIO[49] M0C1P SSD0_3 eMIOS0[9] | — | SIUL SMC SSD PWM/Timer | I/O | SMD | None, None | 93 | 109 | AB23 |
| PD[4] | PCR[50] | Option 0 Option 1 Option 2 Option 3 | GPIO[50] M1C0M SSD1_0 eMIOS0[8] | — | SIUL SMC SSD PWM/Timer | I/O | SMD | None, None | 96 | 112 | AA26 |
| PD[5] | PCR[51] | Option 0 Option 1 Option 2 Option 3 | GPIO[51] M1C0P SSD1_1 eMIOS0[16] | — | SIUL SMC SSD PWM/Timer | I/O | SMD | None, None | 97 | 113 | AA23 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|---------|--|---|-------------------------------|---------------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PD[6] | PCR[52] | Option 0 Option 1 Option 2 Option 3 | GPIO[52] M1C1M SSD1_2 eMIOS0[23] | — | SIUL SMC SSD PWM/Timer | I/O | SMD | None, None | 98 | 114 | Y26 |
| PD[7] | PCR[53] | Option 0 Option 1 Option 2 Option 3 | GPIO[53] M1C1P SSD1_3 — | — | SIUL SMC SSD — | I/O | SMD | None, None | 99 | 115 | Y25 |
| PD[8] | PCR[54] | Option 0 Option 1 Option 2 Option 3 | GPIO[54] M2C0M SSD2_0 — | — | SIUL SMC SSD — | I/O | SMD | None, None | 100 | 116 | Y24 |
| PD[9] | PCR[55] | Option 0 Option 1 Option 2 Option 3 | GPIO[55] M2C0P SSD2_1 eMIOS0[9] | — | SIUL SMC SSD PWM/Timer | I/O | SMD | None, None | 101 | 117 | Y23 |
| PD[10] | PCR[56] | Option 0 Option 1 Option 2 Option 3 | GPIO[56] M2C1M SSD2_2 eMIOS0[10] | — | SIUL SMC SSD PWM/Timer | I/O | SMD | None, None | 102 | 118 | W26 |
| PD[11] | PCR[57] | Option 0 Option 1 Option 2 Option 3 | GPIO[57] M2C1P SSD2_3 eMIOS0[11] | — | SIUL SMC SSD PWM/Timer | I/O | SMD | None, None | 103 | 119 | W23 |
| PD[12] | PCR[58] | Option 0 Option 1 Option 2 Option 3 | GPIO[58] M3C0M SSD3_0 eMIOS0[12] | — | SIUL SMC SSD PWM/Timer | I/O | SMD | None, None | 106 | 122 | V26 |
| PD[13] | PCR[59] | Option 0 Option 1 Option 2 Option 3 | GPIO[59] M3C0P SSD3_1 eMIOS0[13] | — | SIUL SMC SSD PWM/Timer | I/O | SMD | None, None | 107 | 123 | V25 |
| PD[14] | PCR[60] | Option 0 Option 1 Option 2 Option 3 | GPIO[60] M3C1M SSD3_2 eMIOS0[14] | — | SIUL SMC SSD PWM/Timer | I/O | SMD | None, None | 108 | 124 | V24 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|---------|--|---|-------------------------------|---------------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PD[15] | PCR[61] | Option 0 Option 1 Option 2 Option 3 | GPIO[61] M3C1P SSD3_3 eMIOS0[15] | — | SIUL SMC SSD PWM/Timer | I/O | SMD | None, None | 109 | 125 | V23 |
| PORT E | | | | | | | | | | | |
| PE[0] | PCR[62] | Option 0 Option 1 Option 2 Option 3 | GPIO[62] M4C0M SSD4_0 — | — | SIUL SMC SSD — | I/O | SMD | None, None | — | 126 | U26 |
| PE[1] | PCR[63] | Option 0 Option 1 Option 2 Option 3 | GPIO[63] M4C0P SSD4_1 — | — | SIUL SMC SSD — | I/O | SMD | None, None | — | 127 | U23 |
| PE[2] | PCR[64] | Option 0 Option 1 Option 2 Option 3 | GPIO[64] M4C1M SSD4_2 — | — | SIUL SMC SSD — | I/O | SMD | None, None | — | 128 | T26 |
| PE[3] | PCR[65] | Option 0 Option 1 Option 2 Option 3 | GPIO[65] M4C1P SSD4_3 — | — | SIUL SMC SSD — | I/O | SMD | None, None | — | 129 | T25 |
| PE[4] | PCR[66] | Option 0 Option 1 Option 2 Option 3 | GPIO[66] M5C0M SSD5_0 — | — | SIUL SMC SSD — | I/O | SMD | None, None | — | 132 | T24 |
| PE[5] | PCR[67] | Option 0 Option 1 Option 2 Option 3 | GPIO[67] M5C0P SSD5_1 — | — | SIUL SMC SSD — | I/O | SMD | None, None | — | 133 | T23 |
| PE[6] | PCR[68] | Option 0 Option 1 Option 2 Option 3 | GPIO[68] M5C1M SSD5_2 — | — | SIUL SMC SSD — | I/O | SMD | None, None | — | 134 | R24 |
| PE[7] | PCR[69] | Option 0 Option 1 Option 2 Option 3 | GPIO[69] M5C1P SSD5_3 — | — | SIUL SMC SSD — | I/O | SMD | None, None | — | 135 | R23 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|---------|--|---|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PORT F | | | | | | | | | | | |
| PF[0] | PCR[70] | Option 0 Option 1 Option 2 Option 3 | GPIO[70] eMIOS1[19] EVTO DCULITE_B2 | — | SIUL PWM/Timer NEXUS DCULite | I/O | M | None, None | 157 | 189 | C20 |
| PF[1] | PCR[71] | Option 0 Option 1 Option 2 Option 3 | GPIO[71] eMIOS1[20] MSEO DCULITE_B3 | — | SIUL PWM/Timer NEXUS DCULite | I/O | M | None, None | 158 | 190 | B20 |
| PF[2] | PCR[72] | Option 0 Option 1 Option 2 Option 3 | GPIO[72] NMI — — | — | SIUL NMI — — | I/O | S | None, None | 45 | 53 | AC7 |
| PF[3] | PCR[73] | Option 0 Option 1 Option 2 Option 3 | GPIO[73] eMIOS1[21] MSEO DCULITE_B4 | — | SIUL PWM/Timer NEXUS DCULite | I/O | M | None, None | 159 | 191 | A20 |
| PF[4] | PCR[74] | Option 0 Option 1 Option 2 Option 3 | GPIO[74] eMIOS1[14] SDA_1 DCULITE_B5 | — | SIUL PWM/Timer I ² C_1 DCULite | I/O | M | None, None | 160 | 192 | D19 |
| PF[5] | PCR[75] | Option 0 Option 1 Option 2 Option 3 | GPIO[75] QUADSPI_IO1_B eMIOS1[15] VIU8_PDI16 | — | SIUL QuadSPI PWM/Timer VIU2/PDI | I/O | M | None, None | 161 | 193 | A19 |
| PF[6] | PCR[76] | Option 0 Option 1 Option 2 Option 3 | GPIO[76] QUADSPI_IO0_B eMIOS1[16] VIU9_PDI17 | — | SIUL QuadSPI PWM/Timer VIU2/PDI | I/O | M | None, None | 162 | 194 | D18 |
| PF[7] | PCR[77] | Option 0 Option 1 Option 2 Option 3 | GPIO[77] eMIOS1[15] SCL_1 DCULITE_B6 | — | SIUL PWM/Timer I ² C_1 DCULite | I/O | M | None, None | 163 | 195 | C18 |
| PF[8] | PCR[78] | Option 0 Option 1 Option 2 Option 3 | GPIO[78] SDA_0 CS2_1 RXD_1 | — | SIUL I ² C_0 DSPI_1 LINFlex_1 | I/O | S | None, None | 164 | 196 | A18 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|---------|--|---|-------------------------------|---|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PF[9] | PCR[79] | Option 0 Option 1 Option 2 Option 3 | GPIO[79] SCL_0 CS1_1 TXD_1 | — | SIUL I ² C_0 DSPI_1 LINFlex_1 | I/O | S | None, None | 165 | 197 | D17 |
| PF[10] | PCR[80] | Option 0 Option 1 Option 2 Option 3 | GPIO[80] QUADSPI_PCS_A — EVTI | — | SIUL QuadSPI — NEXUS | I/O | M | None, None | 169 | 201 | A17 |
| PF[11] | PCR[81] | Option 0 Option 1 Option 2 Option 3 | GPIO[81] QUADSPI_IO2_A — MDO0 | — | SIUL QuadSPI — NEXUS | I/O | M | None, None | 170 | 202 | D16 |
| PF[12] | PCR[82] | Option 0 Option 1 Option 2 Option 3 | GPIO[82] QUADSPI_IO3_A — MDO1 | — | SIUL QuadSPI — NEXUS | I/O | M | None, None | 171 | 203 | C16 |
| PF[13] | PCR[83] | Option 0 Option 1 Option 2 Option 3 | GPIO[83] QUADSPI_IO0_A — MDO2 | — | SIUL QuadSPI — NEXUS | I/O | M | None, None | 172 | 204 | B16 |
| PF[14] | PCR[84] | Option 0 Option 1 Option 2 Option 3 | GPIO[84] QUADSPI_IO1_A — MDO3 | — | SIUL QuadSPI — NEXUS | I/O | M | None, None | 173 | 205 | A16 |
| PF[15] | PCR[85] | Option 0 Option 1 Option 2 Option 3 | GPIO[85] QUADSPI_CLK_A CLKOUT MCKO | — | SIUL QuadSPI Control NEXUS | I/O | F | None, None | 174 | 206 | B18 |
| PORT G | | | | | | | | | | | |
| PG[0] | PCR[86] | Option 0 Option 1 Option 2 Option 3 | GPIO[86] DCU_B0 SCL_3 eMIOS0[21] | RSDS8P | SIUL DCU3 I ² C_3 PWM/Timer | I/O | M | None, None | 136 | 160 | E26 |
| PG[1] | PCR[87] | Option 0 Option 1 Option 2 Option 3 | GPIO[87] DCU_B1 SDA_3 eMIOS0[22] | RSDS8M | SIUL DCU3 I ² C_3 PWM/Timer | I/O | M | None, None | 137 | 161 | D26 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|---------|--|---------------------------------|-------------------------------|-------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PG[2] | PCR[88] | Option 0 Option 1 Option 2 Option 3 | GPIO[88] DCU_B2 — — | RSDS9P | SIUL DCU3 — — | I/O | M | None, None | 141 | 166 | D25 |
| PG[3] | PCR[89] | Option 0 Option 1 Option 2 Option 3 | GPIO[89] DCU_B3 — — | RSDS9M | SIUL DCU3 — — | I/O | M | None, None | 142 | 167 | C25 |
| PG[4] | PCR[90] | Option 0 Option 1 Option 2 Option 3 | GPIO[90] DCU_B4 — — | RSDS10P | SIUL DCU3 — — | I/O | M | None, None | 143 | 168 | C26 |
| PG[5] | PCR[91] | Option 0 Option 1 Option 2 Option 3 | GPIO[91] DCU_B5 — — | RSDS10M | SIUL DCU3 — — | I/O | M | None, None | 144 | 169 | B26 |
| PG[6] | PCR[92] | Option 0 Option 1 Option 2 Option 3 | GPIO[92] DCU_B6 — — | RSDS11P | SIUL DCU3 — — | I/O | M | None, None | 145 | 170 | A26 |
| PG[7] | PCR[93] | Option 0 Option 1 Option 2 Option 3 | GPIO[93] DCU_B7 — — | RSDS11M | SIUL DCU3 — — | I/O | M | None, None | 146 | 171 | A25 |
| PG[8] | PCR[94] | Option 0 Option 1 Option 2 Option 3 | GPIO[94] DCU_VSYNC — — | — | SIUL DCU3 — — | I/O | M | None, None | 1 | 1 | T4 |
| PG[9] | PCR[95] | Option 0 Option 1 Option 2 Option 3 | GPIO[95] DCU_HSYNC — — | — | SIUL DCU3 — — | I/O | M | None, None | 2 | 2 | T2 |
| PG[10] | PCR[96] | Option 0 Option 1 Option 2 Option 3 | GPIO[96] DCU_DE — — | — | SIUL DCU3 — — | I/O | M | None, None | 3 | 3 | T1 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|--------------------|----------|--|--|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PG[11] | PCR[97] | Option 0 Option 1 Option 2 Option 3 | GPIO[97] DCU_PCLK — — | RSDSLKP | SIUL DCU3 — — | I/O | F | None, None | 147 | 172 | E23 |
| PG[12] | PCR[98] | Option 0 Option 1 Option 2 Option 3 | GPIO[98] CS0_1 PDI_DE DCULITE_B7 | — | SIUL DSPI_1 PDI DCULite | I/O | M | None, None | 168 | 200 | A15 |
| PG[13] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PG[14] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PG[15] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PORT H | | | | | | | | | | | |
| PH[0] ⁶ | PCR[99] | Option 0 Option 1 Option 2 Option 3 | GPIO[99] TCK — — | — | SIUL JTAG — — | I/O | S | Input, Pull Up | 41 | 49 | AC6 |
| PH[1] ⁶ | PCR[100] | Option 0 Option 1 Option 2 Option 3 | GPIO[100] TDI — — | — | SIUL JTAG — — | I/O | S | Input, Pull Up | 42 | 50 | AD6 |
| PH[2] ⁶ | PCR[101] | Option 0 Option 1 Option 2 Option 3 | GPIO[101] TDO — — | — | SIUL JTAG — — | I/O | M | Output, None | 43 | 51 | AE6 |
| PH[3] ⁶ | PCR[102] | Option 0 Option 1 Option 2 Option 3 | GPIO[102] TMS — — | — | SIUL JTAG — — | I/O | S | Input, Pull Up | 44 | 52 | AF6 |
| PH[4] | PCR[103] | Option 0 Option 1 Option 2 Option 3 | GPIO[103] CS0_0 eMIOS1[21] DCULITE_G6 | — | SIUL DSPI_0 PWM/Timer DCULite | I/O | M | None, None | 61 | 73 | AE15 |
| PH[5] | PCR[104] | Option 0 Option 1 Option 2 Option 3 | GPIO[104] VIU7_PDI15 I2S_FS eMIOS1[8] | — | SIUL VIU2/PDI SGM PWM/Timer | I/O | S | None, None | 38 | — | — |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|----------|--|--|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PH[6] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[7] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[8] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[9] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[10] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[11] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[12] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[13] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[14] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PH[15] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PORT J | | | | | | | | | | | |
| PJ[0] | PCR[105] | Option 0 Option 1 Option 2 Option 3 | GPIO[105] DCULITE_B6 — I2S_DO / PWMO | — | SIUL DCULite — SGM | I/O | M | None, None | — | — | L26 |
| PJ[1] | PCR[106] | Option 0 Option 1 Option 2 Option 3 | GPIO[106] VIU1_PDI_HSYNC eMIOS1[9] eMIOS0[8] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 4 | 4 | U4 |
| PJ[2] | PCR[107] | Option 0 Option 1 Option 2 Option 3 | GPIO[107] VIU0_PDI_VSYNC eMIOS1[14] eMIOS0[9] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 5 | 5 | U3 |
| PJ[3] | PCR[108] | Option 0 Option 1 Option 2 Option 3 | GPIO[108] VIU_PCLK eMIOS0[22] PDI_DE | — | SIUL VIU2 PWM/Timer PDI | I/O | S | None, None | 60 | 72 | AD15 |
| PJ[4] | PCR[109] | Option 0 Option 1 Option 2 Option 3 | GPIO[109] VIU2_PDI0 eMIOS0[21] eMIOS0[23] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 56 | 68 | AD14 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|----------|--|---|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PJ[5] | PCR[110] | Option 0 Option 1 Option 2 Option 3 | GPIO[110] VIU3_PDI1 eMIOS0[20] eMIOS0[16] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | M | None, None | 57 | 69 | AE14 |
| PJ[6] | PCR[111] | Option 0 Option 1 Option 2 Option 3 | GPIO[111] VIU4_PDI2 eMIOS0[19] eMIOS0[15] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 58 | 70 | AF14 |
| PJ[7] | PCR[112] | Option 0 Option 1 Option 2 Option 3 | GPIO[112] VIU5_PDI3 eMIOS0[18] eMIOS0[14] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 59 | 71 | AC15 |
| PJ[8] | PCR[113] | Option 0 Option 1 Option 2 Option 3 | GPIO[113] VIU6_PDI4 eMIOS0[17] eMIOS0[13] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 8 | 8 | U2 |
| PJ[9] | PCR[114] | Option 0 Option 1 Option 2 Option 3 | GPIO[114] VIU7_PDI5 eMIOS1[22] eMIOS0[12] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 9 | 9 | U1 |
| PJ[10] | PCR[115] | Option 0 Option 1 Option 2 Option 3 | GPIO[115] VIU8_PDI6 eMIOS1[17] eMIOS0[11] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 10 | 10 | V4 |
| PJ[11] | PCR[116] | Option 0 Option 1 Option 2 Option 3 | GPIO[116] VIU9_PDI7 eMIOS1[15] eMIOS0[10] | — | SIUL VIU2/PDI PWM/Timer PWM/Timer | I/O | S | None, None | 11 | 11 | V3 |
| PJ[12] | PCR[117] | Option 0 Option 1 Option 2 Option 3 | GPIO[117] DCU_TAG — DCULITE_G6 | — | SIUL DCU3 — DCULite | I/O | M | None, None | 148 | 178 | A23 |
| PJ[13] | PCR[118] | Option 0 Option 1 Option 2 Option 3 | GPIO[118] QUADSPI_PCS_B eMIOS1[8] VIU5_PDI13 | — | SIUL QuadSPI PWM/Timer VIU2/PDI | I/O | M | None, None | 149 | 179 | D22 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|----------|--|--|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PJ[14] | PCR[119] | Option 0 Option 1 Option 2 Option 3 | GPIO[119] QUADSPI_CLK_B eMIOS1[17] PDI_PCLK | — | SIUL QuadSPI PWM/Timer PDI | I/O | F | None, None | 150 | 180 | C22 |
| PJ[15] | PCR[120] | Option 0 Option 1 Option 2 Option 3 | GPIO[120] QUADSPI_IO3_B eMIOS1[9] VIU6_PDI14 | — | SIUL QuadSPI PWM/Timer VIU2/PDI | I/O | M | None, None | 151 | 181 | B22 |
| PORT K | | | | | | | | | | | |
| PK[0] | PCR[121] | Option 0 Option 1 Option 2 Option 3 | GPIO[121] eMIOS1[18] — DCULITE_G7 | — | SIUL PWM/Timer — DCULite | I/O | M | None, None | 155 | 187 | A21 |
| PK[1] | PCR[122] | Option 0 Option 1 Option 2 Option 3 | GPIO[122] QUADSPI_IO2_B eMIOS1[14] VIU7_PDI15 | — | SIUL QuadSPI PWM/Timer VIU2/PDI | I/O | M | None, None | 156 | 188 | D20 |
| PK[2] | PCR[123] | Option 0 Option 1 Option 2 Option 3 | GPIO[123] VIU0_PDI8 eMIOS1[10] DCULITE_TAG | — | SIUL VIU2/PDI PWM/Timer DCULite | I/O | M | None, None | 31 | 39 | AE3 |
| PK[3] | PCR[124] | Option 0 Option 1 Option 2 Option 3 | GPIO[124] VIU1_PDI9 eMIOS1[11] DCULITE_DE | — | SIUL VIU2/PDI PWM/Timer DCULite | I/O | M | None, None | 32 | 40 | AF3 |
| PK[4] | PCR[125] | Option 0 Option 1 Option 2 Option 3 | GPIO[125] VIU2_PDI10 eMIOS1[12] DCULITE_HSYNC | — | SIUL VIU2/PDI PWM/Timer DCULite | I/O | M | None, None | 33 | 41 | AC4 |
| PK[5] | PCR[126] | Option 0 Option 1 Option 2 Option 3 | GPIO[126] VIU3_PDI11 eMIOS1[13] DCULITE_VSYNC | — | SIUL VIU2/PDI PWM/Timer DCULite | I/O | M | None, None | 34 | 42 | AF4 |
| PK[6] | PCR[127] | Option 0 Option 1 Option 2 Option 3 | GPIO[127] VIU4_PDI12 eMIOS1[9] DCULITE_PCLK | — | SIUL VIU2/PDI PWM/Timer DCULite | I/O | F | None, None | 35 | 43 | AC5 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|----------|--|---|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PK[7] | PCR[128] | Option 0 Option 1 Option 2 Option 3 | GPIO[128] RXD_2 DCULITE_R2 TCON[8] | — | SIUL LINFlex_2 DCULite TCON | I/O | M | None, None | — | 44 | AD5 |
| PK[8] | PCR[129] | Option 0 Option 1 Option 2 Option 3 | GPIO[129] TXD_2 DCULITE_R3 TCON[9] | — | SIUL LINFlex_2 DCULite TCON | I/O | M | None, None | — | 45 | AE5 |
| PK[9] | PCR[130] | Option 0 Option 1 Option 2 Option 3 | GPIO[130] I2S_DO / PWMO DCULITE_R4 TCON[10] | — | SIUL SGM DCULite TCON | I/O | M | None, None | — | 46 | AF5 |
| PK[10] | PCR[131] | Option 0 Option 1 Option 2 Option 3 | GPIO[131] SDA_1 eMIOS1[12] DCULITE_TAG | — | SIUL I ² C_1 PWM/Timer DCULite | I/O | S | None, None | 51 | 59 | AF8 |
| PK[11] | PCR[132] | Option 0 Option 1 Option 2 Option 3 | GPIO[132] SCL_1 eMIOS1[13] DCU_TAG / TCON[3] | — | SIUL I ² C_1 PWM/Timer DCU3 / TCON | I/O | S | None, None | 52 | 60 | AC9 |
| PK[12] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PK[13] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PK[14] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PK[15] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PORT L | | | | | | | | | | | |
| PL[0] | PCR[133] | Option 0 Option 1 Option 2 Option 3 | GPIO[133] — CANRX_1 — | ANS[19] | SIUL — FlexCAN_1 — | I/O | M / ANALO G | None, None | — | 81 | AE22 |
| PL[1] | PCR[134] | Option 0 Option 1 Option 2 Option 3 | GPIO[134] — CANTX_1 — | ANS[18] | SIUL — FlexCAN_1 — | I/O | M / ANALO G | None, None | — | 82 | AE21 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|----------|--|---|-------------------------------|---|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PL[2] | PCR[135] | Option 0 Option 1 Option 2 Option 3 | GPIO[135] — CANRX_0 eMIOS1[22] | ANS[17] | SIUL — FlexCAN_0 PWM/Timer | I/O | S/ ANALOG | None, None | — | 83 | AF22 |
| PL[3] | PCR[136] | Option 0 Option 1 Option 2 Option 3 | GPIO[136] — CANTX_0 eMIOS1[23] | ANS[16] | SIUL — FlexCAN_0 PWM/Timer | I/O | S/ ANALOG | None, None | — | 84 | AF21 |
| PL[4] | PCR[137] | Option 0 Option 1 Option 2 Option 3 | GPIO[137] CS2_2 VIU5_PDI13 TCON[6] | — | SIUL DSPI_2 VIU2/PDI TCON | I/O | M | None, None | — | 31 | AB2 |
| PL[5] | PCR[138] | Option 0 Option 1 Option 2 Option 3 | GPIO[138] CS1_2 VIU6_PDI14 TCON[7] | — | SIUL DSPI_2 VIU2/PDI TCON | I/O | M | None, None | — | 32 | AC2 |
| PL[6] | PCR[139] | Option 0 Option 1 Option 2 Option 3 | GPIO[139] CS0_2 VIU7_PDI15 eMIOS1[18] | — | SIUL DSPI_2 VIU2/PDI PWM/Timer | I/O | S | None, None | — | 33 | AD1 |
| PL[7] | PCR[140] | Option 0 Option 1 Option 2 Option 3 | GPIO[140] SIN_2 VIU8_PDI16 eMIOS1[19] | — | SIUL DSPI_2 VIU2/PDI PWM/Timer | I/O | S | None, None | — | 34 | AE1 |
| PL[8] | PCR[141] | Option 0 Option 1 Option 2 Option 3 | GPIO[141] SOUT_2 VIU9_PDI17 eMIOS1[20] | — | SIUL DSPI_2 VIU2/PDI PWM/Timer | I/O | S | None, None | — | 35 | AF1 |
| PL[9] | PCR[142] | Option 0 Option 1 Option 2 Option 3 | GPIO[142] SCK_2 PDI_PCLK eMIOS1[21] | — | SIUL DSPI_2 PDI PWM/Timer | I/O | S | None, None | — | 36 | AF2 |
| PL[10] | PCR[143] | Option 0 Option 1 Option 2 Option 3 | GPIO[143] eMIOS1[10] DCULITE_G2 — | — | SIUL PWM/Timer DCULite — | I/O | M | None, None | — | 174 | C24 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|----------|--|--|-------------------------------|---|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PL[11] | PCR[144] | Option 0 Option 1 Option 2 Option 3 | GPIO[144] eMIOS1[11] DCULITE_G3 — | — | SIUL PWM/Timer DCULite — | I/O | M | None, None | — | 175 | A24 |
| PL[12] | PCR[145] | Option 0 Option 1 Option 2 Option 3 | GPIO[145] eMIOS1[12] DCULITE_G4 — | — | SIUL PWM/Timer DCULite — | I/O | M | None, None | — | 176 | C23 |
| PL[13] | PCR[146] | Option 0 Option 1 Option 2 Option 3 | GPIO[146] eMIOS1[13] DCULITE_G5 — | — | SIUL PWM/Timer DCULite — | I/O | M | None, None | — | 177 | B23 |
| PL[14] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PL[15] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PORT M | | | | | | | | | | | |
| PM[0] | PCR[147] | Option 0 Option 1 Option 2 Option 3 | GPIO[147] I2S_SCK / PWMOA DCULITE_R5 TCON[11] | — | SIUL SGM DCULite TCON | I/O | M | None, None | — | 61 | AE9 |
| PM[1] | PCR[148] | Option 0 Option 1 Option 2 Option 3 | GPIO[148] I2S_FS DCULITE_R6 — | — | SIUL SGM DCULite — | I/O | M | None, None | — | 62 | AF9 |
| PM[2] | PCR[149] | Option 0 Option 1 Option 2 Option 3 | GPIO[149] eMIOS1[17] DCULITE_R7 DCULITE_DE | RSDSCLKM | SIUL PWM/Timer DCULite DCULite | I/O | M | None, None | — | 173 | D23 |
| PM[3] | PCR[150] | Option 0 Option 1 Option 2 Option 3 | GPIO[150] CANRX_2 RXD_3 TCON[4] | — | SIUL FlexCAN_2 LINFlex_3 TCON | I/O | M | None, None | — | 16 | Y3 |
| PM[4] | PCR[151] | Option 0 Option 1 Option 2 Option 3 | GPIO[151] CANTX_2 TXD_3 TCON[5] | — | SIUL FlexCAN_2 LINFlex_3 TCON | I/O | M | None, None | — | 17 | Y2 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|----------|--|--|-------------------------------|---|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PM[5] | PCR[152] | Option 0 Option 1 Option 2 Option 3 | GPIO[152] VIU5_PDI13 eMIOS1[22] DCU_TAG | — | SIUL VIU2/PDI PWM/Timer DCU3 | I/O | M | None, None | 16 | — | — |
| PM[6] | PCR[153] | Option 0 Option 1 Option 2 Option 3 | GPIO[153] VIU6_PDI14 eMIOS1[23] DCULITE_TAG | — | SIUL VIU2/PDI PWM/Timer DCULite | I/O | M | None, None | 17 | — | — |
| PM[7] | PCR[154] | Option 0 Option 1 Option 2 Option 3 | GPIO[154] VIU8_PDI16 I2S_DO / PWMO eMIOS1[16] | — | SIUL VIU2/PDI SGM PWM/Timer | I/O | S | None, None | 39 | — | — |
| PM[8] | PCR[155] | Option 0 Option 1 Option 2 Option 3 | GPIO[155] VIU9_PDI17 I2S_SCK / PWMOA eMIOS1[23] | — | SIUL VIU2/PDI SGM PWM/Timer | I/O | S | None, None | 40 | — | — |
| PM[9] | PCR[156] | Option 0 Option 1 Option 2 Option 3 | GPIO[156] PDI_PCLK SGM_MCLK eMIOS0[8] | — | SIUL PDI SGM PWM/Timer | I/O | M | None, None | 113 | — | — |
| PM[10] | PCR[157] | Option 0 Option 1 Option 2 Option 3 | GPIO[157] RXD_2 CANRX_2 eMIOS0[16] | — | SIUL LINFlex_2 FlexCAN_2 PWM/Timer | I/O | S | None, None | 114 | — | — |
| PM[11] | PCR[158] | Option 0 Option 1 Option 2 Option 3 | GPIO[158] TXD_2 CANTX_2 eMIOS0[23] | — | SIUL LINFlex_2 FlexCAN_2 PWM/Timer | I/O | S | None, None | 115 | — | — |
| PM[12] | PCR[159] | Option 0 Option 1 Option 2 Option 3 | GPIO[159] DCULITE_B7 — I2S_SCK / PWMOA | — | SIUL DCULite — SGM | I/O | M | None, None | — | — | L24 |
| PM[13] | PCR[160] | Option 0 Option 1 Option 2 Option 3 | GPIO[160] DCULITE_PCLK — SGM_MCLK | — | SIUL DCULite — SGM | I/O | F | None, None | — | — | L23 |
| PM[14] | — | — | Reserved | — | — | — | — | — | — | — | — |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|----------|--|---|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PM[15] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PORT N | | | | | | | | | | | |
| PN[0] | PCR[161] | Option 0 Option 1 Option 2 Option 3 | GPIO[161] DCULITE_HSYNC — TCON[4] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AC3 |
| PN[1] | PCR[162] | Option 0 Option 1 Option 2 Option 3 | GPIO[162] DCULITE_VSYNC — TCON[5] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AD3 |
| PN[2] | PCR[163] | Option 0 Option 1 Option 2 Option 3 | GPIO[163] DCULITE_R0 RXD_2 VIU0_PDI8 | — | SIUL DCULite LINFlex_2 VIU2/PDI | I/O | M | None, None | — | — | AC10 |
| PN[3] | PCR[164] | Option 0 Option 1 Option 2 Option 3 | GPIO[164] DCULITE_R1 TXD_2 VIU1_PDI9 | — | SIUL DCULite LINFlex_2 VIU2/PDI | I/O | M | None, None | — | — | AF10 |
| PN[4] | PCR[165] | Option 0 Option 1 Option 2 Option 3 | GPIO[165] DCULITE_R2 — TCON[6] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AC11 |
| PN[5] | PCR[166] | Option 0 Option 1 Option 2 Option 3 | GPIO[166] DCULITE_R3 — TCON[7] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AD11 |
| PN[6] | PCR[167] | Option 0 Option 1 Option 2 Option 3 | GPIO[167] DCULITE_R4 — TCON[8] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AE11 |
| PN[7] | PCR[168] | Option 0 Option 1 Option 2 Option 3 | GPIO[168] DCULITE_R5 — TCON[9] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AF11 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|---------------|----------|--|--|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PN[8] | PCR[169] | Option 0 Option 1 Option 2 Option 3 | GPIO[169] DCULITE_R6 — TCON[10] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AC12 |
| PN[9] | PCR[170] | Option 0 Option 1 Option 2 Option 3 | GPIO[170] DCULITE_R7 — TCON[11] | — | SIUL DCULite — TCON | I/O | M | None, None | — | — | AD12 |
| PN[10] | PCR[171] | Option 0 Option 1 Option 2 Option 3 | GPIO[171] DCULITE_G0 RXD_3 VIU2_PDI10 | — | SIUL DCULite LINFlex_3 VIU2/PDI | I/O | M | None, None | — | — | AE12 |
| PN[11] | PCR[172] | Option 0 Option 1 Option 2 Option 3 | GPIO[172] DCULITE_G1 TXD_3 VIU3_PDI11 | — | SIUL DCULite LINFlex_3 VIU2/PDI | I/O | M | None, None | — | — | AF12 |
| PN[12] | PCR[173] | Option 0 Option 1 Option 2 Option 3 | GPIO[173] DCULITE_G2 — eMIOS0[17] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | R26 |
| PN[13] | PCR[174] | Option 0 Option 1 Option 2 Option 3 | GPIO[174] DCULITE_G3 — eMIOS0[18] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | R25 |
| PN[14] | PCR[175] | Option 0 Option 1 Option 2 Option 3 | GPIO[175] DCULITE_G4 — eMIOS0[19] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | P26 |
| PN[15] | PCR[176] | Option 0 Option 1 Option 2 Option 3 | GPIO[176] DCULITE_G5 — eMIOS0[20] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | P24 |
| PORT P | | | | | | | | | | | |
| PP[0] | PCR[177] | Option 0 Option 1 Option 2 Option 3 | GPIO[177] DCULITE_G6 — eMIOS0[21] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | P23 |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|----------|--|---|-------------------------------|--|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PP[1] | PCR[178] | Option 0 Option 1 Option 2 Option 3 | GPIO[178] DCULITE_G7 — eMIOS0[22] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | N26 |
| PP[2] | PCR[179] | Option 0 Option 1 Option 2 Option 3 | GPIO[179] DCULITE_B0 CANRX_2 VIU4_PDI2 | — | SIUL DCULite FlexCAN_2 VIU2/PDI | I/O | M | None, None | — | — | N25 |
| PP[3] | PCR[180] | Option 0 Option 1 Option 2 Option 3 | GPIO[180] DCULITE_B1 CANTX_2 PDI_DE | — | SIUL DCULite FlexCAN_2 PDI | I/O | M | None, None | — | — | N23 |
| PP[4] | PCR[181] | Option 0 Option 1 Option 2 Option 3 | GPIO[181] DCULITE_B2 — eMIOS0[11] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | M26 |
| PP[5] | PCR[182] | Option 0 Option 1 Option 2 Option 3 | GPIO[182] DCULITE_B3 — eMIOS0[13] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | M25 |
| PP[6] | PCR[183] | Option 0 Option 1 Option 2 Option 3 | GPIO[183] DCULITE_B4 — eMIOS0[15] | — | SIUL DCULite — PWM/Timer | I/O | M | None, None | — | — | M24 |
| PP[7] | PCR[184] | Option 0 Option 1 Option 2 Option 3 | GPIO[184] DCULITE_B5 — I2S_FS | — | SIUL DCULite — SGM | I/O | M | None, None | — | — | M23 |
| PP[8] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PP[9] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PP[10] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PP[11] | — | — | Reserved | — | — | — | — | — | — | — | — |

Table 7. Port pin summary (continued)

| Port pin | PCR | Alternate function ¹ | Function | Special function ² | Peripheral ³ | I/O direction | Pad Type ⁴ | RESET config ⁵ | Pin number | | |
|----------|-----|---------------------------------|----------|-------------------------------|-------------------------|---------------|-----------------------|---------------------------|------------|----------|------------|
| | | | | | | | | | 176 LQFP | 208 LQFP | 416 TEPBGA |
| PP[12] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PP[13] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PP[14] | — | — | Reserved | — | — | — | — | — | — | — | — |
| PP[15] | — | — | Reserved | — | — | — | — | — | — | — | — |

¹ Alternate functions are chosen by setting the values of the PCR[PA] bitfields inside the SIUL module.

PCR[PA] = 00 selects Option 0

PCR[PA] = 01 selects Option 1

PCR[PA] = 10 selects Option 2

PCR[PA] = 11 selects Option 3

This is intended to select the output functions. To use one of the input functions, the PCR[IBE] bit must be written to '1', regardless of the values selected in the PCR[PA] bitfields. For this reason, the value corresponding to an input only function is reported as "—".

² Special functions are enabled independently from the standard digital pin functions. Enabling standard I/O functions in the PCR registers may interfere with their functionality. ADC functions are enabled using the PCR[APC] bit; other functions are enabled by enabling the respective module.

³ Using the PSMI registers in the System Integration Unit Lite (SIUL), different pads can be multiplexed to the same peripheral input. Please see the SIUL chapter of the *MPC5645S Microcontroller Reference Manual* for details.

⁴ See the "Pad types" section for an explanation of the letters in this column.

⁵ Reset configuration is given as I/O direction and pull, e.g., "Input, pullup".

⁶ Out of reset pins PH[0:3] are available as JTAG pins (TCK, TDI, TDO and TMS respectively). It is up to the user to configure pins PH[0:3] when needed.

The following pad types are available for system pins and functional port pins:

Table 8. Pad Types

| Pad | Function |
|--------|---|
| S | Slow (pad_ssr, pad_ssr_hv) |
| M | Medium (pad_msr, pad_msr_hv) |
| F | Fast (pad_fc) |
| J | Input/output with analog features (pad_tgate, pad_tgate_hv) |
| Analog | Input only with analog features (pad_ae, pad_ae_hv) |
| SMD | Stepper Motor Detector |
| DDR | DDR pads |
| RSDS | RSDS pads |

3 System design information

3.1 Power-up sequencing

The preferred power-up sequence for MPC5645S is as follows:

1. Generic IO supplies or noise-free supplies, consisting of:
 - VDDA
 - VDDE_A
 - VDDE_B
 - VDDM
 - VDD_DR
 - VDD33_DR
 - VDDPLL
2. All 3.3V supplies (VDDE_B & VDD33_DR) should be ramped up first, and then the rest of the I/O supplies should be ramped up (VDDA, VDDE_A, VDDM, VDD_DR).
3. VDDR, the regulator input supply, should be the last supply to ramp up; all supplies can be ramped up together as long as VDDR is included. So all 5V supplies should be ramped up after the 3.3V supplies, and if all the supplies are of the same level, they can be ramped up together as well.
4. LV supply (VDD12). If VREG is in bypass mode and the core supply (1.2V) is supplied externally, then this should be the last supply given.

NOTE

For DDR, the 3.3 V supply (VDD33_DR) should come before VDD_DR.

This sequence ensures that when VREG releases its LVDs, the IO and other HV segments are powered properly. This is important because MPC5645S doesn't monitor LVDs on IO HV supplies.

4 Electrical characteristics

4.1 Introduction

This section contains electrical characteristics of the device as well as temperature and power considerations.

This product contains devices to protect the inputs against damage due to high static voltages. However, it is advisable to take precautions to avoid application of any voltage higher than the specified maximum rated voltages.

To enhance reliability, unused inputs can be driven to an appropriate logic voltage level (V_{DD} or V_{SS}). This could be done by internal pull up and pull down, which is provided by the product for most general purpose pins.

The parameters listed in the following tables represent the characteristics of the device and its demands on the system.

In the tables where the device logic provides signals with their respective timing characteristics, the symbol “CC” for Controller Characteristics is included in the Symbol column.

In the tables where the external system must provide signals with their respective timing characteristics to the device, the symbol “SR” for System Requirement is included in the Symbol column.

4.2 Parameter classification

The electrical parameters shown in this supplement are guaranteed by various methods. To give the customer a better understanding, the classifications listed in Table 9 are used and the parameters are tagged accordingly in the tables where appropriate.

Table 9. Parameter Classifications

| Classification tag | Tag description |
|--------------------|--|
| P | Those parameters are guaranteed during production testing on each individual device. |
| C | Those parameters are achieved by the design characterization by measuring a statistically relevant sample size across process variations. |
| T | Those parameters are achieved by design characterization on a small sample size from typical devices under typical conditions unless otherwise noted. All values shown in the typical column are within this category. |
| D | Those parameters are derived mainly from simulations. |

NOTE

The classification is shown in the column labeled “C” in the parameter tables where appropriate.

4.3 Absolute maximum ratings

Table 10. Absolute maximum ratings

| Symbol | C | Parameter | Conditions | Value | | Unit | SpecID |
|---------------------------------|----|---|-----------------------------|----------------------|----------------------|------|--------|
| | | | | Min | Max | | |
| V _{DDA} | SR | D Voltage on VDDA pin (ADC reference) with respect to ground (V _{SSA}) | — | -0.3 | +5.5 | V | D1.1 |
| | | | Relative to V _{DD} | V _{DD} -0.3 | V _{DD} +0.3 | | |
| V _{SSA} | SR | D Voltage on VSSA (ADC reference) pin with respect V _{SS} | — | V _{SS} -0.1 | V _{SS} +0.1 | V | D1.2 |
| V _{DDPLL} | CC | D Voltage on VDDPLL (1.2 V PLL supply) pin with respect to ground (V _{SSPLL}) | — | 1.08 | 1.4 | V | D1.3 |
| | | | Relative to V _{DD} | V _{DD} -0.3 | V _{DD} +0.3 | | |
| V _{DDR} | SR | D Voltage on VDDR pin (regulator supply) with respect to ground (V _{SSR}) | — | -0.3 | +5.5 | V | D1.4 |
| | | | Relative to V _{DD} | V _{DD} -0.3 | V _{DD} +0.3 | | |
| V _{SSR} | SR | D Voltage on VSSR (regulator ground) pin with respect to V _{SS} | — | V _{SS} -0.1 | V _{SS} +0.1 | V | D1.5 |
| V _{DD12} | CC | D Voltage on VDD12 pin with respect to ground (V _{SS12}) | — | 1.08 | 1.4 | V | D1.6 |
| V _{SS12} | CC | D Voltage on VSS12 pin with respect to V _{SS} | — | V _{SS} -0.1 | V _{SS} +0.1 | V | D1.7 |
| V _{DDE_A} ¹ | SR | D Voltage on VDDE_A (I/O supply) pin with respect to ground (V _{SSE_A}) | — | -0.3 | +5.5 | V | D1.8 |
| V _{DDE_B} ¹ | SR | D Voltage on VDDE_B (I/O supply) pin with respect to ground (V _{SS}) | — | -0.3 | +3.6 | V | D1.9 |

Table 10. Absolute maximum ratings (continued)

| Symbol | C | Parameter | Conditions | Value | | Unit | SpecID | |
|---------------|----|-----------|---|-------|------|---|--------|-------|
| | | | | Min | Max | | | |
| V_{DDM}^1 | SR | D | Voltage on VDDM (stepper motor supply) pin with respect to ground (V_{SSM}) | — | -0.3 | +5.5 | V | D1.10 |
| V_{SS}^2 | SR | D | I/O supply ground | — | 0 | 0 | V | D1.11 |
| V_{DD_DR} | | D | Voltage on VDDDDR with respect to V_{SS} | — | -0.3 | 3.6 | V | D1.12 |
| V_{RSDS} | | D | Voltage on VDDRSDS with respect to V_{SS} | — | -0.3 | 3.6 | V | D1.13 |
| V_{IN} | SR | D | Voltage on any GPIO pin with respect to ground (V_{SS}) | — | -0.3 | V_{DDmax} (V_{DDE} max of that segment) | V | — |
| I_{INJPAD} | SR | D | Injected input current on any pin during overload condition | — | -10 | 10 | mA | D1.15 |
| I_{INJSUM} | SR | D | Absolute sum of all injected input currents during overload condition | — | -50 | 50 | | D1.16 |
| $T_{STORAGE}$ | SR | T | Storage temperature | — | -55 | 150 | °C | D1.17 |
| ESD_{HBM} | SR | T | ESD Susceptibility (Human Body Model) | — | — | 2000 | V | D1.18 |

¹ Throughout the remainder of this document V_{DD} refers collectively to I/O voltage supplies, i.e., V_{DDE_A} , V_{DDE_B} , and V_{DDM} , unless otherwise noted.

² Throughout the remainder of this document V_{SS} refers collectively to I/O voltage supply grounds, i.e., V_{SSE_A} , V_{SSPLL} , and V_{SSM} , unless otherwise noted.

NOTE

Stresses exceeding the recommended absolute maximum ratings may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. During overload conditions ($V_{IN} > V_{DD}$ or $V_{IN} < V_{SS}$), the voltage on pins with respect to ground (V_{SS}) must not exceed the recommended values.

4.4 Recommended operating conditions

Table 11. Recommended operating conditions (3.3 V)

| Symbol | C | Parameter | Conditions | Value | | Unit | SpecID | |
|-------------|----|---|---|--------------|--------------|--------------|--------|------|
| | | | | Min | Max | | | |
| V_{DDA}^1 | SR | Voltage on VDDA pin (ADC reference) with respect to ground (V_{SS}) | — | +3.0 | +3.6 | V | D2.1 | |
| | | | Relative to V_{DD} | $V_{DD}-0.1$ | $V_{DD}+0.1$ | | | |
| V_{SSA} | SR | P | Voltage on VSSA (ADC reference) pin with respect V_{SS} | — | $V_{SS}-0.1$ | $V_{SS}+0.1$ | V | D2.2 |
| V_{DDPLL} | CC | P | Voltage on VDDPLL (1.2 V PLL supply) pin with respect to ground (V_{SSPLL}) | — | 1.08 | 1.32 | V | D2.3 |

Table 11. Recommended operating conditions (3.3 V) (continued)

| Symbol | C | Parameter | Conditions | Value | | Unit | SpecID |
|----------------------------------|----|---|-----------------------------|---------------------------------|---------------------------------|------|--------|
| | | | | Min | Max | | |
| V _{DDR} ² | SR | Voltage on VDDR pin (regulator supply) with respect to ground (V _{SSR}) | — | +3.0 | +3.6 | V | D2.4 |
| | D | | Relative to V _{DD} | V _{DD} -0.1 | V _{DD} +0.1 | | |
| V _{SSR} | SR | D | — | V _{SS} -0.1 | V _{SS} +0.1 | V | D2.5 |
| V _{DD12} ^{3,4} | CC | P | — | 1.08 | 1.4 | V | D2.6 |
| V _{SS12} | CC | D | — | V _{SS} -0.1 | V _{SS} +0.1 | V | D2.7 |
| V _{DD} ^{5,6,7} | SR | P | — | V _{DDmin} ⁵ | V _{DDmax} ⁵ | V | D2.8 |
| V _{SS} ⁸ | SR | D | — | 0 | 0 | V | D2.9 |
| V _{DDE_A} ⁹ | SR | P | — | +3.0 | +3.6 | V | D2.10 |
| V _{DDE_B} | SR | P | — | +3.0 | +3.6 | V | D2.11 |
| V _{DDM} | SR | P | — | +3.0 | +3.6 | V | D2.12 |
| V _{DD_DR} | | P | — | +1.62 | +3.6 | V | D2.13 |
| V _{SS_DR} | | D | — | +1.62 | +3.6 | V | D2.14 |
| V _{RSDS} | | P | — | +3.0 | +3.6 | V | D2.15 |
| TV _{DD} | SR | D | — | — | 12 | V/ms | D2.16 |
| T _A | SR | P | — | -40 | +105 | °C | D2.17 |
| T _J | SR | D | | -40 | +140 | | D2.18 |

¹ 100 nF capacitance needs to be provided between V_{DDA}/V_{SSA} pair.

² 10 μF capacitance must be connected between V_{DDR} and V_{SS12} because of a sharp surge due to external ballast.

³ V_{DD12} cannot be used to drive any external component.

⁴ Each V_{DD12}/V_{SS12} supply pair should have a 10 μF capacitor. Absolute combined maximum capacitance is 40 μF. Preferably, all the VDD12 supply pads should be shorted and then connected to a 4×10 μF capacitance. This is to ensure the ESR of external capacitance does not exceed 0.2 Ω. A 100 nF capacitor must be placed close to the pin.

⁵ V_{DD} refers collectively to I/O voltage supplies, i.e., V_{DDE_A}, V_{DDE_B}, V_{DD_DR}, and V_{DDM}.

⁶ 100 nF capacitance needs to be provided between each V_{DD}/V_{SS} pair. VDDmin value for is 3 V for VDDE_A & VDDM as well as for VDDE_B, while it is 1.62 V for VDD_DR. VDD max value is 3.6 V for VDDE_A & VDDM as well as for VDDE_B & VDD_DR.

⁷ Full electrical specification cannot be guaranteed when voltage drops below 3.0V. In particular, ADC electrical characteristics and I/O's DC electrical specification may not be guaranteed.

When voltage drops below V_{LVDHVL} device is reset.

⁸ V_{SS} refers collectively to I/O voltage supply grounds, i.e., V_{SSE_A}, V_{SS}, and V_{SSE_B} unless otherwise noted.

⁹ V_{DDE_A} should not be less than V_{DDA}.

¹⁰ Guaranteed by device validation.

4.5 Thermal characteristics

Table 12. Recommended operating conditions (5.0 V)

| Symbol | C | Parameter | Conditions | Value | | Unit | SpecID | | |
|-----------------------------------|----|-----------|---|---------------------------|---------------------------------|---------------------------------|--------|-------|----------------------|
| | | | | Min | Max | | | | |
| V _{DDA} ¹ | SR | P | Voltage on VDDA pin (ADC reference) with respect to ground (V _{SS}) | — | +4.5 | +5.5 | V | D2.19 | |
| | | | | D | Voltage drop ² | +3.0 | | | +5.5 |
| | | | | | Relative to V _{DD} | V _{DD} -0.1 | | | V _{DD} +0.1 |
| V _{SSA} | SR | D | Voltage on VSSA (ADC reference) pin with respect V _{SS} | — | V _{SS} -0.1 | V _{SS} +0.1 | V | D2.20 | |
| V _{DDPLL} | CC | P | Voltage on VDDPLL (1.2 V PLL supply) pin with respect to ground (V _{SSPLL}) | — | 1.08 | 1.32 | V | D2.21 | |
| V _{DDR} ³ | SR | P | Voltage on VDDR pin (regulator supply) with respect to ground (V _{SSR}) | — | +3.0 | +3.6 | V | D2.22 | |
| | | | | D | Voltage drop ² | +3.0 | | | +3.6 |
| | | | | | Relative to V _{DD} | V _{DD} -0.1 | | | V _{DD} +0.1 |
| V _{SSR} | SR | D | Voltage on VSSR (regulator ground) pin with respect to V _{SS} | — | V _{SS} -0.1 | V _{SS} +0.1 | V | D2.23 | |
| V _{DD12} ^{4,5} | CC | P | Voltage on VDD12 pin with respect to ground (V _{SS12}) | — | 1.08 | 1.4 | V | D2.24 | |
| V _{SS12} | CC | D | Voltage on VSS12 pin with respect to V _{SS} | — | V _{SS} -0.1 | V _{SS} +0.1 | V | D2.25 | |
| V _{DD} ^{6,7} | SR | P | Voltage on VDD pins (VDDE_A, VDDE_B, VDD_DR, VDDMA, VDDMB, VDDMC) with respect to ground (V _{SS}) | Voltage drop ² | V _{DDmin} ⁶ | V _{DDmax} ⁶ | V | D2.26 | |
| V _{SS} ⁸ | SR | D | I/O supply ground | — | 0 | 0 | V | D2.27 | |
| V _{DDDE_A} ⁹ | SR | P | Voltage on VDDE_A (I/O supply) pin with respect to ground (V _{SSE_A}) | — | +4.5 | +5.5 | V | D2.28 | |
| V _{DDDE_B} ¹⁰ | SR | P | Voltage on VDDE_B (I/O supply) pin with respect to ground (V _{SSE_B}) | — | +3.0 | +3.6 | V | D2.29 | |
| V _{DDM} | SR | P | Voltage on VDDMA (stepper motor supply) pin with respect to ground (V _{SSMA}) | — | +4.5 | +5.5 | V | D2.30 | |
| V _{DD_DR} ¹¹ | | P | Voltage on V _{DD_DR} with respect to V _{SS} | — | +1.62 | +3.6 | V | D2.31 | |
| V _{SS_DR} | | D | Voltage on V _{SSRSDS} with respect to V _{SS} | — | +1.62 | +3.6 | V | D2.32 | |
| V _{RSDS} | | P | Voltage on V _{DD_DR} with respect to V _{SS} | — | +3.0 | +3.6 | V | D2.33 | |
| TV _{DD} | SR | D | V _{DD} slope to ensure correct power up ¹² | — | — | 12 | V/ms | D2.34 | |
| T _A | SR | P | Ambient temperature under bias | — | -40 | +105 | °C | D2.35 | |
| | | | | | -40 | +105 | | | |
| T _J | SR | D | Junction temperature under bias | — | -40 | +140 | — | D2.36 | |

¹ 100 nF capacitance needs to be provided between V_{DDA}/V_{SSA} pair.

² Full functionality cannot be guaranteed when voltage drops below 4.5 V. In particular, I/O DC and ADC electrical characteristics may not be guaranteed below 4.5 V during the voltage drop sequence.

³ 10 μF capacitance must be connected between V_{DDR} and V_{SS12}. It is recommended that this cap should be placed, as close as possible to the DUT pin on board.

- ⁴ V_{DD12} cannot be used to drive any external component.
- ⁵ Each V_{DD12}/V_{SS12} supply pair should have a 10 μ F capacitor. Absolute combined maximum capacitance is 40 μ F. Preferably, all the VDD12 supply pads should be shorted and then connected to a 4x10 μ F capacitance. This is to ensure the ESR of external capacitance does not exceed 0.2 Ω . A 100 nF capacitor must be placed close to the pin.
- ⁶ V_{DD} refers collectively to I/O voltage supplies, i.e., V_{DDE_A} , V_{DDE_B} , V_{DDE_DR} , V_{DDMA} , V_{DDMB} and V_{DDMC} . VDDmin value for is 4.5 V for V_{DDE_A} & V_{DDM} , 3 V V_{DDE_B} , while it is 1.62 V for V_{DD_DR} . VDD max value is 5.5 V for V_{DDE_A} & V_{DDM} and 3.6 V for V_{DDE_B} & V_{DD_DR} .
- ⁷ 100 nF capacitance needs to be provided between each V_{DD}/V_{SS} pair.
- ⁸ V_{SS} refers collectively to I/O voltage supply grounds, i.e., V_{SSE_A} , V_{SSE_B} , V_{SSE_A} , V_{SSE_E} , V_{SSMA} , V_{SSMB} and V_{SSMC}) unless otherwise noted.
- ⁹ V_{DDE_A} should not be less than V_{DDA} .
- ¹⁰ V_{DDE_B} cannot go beyond 3.6V under any operating condition.
- ¹¹ V_{DD_DR} can be 1.8, 2.5 and 3.3V (typical) based on type of SDR memory.
- ¹² Guaranteed by device validation.

Table 13. Thermal characteristics for 176-pin LQFP¹

| Symbol | C | D | Parameter | Conditions | Value | Unit | SpecID |
|--------------------|----|---|---|--|-------|------|--------|
| $R_{\theta JA}$ | CC | D | Junction to Ambient Natural Convection ² | Single layer board - 1s | 36 | °C/W | D3.1 |
| $R_{\theta JA}$ | CC | D | Junction to Ambient Natural Convection ² | Four layer board - 2s2p | 29 | °C/W | D3.2 |
| $R_{\theta JMA}$ | CC | D | Junction to Ambient ² | @200 ft./min., single layer board - 1s | 28 | °C/W | D3.3 |
| $R_{\theta JMA}$ | CC | D | Junction to Ambient ² | @200 ft./min., Four layer board - 2s2p | 23 | °C/W | D3.4 |
| $R_{\theta JB}$ | CC | D | Junction to Board ³ | — | 18 | °C/W | D3.5 |
| $R_{\theta JCtop}$ | CC | D | Junction to Case (Top) ⁴ | — | 5 | °C/W | D3.6 |
| Ψ_{JT} | CC | D | Junction to Package Top Natural Convection ⁵ | — | 2 | °C/W | D3.7 |

- ¹ Thermal characteristics are targets based on simulation that are subject to change per device characterization.
- ² Junction-to-Ambient Thermal Resistance determined per JEDEC JESD51-3 and JESD51-6. Thermal test board meets JEDEC specification for this package.
- ³ Junction-to-Board thermal resistance determined per JEDEC JESD51-8. Thermal test board meets JEDEC specification for the specified package.
- ⁴ Junction-to-Case at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.
- ⁵ Thermal characterization parameter indicating the temperature difference between the package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

Table 14. Thermal characteristics for 208-pin LQFP¹

| Symbol | C | D | Parameter | Conditions | Value | Unit | SpecID |
|--------------------|----|---|---|--|-------|------|--------|
| $R_{\theta JA}$ | CC | D | Junction to Ambient Natural Convection ² | Single layer board - 1s | 34 | °C/W | D3.8 |
| $R_{\theta JA}$ | CC | D | Junction to Ambient Natural Convection ² | Four layer board - 2s2p | 27 | °C/W | D3.9 |
| $R_{\theta JMA}$ | CC | D | Junction to Ambient ² | @200 ft./min., single layer board - 1s | 27 | °C/W | D3.10 |
| $R_{\theta JMA}$ | CC | D | Junction to Ambient ² | @200 ft./min., Four layer board - 2s2p | 22 | °C/W | D3.11 |
| $R_{\theta JB}$ | CC | D | Junction to Board ³ | — | 18 | °C/W | D3.12 |
| $R_{\theta JCtop}$ | CC | D | Junction to Case (Top) ⁴ | — | 5 | °C/W | D3.13 |

Table 14. Thermal characteristics for 208-pin LQFP¹ (continued)

| Symbol | C | Parameter | Conditions | Value | Unit | SpecID |
|-------------|----|---|------------|-------|------|--------|
| Ψ_{JT} | CC | D Junction to Package Top Natural Convection ⁵ | — | 2 | °C/W | D3.14 |

- ¹ Thermal characteristics are targets based on simulation that are subject to change per device characterization.
- ² Junction-to-Ambient Thermal Resistance determined per JEDEC JESD51-3 and JESD51-6. Thermal test board meets JEDEC specification for this package.
- ³ Junction-to-Board thermal resistance determined per JEDEC JESD51-8. Thermal test board meets JEDEC specification for the specified package.
- ⁴ Junction-to-Case at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.
- ⁵ Thermal characterization parameter indicating the temperature difference between the package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

Table 15. Thermal characteristics for 416-pin TEPBGA¹

| Symbol | C | Parameter | Conditions | Value | Unit | SpecID |
|--------------------|----|---|--|-------|------|--------|
| $R_{\theta JA}$ | CC | D Junction to Ambient Natural Convection ² | Single layer board - 1s | 26 | °C/W | D3.15 |
| $R_{\theta JA}$ | CC | D Junction to Ambient Natural Convection ² | Four layer board - 2s2p | 18 | °C/W | D3.16 |
| $R_{\theta JMA}$ | CC | D Junction to Ambient ² | @200 ft./min., single layer board - 1s | 20 | °C/W | D3.17 |
| $R_{\theta JMA}$ | CC | D Junction to Ambient ² | @200 ft./min., Four layer board - 2s2p | 15 | °C/W | D3.18 |
| $R_{\theta JB}$ | CC | D Junction to Board ³ | — | 10 | °C/W | D3.19 |
| $R_{\theta JCTop}$ | CC | D Junction to Case (Top) ⁴ | — | 6 | °C/W | D3.20 |
| Ψ_{JT} | CC | D Junction to Package Top Natural Convection ⁵ | — | 2 | °C/W | D3.21 |

- ¹ Thermal characteristics are targets based on simulation that are subject to change per device characterization.
- ² Junction-to-Ambient Thermal Resistance determined per JEDEC JESD51-3 and JESD51-6. Thermal test board meets JEDEC specification for this package.
- ³ Junction-to-Board thermal resistance determined per JEDEC JESD51-8. Thermal test board meets JEDEC specification for the specified package.
- ⁴ Junction-to-Case at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.
- ⁵ Thermal characterization parameter indicating the temperature difference between the package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

4.5.1 General notes for specifications at maximum junction temperature

An estimate of the chip junction temperature, T_J , can be obtained from the equation:

$$T_J = T_A + (R_{\theta JA} * P_D) \quad \text{Eqn. 1}$$

where:

T_A = ambient temperature for the package (°C)

$R_{\theta JA}$ = junction to ambient thermal resistance (°C/W)

P_D = power dissipation in the package (W)

The thermal resistance values used are based on the JEDEC JESD51 series of standards to provide consistent values for estimations and comparisons. The difference between the values determined for the single-layer (1s) board compared to a four-layer board that has two signal layers, a power and a ground plane (2s2p), demonstrate that the effective thermal resistance is not a constant. The thermal resistance depends on the:

- Construction of the application board (number of planes)
- Effective size of the board which cools the component
- Quality of the thermal and electrical connections to the planes
- Power dissipated by adjacent components

Connect all the ground and power balls to the respective planes with one via per ball. Using fewer vias to connect the package to the planes reduces the thermal performance. Thinner planes also reduce the thermal performance. When the clearance between the vias leave the planes virtually disconnected, the thermal performance is also greatly reduced.

As a general rule, the value obtained on a single-layer board is within the normal range for the tightly packed printed circuit board. The value obtained on a board with the internal planes is usually within the normal range if the application board has:

- One oz. (35 micron nominal thickness) internal planes
- Components are well separated
- Overall power dissipation on the board is less than 0.02 W/cm²

The thermal performance of any component depends on the power dissipation of the surrounding components. In addition, the ambient temperature varies widely within the application. For many natural convection and especially closed box applications, the board temperature at the perimeter (edge) of the package is approximately the same as the local air temperature near the device. Specifying the local ambient conditions explicitly as the board temperature provides a more precise description of the local ambient conditions that determine the temperature of the device.

At a known board temperature, the junction temperature is estimated using the following equation:

$$T_J = T_B + (R_{\theta JB} * P_D) \quad \text{Eqn. 2}$$

where:

T_B = board temperature for the package perimeter (°C)

$R_{\theta JB}$ = junction-to-board thermal resistance (°C/W) per JESD51-8S

P_D = power dissipation in the package (W)

When the heat loss from the package case to the air does not factor into the calculation, an acceptable value for the junction temperature is predictable. Ensure the application board is similar to the thermal test condition, with the component soldered to a board with internal planes.

The thermal resistance is expressed as the sum of a junction-to-case thermal resistance plus a case-to-ambient thermal resistance:

$$R_{\theta JA} = R_{\theta JC} + R_{\theta CA} \quad \text{Eqn. 3}$$

where:

$R_{\theta JA}$ = junction to ambient thermal resistance (°C/W)

$R_{\theta JC}$ = junction to case thermal resistance (°C/W)

$R_{\theta CA}$ = case to ambient thermal resistance (°C/W)

$R_{\theta JC}$ is device related and is not affected by other factors. The thermal environment can be controlled to change the case-to-ambient thermal resistance, $R_{\theta CA}$. For example, change the air flow around the device, add a heat sink, change the mounting arrangement on the printed circuit board, or change the thermal dissipation on the printed circuit board surrounding the device. This description is most useful for packages with heat sinks where 90% of the heat flow is through the case to heat sink to ambient. For most packages, a better model is required.

A more accurate two-resistor thermal model can be constructed from the junction-to-board thermal resistance and the junction-to-case thermal resistance. The junction-to-case thermal resistance describes when using a heat sink or where a substantial amount of heat is dissipated from the top of the package. The junction-to-board thermal resistance describes the thermal performance when most of the heat is conducted to the printed circuit board. This model can be used to generate simple estimations and for computational fluid dynamics (CFD) thermal models.

To determine the junction temperature of the device in the application on a prototype board, use the thermal characterization parameter (Ψ_{JT}) to determine the junction temperature by measuring the temperature at the top center of the package case using the following equation:

$$T_J = T_T + (\Psi_{JT} \times P_D) \quad \text{Eqn. 4}$$

where:

T_T = thermocouple temperature on top of the package ($^{\circ}\text{C}$)

Ψ_{JT} = thermal characterization parameter ($^{\circ}\text{C}/\text{W}$)

P_D = power dissipation in the package (W)

The thermal characterization parameter is measured in compliance with the JESD51-2 specification using a 40-gauge type T thermocouple epoxied to the top center of the package case. Position the thermocouple so that the thermocouple junction rests on the package. Place a small amount of epoxy on the thermocouple junction and approximately 1 mm of wire extending from the junction. Place the thermocouple wire flat against the package case to avoid measurement errors caused by the cooling effects of the thermocouple wire.

References:

Semiconductor Equipment and Materials International
805 East Middlefield Rd.
Mountain View, CA 94043
(415) 964-5111

MIL-SPEC and EIA/JESD (JEDEC) specifications are available from Global Engineering Documents at 800-854-7179 or 303-397-7956.

JEDEC specifications are available on the WEB at <http://www.jedec.org>.

4.6 EMI (electromagnetic interference) characteristics

Table 16. EMI testing specifications^{1 2}

| Symbol | Parameter | Conditions | Clocks | Frequency Range | Level (Typ) | Unit |
|--------------------|------------------|--|--|--------------------|-------------|------|
| Radiated Emissions | V _{EME} | Device Configuration, test conditions and EM testing per standard IEC61967-2 | FOSC – 8MHz, External Crystal FCPU – 124MHz FBUS – 124MHz No PLL Frequency Modulation | 150 kHz – 50 MHz | 19 | dBμV |
| | | | | 50 MHz – 150 MHz | 30 | |
| | | | | 150 MHz – 500 MHz | 25 | |
| | | | | 500 MHz – 1000 MHz | 19 | |
| | | | | IEC Level | K | |
| | | | FOSC - 8MHz, External Crystal FCPU -124MHz FBUS -124MHz 2% PLL Frequency Modulation | 150 kHz – 50 MHz | 15 | dBμV |
| | | | | 50 MHz – 150 MHz | 24 | |
| | | | | 150 MHz – 500 MHz | 17 | |
| | | | | 500 MHz – 1000 MHz | 14 | |
| | | | | IEC Level | L | |

¹ The reported emission level is the value of the maximum emission, rounded up to the next whole number.

² IEC Level Maximum: L is less than or equal to 24 dBμV, K is less than or equal to 30 dBμV.

4.7 Power management

4.7.1 Voltage regulator electrical characteristics

The internal voltage regulator requires an external NPN (BCP68 or NJD2873) ballast to be connected as shown in [Figure 6](#) as well as an external capacitance (C_{REG}) to be connected to the device in order to provide a stable low voltage digital supply to the device. Capacitances should be placed on the board as near as possible to the associated pins. Care should also be taken to limit the serial inductance of the board to less than 15 nH.

For the MPC5645S microcontroller, 100 nF should be placed between each V_{DD12}/V_{SS12} supply pair and also between the V_{DDPLL}/V_{SSPLL} pair. Additionally, 10 μF should be placed between the V_{DDR} pin and the adjacent V_{SS} pin.

V_{DDR} = 3.0 V to 3.6 V / 4.5 V to 5.5 V, T_A = -40 to 105 °C, unless otherwise specified.

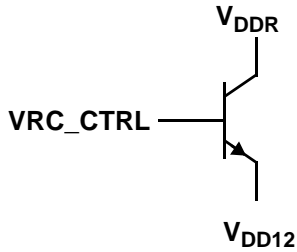


Figure 6. External NPN ballast connections

Table 17. Voltage regulator electrical characteristics

| Symbol | C | Parameter | Conditions | Min | Max | Unit | SpecID | | |
|-------------------|----|-----------|---|---|------------------|--|--------|-------|------|
| V _{DDR} | SR | P | Power supply | — | 3.0 | 5.5 | V | D5.1 | |
| T _J | SR | D | Junction temperature | — | -40 | 140 | °C | D5.2 | |
| I _{REG} | CC | T | Current consumption | Reference included, @ 55 °C No load @ Full load | — | 2 11 | mA | D5.3 | |
| I _L | CC | T | Output current capacity | DC load current | — | 450 | mA | D5.4 | |
| V _{DD12} | CC | D | Output voltage (value @ I _L = 0 @ 27°C) | Pre-trimming sigma < 7 mV | — | 1.330 | V | D5.5 | |
| | | P | | Post-trimming | 1.145 | 1.32 | | | |
| | | T | Output voltage (value @ I _L = I _{max}) | Post-trimming | 1.145 | — | | | |
| | SR | D | External decoupling/stability capacitor | 4 capacitances of 10 μF each | 10 * 4 | | μF | D5.6 | |
| | | D | | ESR of external cap | 0.05 | 0.2 | | | Ω |
| | | D | | 1 bond wire R + 1 pad R | 0.2 | 1 | | | Ω |
| L _{BOND} | CC | D | Bonding Inductance for Bipolar Base Control pad | — | 0 | 15 | nH | D5.7 | |
| | CC | D | Power supply rejection | @ DC @ no load | Load = 10 μF * 4 | — | -30 | dB | D5.8 |
| | | | | @ 200 kHz @ no load | | -100 | | | |
| | | | | @ DC @ 400 mA | | -30 | | | |
| | | | | @ 200 kHz @ 400 mA | | -30 | | | |
| | CC | D | Load current transient | Load = 10 μF * 4 | — | 10% to 90% of I _L (max) in 100 ns | | D5.9 | |
| t _{SU} | CC | T | Start-up time after input supply stabilizes ¹ | Load = 10 μF * 4 | — | 500 | μs | D5.10 | |

¹ Time after the input supply to the voltage regulator has ramped up (VDDR) and the voltage regulator has asserted the Power OK signal.

Table 18. Low-power voltage regulator electrical characteristics

| Symbol | | C | Parameter | Conditions | Min | Max | Unit | SpecID |
|------------|----|---|-------------------------|---|------|----------|------|--------|
| T_J | SR | D | Junction temperature | — | -40 | 140 | °C | D5.2 |
| I_{REG} | CC | T | Current consumption | Reference included, @ 55 °C No load @ Full load | — | 5 600 | µA | D5.3 |
| I_L | CC | T | Output current capacity | DC load current | — | 15 | mA | D5.4 |
| V_{DD12} | CC | D | Output voltage | Pre-trimming sigma < 7 mV | — | 1.33 | V | D5.5 |
| | | P | | Post-trimming | 1.14 | 1.32 | | |

Table 19. Ultra low-power voltage regulator electrical characteristics

| Symbol | | C | Parameter | Conditions | Min | Max | Unit | SpecID |
|------------|----|---|---|---|------|----------|------|--------|
| T_J | SR | D | Junction temperature | — | -40 | 140 | °C | D5.2 |
| I_{REG} | CC | T | Current consumption | Reference included, @ 55 °C No load @ Full load | — | 2 100 | µA | D5.3 |
| I_L | CC | T | Output current capacity | DC load current | — | 5 | mA | D5.4 |
| V_{DD12} | CC | D | Output voltage (value @ $I_L = 0$ @ 27°C) | Pre-trimming sigma < 7 mV | — | 1.33 | V | D5.5 |
| | | P | | Post-trimming | 1.14 | 1.32 | | |

4.7.2 Voltage monitor electrical characteristics

The device implements a Power On Reset module to ensure correct power-up initialization, as well as four low voltage detectors to monitor the V_{DD} and the V_{DD12} voltage while device is supplied:

- POR monitors V_{DD} during the power-up phase to ensure device is maintained in a safe reset state
- LVDHV3 monitors V_{DD} to ensure device reset below minimum functional supply
- LVDHV5 monitors V_{DD} when application uses device in the 5.0V ± 10% range
- LVDLVCOR monitors power domain No. 1
- LVDLVBKP monitors power domain No. 0

Table 20. Low voltage monitor electrical characteristics

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID | |
|------------------------|----|-----------|--|--|-------|-----|-------|--------|-------|
| | | | | Min | Typ | Max | | | |
| V _{PORH} | CC | C | Power-on reset threshold | — | 1.5 | — | 2.7 | V | D5.11 |
| V _{LVDHV3H} | CC | C | LVDHV3 low voltage detector high threshold | — | — | — | 2.9 | | D5.12 |
| V _{LVDHV3L} | CC | C | LVDHV3 low voltage detector low threshold | — | 2.5 | — | — | | D5.13 |
| V _{LVDHV5H} | CC | C | LVDHV5 low voltage detector high threshold | — | — | — | 4.4 | | D5.14 |
| V _{LVDHV5L} | CC | C | LVDHV5 low voltage detector low threshold | — | 3.9 | — | — | | D5.15 |
| V _{LVDLVCORH} | CC | C | LVDLVCOR low voltage detector high threshold | T _A = 25°C, after trimming | — | — | 1.185 | | D5.16 |
| V _{LVDLVCORL} | CC | C | LVDLVCOR low voltage detector low threshold | | 1.095 | — | — | | D5.17 |

¹ V_{DD} = 3.3V ± 10% / 5.0V ± 10%, T_A = -40 / +105°C, unless otherwise specified

² All values need to be confirmed during device validation.

4.7.3 Low voltage domain power consumption

Table 21 provides DC electrical characteristics for significant application modes. These values are indicative values; actual consumption depends on the application.

Table 21. DC electrical characteristics

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | |
|---------------------------------|----|-----------|---|-------------------------|-----|-------|------------------|----|
| | | | | Min | Typ | Max | | |
| I _{DDMAX} ² | CC | D | RUN mode maximum average current | — | — | 295 | 375 ³ | mA |
| I _{DDRUN} ⁴ | CC | P | RUN mode typical average current ⁵ f _{CPU} = 125MHz, Dual Display Drive with external DRAM, 416 TEPBGA package option only | — | — | 275 | — | mA |
| | | | | — | — | 240 | — | |
| I _{DDHALT} | CC | C | HALT mode current ⁶ Slow internal RC oscillator (128KHz) running | T _A = 25 °C | — | 17.5 | 23.5 | mA |
| | | | | T _A = 105 °C | — | 35 | 45.5 | |
| I _{DDSTOP} | CC | D | STOP mode current ⁷ Slow internal RC oscillator (128KHz) running | T _A = -40°C | — | 645 | — | μA |
| | | | | T _A = 0°C | — | 1100 | — | |
| | | | | T _A = 25°C | — | 1531 | 5500 | |
| | | | | T _A = 55°C | — | 3.8 | — | mA |
| | | | | T _A = 85°C | — | 9.7 | — | |
| | | | | T _A = 105°C | — | 17.67 | 36.5 | |

Table 21. DC electrical characteristics (continued)

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | | |
|-----------------------|----|-----------|---|----------------------------------|------------------------|-----|------|-----|----|
| | | | | Min | Typ | Max | | | |
| I _{DDSTDBY2} | CC | D | STANDBY2 mode current ⁸ (64K SRAM on) | SXOSC (32KHz) ON and RTC running | T _A = -40°C | — | 470 | — | μA |
| | | | | | T _A = 0°C | — | 480 | — | |
| | | | | | T _A = 25°C | — | 481 | 490 | |
| | | | | | T _A = 55°C | — | 525 | — | |
| | | | | | T _A = 85°C | — | 650 | — | |
| | | | | | T _A = 105°C | — | 870 | 910 | |
| | CC | D | SXOSC (32KHz) and RTC OFF | T _A = -40°C | — | 63 | — | μA | |
| | | | | T _A = 0°C | — | 85 | — | | |
| | | | | T _A = 25°C | — | 93 | 100 | | |
| | | | | T _A = 55°C | — | 95 | — | | |
| | | | | T _A = 85°C | — | 190 | — | | |
| | | | | T _A = 105°C | — | 390 | 430 | | |
| I _{DDSTDBY1} | CC | D | STANDBY1 mode current (8K SRAM on) ⁹ | SXOSC (32KHz) ON and RTC running | T _A = -40°C | — | 415 | — | μA |
| | | | | | T _A = 0°C | — | 422 | — | |
| | | | | | T _A = 25°C | — | 426 | 430 | |
| | | | | | T _A = 55°C | — | 575 | — | |
| | | | | | T _A = 85°C | — | 680 | — | |
| | | | | | T _A = 105°C | — | 810 | 915 | |
| | CC | D | SXOSC (32 KHz) and RTC OFF | T _A = -40°C | — | 20 | — | μA | |
| | | | | T _A = 0°C | — | 22 | — | | |
| | | | | T _A = 25°C | — | 29 | 75 | | |
| | | | | T _A = 55°C | — | 47 | — | | |
| | | | | T _A = 85°C | — | 118 | — | | |
| | | | | T _A = 105°C | — | 236 | 410 | | |

¹ V_{DD} = 3.0V to 5.5V, T_A = -40 to 105 °C, unless otherwise specified.

² I_{DDMAX} is composed of the current consumption on all supplies (V_{DD12}, V_{DDE_A}, V_{DDE_B}, V_{DDA}, V_{DDR}, V_{DDM}, V_{DDPLL}, V_{DD_DR}). It does not include current consumption linked to I/Os toggling which is highly dependent on the application. The given value is thought to be a worst case value with all peripherals running, and code fetched from code flash while modify operation on-going on data flash. It is to be noticed that this value can be significantly reduced by application; switch-off not used peripherals (default), reduce peripheral frequency through internal prescaler, fetch from RAM most used functions, use low power mode when possible.

³ Higher current may be sinked by device during power-up and standby exit. Please refer to inrush current in [Table 22](#).

⁴ RUN current measured with typical application and accesses on both flash and RAM.

⁵ Data and Code Flash in Normal Power. Code fetched from RAM: DCUs running with 20MHz pixel clock, QuadSPI fetching data at 80MHz, GPU accessing internal SRAM and external DRAM, DMA, RLE, and VIU active, Serial IPs CAN and LIN in loop back mode, DSPI as Master, PLL as system Clock (4 x Multiplier) peripherals on (eMIOS/ADC/SMD/SSD/SGM) and running at max frequency, periodic SW/WDG timer reset enabled.

- ⁶ Flash in Low Power. RC-osc128KHz & RC-OSC 16MHz on. 10MHz XTAL clock. FlexCAN: instances: 0, 1 ON (clocked but no reception or transmission), LINFLEX: instances 0, 1, 2 ON (clocked but no reception or transmission). eMIOS: instance: 0, 1 ON - 16 channels on with PWM20KHz. DSPI: instance: 0 (clocked but no communication). DCUs, TCON, VIU, GPU clock gated, RTC/API ON. PIT ON. STM ON. ADC ON but not converting.
- ⁷ No clock, RC 16MHz off, RCI 128KHz on, PLL off, HPVreg off, ULPVreg/LPVreg on. All possible peripherals off and clock gated. Flash in power down mode.
- ⁸ ULPreg ON, HP/LPVreg off, 64KB RAM on, device configured for minimum consumption, all possible modules switched-off.
- ⁹ ULPreg ON, HP/LPVreg off, 8KB RAM on, device configured for minimum consumption, all possible modules switched-off.

4.8 DC electrical specifications

4.8.1 DC specification for CMOS090LP2 library @ VDDE = 3.3 V

NOTE

These pad specifications are applicable for pads in the Digital segment Only. See the "GPIO power bank supplies and functionality" table in the "Voltage Regulators and Power Supplies" chapter of the reference manual for details.

Table 22. DC electrical specifications

| Symbol | C | Parameter | Condition | Value | | Unit | SpecID | |
|-----------|----|-----------|---|--------------------------|------------|------------|--------|-------|
| | | | | Min | Max | | | |
| Vdd | SR | P | Core supply voltage | — | 1.08 | 1.47 | V | D9.1 |
| Vdde | SR | P | I/O supply voltage | — | 3.0 | 3.6 | V | D9.2 |
| Vdd33 | SR | P | I/O pre-driver supply voltage | — | 3.0 | 3.6 | V | D9.3 |
| Vih_c | SR | P | CMOS input buffer high voltage | With hysteresis enabled | 0.65×Vdde | Vdde+0.3 | V | D9.4 |
| | | | | With hysteresis disabled | 0.55×Vdde | Vdde+0.3 | | |
| Vil_c | SR | P | CMOS input buffer low voltage | With hysteresis enabled | Vss-0.3 | 0.35×Vdde | V | D9.5 |
| | | | | With hysteresis disabled | Vss-0.3 | 0.40×Vdde | | |
| Vhys_c | SR | T | CMOS input buffer hysteresis | — | 0.1×Vdde | — | V | D9.6 |
| Vih_fod_h | SR | P | 5 V tolerant CMOS input buffer high voltage | With hysteresis enabled | 0.65×Vdd33 | Vdd33+0.3 | V | D9.7 |
| Vil_fod_h | SR | P | 5 V tolerant CMOS input buffer low voltage | With hysteresis enabled | Vss-0.3 | 0.35×Vdd33 | V | D9.8 |
| lact_s | SR | T | Selectable weak pullup/pulldown current | — | 25 | 150 | μA | D9.9 |
| linact_d | SR | P | Digital pad input leakage current | Weak pull inactive | -2.5 | 2.5 | μA | D9.10 |

Table 22. DC electrical specifications (continued)

| Symbol | | C | Parameter | Condition | Value | | Unit | SpecID |
|-----------|----|---|------------------------------------|--------------------|------------|-------------|------|--------|
| | | | | | Min | Max | | |
| linact_a | SR | P | Analog pad input leakage current | Weak pull inactive | -150 | 150 | nA | D9.11 |
| Voh | SR | P | Output high voltage | Refer to Table 23 | 0.8 × Vdde | — | V | D9.12 |
| Vol | SR | P | Output low voltage | Refer to Table 23 | — | 0.2 × Vdde | V | D9.13 |
| Vol_fod_h | SR | C | Fast open-drain output low voltage | lol_fod_h = 10 mA | — | 0.2 × Vdd33 | — | D9.16 |

Table 23. Drive current, VDDE=3.3 V (+/- 10%)

| Pad | C | Drive mode | Minimum Ioh (mA) ¹ | Minimum Iol (mA) ² |
|---------|---|------------|-------------------------------|-------------------------------|
| pad_fc | C | 00 | 16.1 | 24 |
| | | 01 | 31.8 | 47.9 |
| | | 10 | 47.2 | 70.6 |
| | | 11 | 77 | 114.5 |
| pad_msr | C | All | 61.9 | 83.6 |
| pad_ssr | C | All | 61.9 | 83.6 |

¹ Ioh is defined as the current sourced by the pad to drive the output to Voh.

² Iol is defined as the current sunk by the pad to drive the output to Vol.

Table 24. Supply leakage

| Pad | C | VDD | VDDE (Typ/Max) | VDD33 (Typ/Max) |
|---------|---|-------|----------------|-----------------|
| pad_fc | D | 90 μA | 3 nA / 4 μA | 1 nA / 30 μA |
| pad_msr | | — | — | — |
| pad_ssr | | — | — | — |

4.8.2 DC specification for CMOS090LP2fg library @ VDDE = 5.0 V

NOTE

These pad specifications are applicable for pads in the Analog segment Only. See the "GPIO power bank supplies and functionality" table in the "Voltage Regulators and Power Supplies" chapter of the reference manual for details.

Table 25. DC electrical specifications

| Symbol | C | Parameter | Condition | Value | | Unit | SpecID | |
|----------|----|-----------|--|--------------------------|-----------|-----------|--------|-------|
| | | | | Min | Max | | | |
| Vdd | SR | P | Core supply voltage | — | 1.08 | 1.32 | V | D9.17 |
| Vdde | SR | P | I/O supply voltage | — | 4.5 | 5.5 | V | D9.18 |
| Vdd33 | SR | P | I/O pre-driver supply voltage | — | 3.0 | 3.6 | V | D9.19 |
| Vih_hys | SR | P | CMOS input buffer high voltage | With hysteresis enabled | 0.65×Vdde | Vdde+0.3 | V | D9.20 |
| Vil_hys | SR | P | CMOS input buffer low voltage | With hysteresis enabled | Vss–0.3 | 0.35×Vdde | V | D9.21 |
| Vih | SR | P | CMOS input buffer high voltage | With hysteresis disabled | 0.55×Vdde | Vdde+0.3 | V | D9.22 |
| Vil | SR | P | CMOS input buffer low voltage | With hysteresis disabled | Vss–0.3 | 0.40×Vdde | V | D9.23 |
| Vhys | SR | T | CMOS input buffer hysteresis | — | 0.1×Vdde | — | V | D9.24 |
| Pull_loh | SR | P | Weak pullup current | — | 35 | 135 | μA | D9.25 |
| Pull_lol | SR | P | Weak pulldown current | — | 35 | 200 | μA | D9.26 |
| linact_d | SR | P | Digital pad input leakage current | Weak pull inactive | –2.5 | 2.5 | μA | D9.27 |
| linact_a | SR | P | Analog pad input leakage current | Weak pull inactive | –150 | 150 | nA | D9.28 |
| Voh | SR | P | Slew rate controlled output high voltage | — | 0.8×Vdde | — | V | D9.29 |
| Vol | SR | P | Slew rate controlled output low voltage | — | — | 0.2×Vdde | V | D9.30 |
| Voh_ls | SR | C | Low swing output pad output high voltage | — | 2.64 | — | V | D9.31 |
| loh_msr | SR | C | pad_msr_hv loh | — | 11.6 | 40.7 | mA | D9.32 |
| lol_msr | SR | C | pad_msr_hv lol | — | 17.7 | 68.2 | mA | D9.33 |
| loh_ssr | SR | C | pad_ssr_hv loh | — | 6.0 | 21.3 | mA | D9.34 |
| lol_ssr | SR | C | pad_ssr_hv lol | — | 9.2 | 36.3 | mA | D9.35 |
| Rtgate | SR | D | Pad_tgate_hv input resistance | — | 250 | 800 | Ω | D9.39 |

Table 26. DC electrical specifications

| Symbol | | Parameter | Condition | Value | | Unit | SpecID |
|----------|----|--|--------------------------|-----------|-----------|------|--------|
| | | | | Min | Max | | |
| Vdd | SR | Core supply voltage | — | 1.08 | 1.32 | V | D9.45 |
| Vdde | SR | I/O supply voltage | — | 3.0 | 3.6 | V | D9.46 |
| Vdd33 | SR | I/O pre-driver supply voltage | — | 3.0 | 3.6 | V | D9.47 |
| Vih_hys | SR | CMOS input buffer high voltage | With hysteresis enabled | 0.65×Vdde | Vdde+0.3 | V | D9.48 |
| Vil_hys | SR | CMOS input buffer low voltage | With hysteresis enabled | Vss–0.3 | 0.35×Vdde | V | D9.49 |
| Vih | SR | CMOS input buffer high voltage | With hysteresis disabled | 0.55×Vdde | Vdde+0.3 | V | D9.50 |
| Vil | SR | CMOS input buffer low voltage | With hysteresis disabled | Vss–0.3 | 0.40×Vdde | V | D9.51 |
| Vhys | SR | CMOS input buffer hysteresis | — | 0.1×Vdde | — | V | D9.52 |
| Pull_loh | SR | Weak pullup current | — | 15 | 70 | μA | D9.53 |
| Pull_lol | SR | Weak pulldown current | — | 15 | 95 | μA | D9.54 |
| Iinact_d | SR | Digital pad input leakage current | Weak pull inactive | –2.5 | 2.5 | μA | D9.55 |
| Iinact_a | SR | Analog pad input leakage current | Weak pull inactive | –150 | 150 | nA | D9.56 |
| Voh | SR | Slew rate controlled output high voltage | — | 0.8×Vdde | — | V | D9.57 |
| Vol | SR | Slew rate controlled output low voltage | — | — | 0.2×Vdde | V | D9.58 |
| Ioh_msr | SR | pad_msr_hv Ioh | — | 5.4 | 21 | mA | D9.59 |
| Iol_msr | SR | pad_msr_hv Iol | — | 8.1 | 38.6 | mA | D9.60 |
| Ioh_ssr | SR | pad_ssr_hv Ioh | — | 2.8 | 11.2 | mA | D9.61 |
| Iol_ssr | SR | pad_ssr_hv Iol | — | 4.2 | 20.6 | mA | D9.62 |
| Rtgate | SR | Pad_tgate_hv input resistance | — | 325 | 1250 | Ω | D9.65 |

Table 27. Supply leakage

| Pad | VDD | | VDDE | | VDD33 | |
|------------|----------|---------|----------|---------|-------|-----|
| | Typ | Max | Typ | Max | Typ | Max |
| pad_msr_hv | 0.818 nA | 83.7 nA | 0.81 nA | 118 nA | — | — |
| pad_ssr_hv | 0.818 nA | 83.7 nA | 0.858 nA | 88.7 nA | — | — |
| pad_i_hv | 0.307 nA | 48.4 nA | 88.2 pA | 30 nA | — | — |
| biasref_hv | — | — | — | — | — | — |

Table 27. Supply leakage (continued)

| Pad | VDD | | VDDE | | VDD33 | |
|---------------------------|-----|-----|------|-----|-------|-----|
| | Typ | Max | Typ | Max | Typ | Max |
| core_v_det_hv | 0 | 0 | — | — | 0 | 0 |
| core_v_det_lp_hv | 0 | 0 | — | — | — | — |
| corner_esdpadcell_hv | — | — | — | — | — | — |
| corner_esdpadcell_id00_hv | — | — | — | — | — | — |
| corner_esdpadcell_id11_hv | — | — | — | — | — | — |
| corner_esdpadcell_lp_hv | — | — | — | — | — | — |
| esd_term_35_84_hv | — | — | — | — | — | — |
| pad_9v_hv | 0 | 0 | — | — | — | — |
| pad_ae_hv | — | — | — | — | — | — |
| pad_esdspacer_hv | — | — | — | — | — | — |
| pad_tgate_hv | — | — | — | — | — | — |
| pad_vdd33_hv | — | — | — | — | — | — |
| pad_vdde_hv | 0 | 0 | — | — | 0 | 0 |
| pad_vddint3v_hv | 0 | 0 | — | — | 0 | 0 |
| pad_vddint_hv | 0 | 0 | — | — | — | — |
| pad_vss_hv | 0 | 0 | — | — | — | — |
| pad_vsse_hv | 0 | 0 | — | — | — | — |
| pad_vssint3v_hv | 0 | 0 | — | — | — | — |
| pad_vssint_hv | 0 | 0 | — | — | — | — |
| spr_17_82_hv | — | — | — | — | — | — |
| spr_35_84_hv | — | — | — | — | — | — |
| spr_71_88_hv | — | — | — | — | — | — |
| spr_143_38_hv | — | — | — | — | — | — |
| spr_vdde_lvl_hv | — | — | — | — | — | — |

Table 28. AVG IDDE specifications

| Cell | Period (ns) | Load (pF) ¹ | VDDE (V) | Drive/slew select | IDDE (mA) |
|-------------------------|-------------|------------------------|----------|-------------------|-----------|
| pad_msr_hv ² | 24 | 50 | 5.5 | 11 | 14 |
| | 62 | 50 | 5.5 | 01 | 5.3 |
| | 317 | 50 | 5.5 | 00 | 1.1 |
| | 425 | 200 | 5.5 | 00 | 3 |

Table 28. AVG IDDE specifications

| Cell | Period (ns) | Load (pF) ¹ | VDDE (V) | Drive/slew select | IDDE (mA) |
|-------------------------|-------------|------------------------|----------|-------------------|-----------|
| pad_ssr_hv ² | 37 | 50 | 5.5 | 11 | 9 |
| | 130 | 50 | 5.5 | 01 | 2.5 |
| | 650 | 50 | 5.5 | 00 | 0.5 |
| | 840 | 200 | 5.5 | 00 | 1.5 |

¹ All loads are lumped loads.

² Average current is for pad configured as output only. Use pad_i current for input.

4.8.3 DC specification for CMOS090_dds library @ VDDE = 3.3 V

Table 29. DC electrical specifications at 3.3 V VDDE

| Symbol | | Parameter | Value | | Unit | SpecID |
|--------|----|-------------------------------|-----------|-----------|------|--------|
| | | | Min | Max | | |
| Vdd | SR | Core supply voltage | 1.08 | 1.47 | V | D9.71 |
| Vdde | SR | I/O supply voltage | 3.0 | 3.6 | V | D9.72 |
| Vdd33 | SR | I/O pre-driver supply voltage | 3.0 | 3.6 | V | D9.73 |
| Vref | SR | Input reference voltage | 1.3 | 1.7 | V | D9.74 |
| Vtt | SR | Termination voltage | Vref-0.05 | Vref+0.05 | V | D9.75 |
| Vih | SR | Input high voltage | Vref+0.20 | — | V | D9.76 |
| Vil | SR | Input low voltage | — | Vref-0.2 | V | D9.77 |
| Voh | SR | Output high voltage | Vtt+0.8 | — | V | D9.78 |
| Vol | SR | Output low voltage | — | Vtt-0.8 | V | D9.79 |

Table 30. Output drive current @ VDDE = 3.3 V (+/-10%)

| Pad | C | Drive mode | Minimum loh (mA) | Minimum lol (mA) |
|------------|---|------------|------------------|------------------|
| pad_st_acc | D | 111 | -16 | 16 |
| pad_st_dq | D | 111 | -16 | 16 |
| pad_st_clk | D | 111 | -16 | 16 |
| pad_st | D | 111 | -16 | 16 |
| pad_st_odt | D | 111 | -16 | 16 |
| pad_st_ck | D | 111 | -16 | 16 |

4.8.4 DC specification for CMOS090_dds library @ VDDE = 2.5 V

Table 31. DC electrical specifications at 2.5 V VDDE

| Symbol | C | Parameter | Value | | Unit | SpecID | |
|--------|----|-----------|-------------------------------|-----------|-----------|--------|-------|
| | | | Min | Max | | | |
| Vdd | SR | P | Core supply voltage | 1.08 | 1.47 | V | D9.80 |
| Vdde | SR | P | I/O supply voltage | 2.3 | 2.7 | V | D9.81 |
| Vdd33 | SR | P | I/O pre-driver supply voltage | 3.0 | 3.6 | V | D9.82 |
| Vref | SR | P | Input reference voltage | 0.49×Vdde | 0.51×Vdde | V | D9.83 |
| Vtt | SR | P | Termination voltage | Vref-0.04 | Vref+0.04 | V | D9.84 |
| Vih | SR | P | Input high voltage | Vref+0.15 | — | V | D9.85 |
| Vil | SR | P | Input low voltage | — | Vref-0.15 | V | D9.86 |
| Voh | SR | P | Output high voltage | Vtt+0.81 | — | V | D9.87 |
| Vol | SR | P | Output low voltage | — | Vtt-0.81 | V | D9.88 |

Table 32. Output drive current @ VDDE = 2.5 V (+/-200mV)

| Pad | C | Drive mode | Minimum loh (mA) | Minimum lol (mA) | Libraries |
|------------|---|------------|------------------|------------------|-----------|
| pad_st_acc | D | 011 | -16.2 | 16.2 | 6MDDR |
| pad_st_dq | D | 011 | -16.2 | 16.2 | 6MDDR |
| pad_st_ck | D | 011 | -16.2 | 16.2 | 6MDDR |

4.8.5 DC specification for CMOS090_ ddr library @ VDDE = 1.8 V

Table 33. DC electrical specifications for 1.8 V VDDE

| Symbol | C | Parameter | Value | | Unit | SpecID | |
|--------|----|-----------|-------------------------------|------------|------------|--------|-------|
| | | | Min | Max | | | |
| Vdd | SR | P | Core supply voltage | 1.08 | 1.47 | V | D9.89 |
| Vdde | SR | P | I/O supply voltage | 1.7 | 1.9 | V | D9.90 |
| Vdd33 | SR | P | I/O pre-driver supply voltage | 3.0 | 3.6 | V | D9.91 |
| Vref | SR | P | Input reference voltage | 0.49×Vdde | 0.51×Vdde | V | D9.92 |
| Vtt | SR | P | Termination voltage | Vref-0.04 | Vref+0.04 | V | D9.93 |
| Vih | SR | P | Input high voltage | Vref+0.125 | — | V | D9.94 |
| Vil | SR | P | Input low voltage | — | Vref-0.125 | V | D9.95 |
| Voh | SR | P | Output high voltage | Vtt+0.81 | — | V | D9.96 |
| Vol | SR | P | Output low voltage | — | Vtt-0.81 | V | D9.97 |

Table 34. Output drive current @ VDDE = 1.8 V (+/-100mV)

| Pad | | Drive mode | Minimum Ioh (mA) | Minimum Iol (mA) | Libraries |
|------------|---|------------|------------------|------------------|-----------|
| pad_st_acc | D | 000 | -3.57 | 3.57 | 6MDDR |
| | | 001 | -7.84 | 7.84 | |
| | | 010 | -5.36 | 5.36 | |
| | | 110 | -13.4 | 13.4 | |
| pad_st_dq | D | 000 | -3.57 | 3.57 | 6MDDR |
| | | 001 | -7.84 | 7.84 | |
| | | 010 | -5.36 | 5.36 | |
| | | 110 | -13.4 | 13.4 | |
| pad_st_clk | D | 000 | -3.57 | 3.57 | 6MDDR |
| | | 001 | -7.84 | 7.84 | |
| | | 010 | -5.36 | 5.36 | |
| | | 110 | -13.4 | 13.4 | |

Table 35. ODT DC electrical characteristics

| Symbol | | C | Parameter | Condition | Value | | | Unit | SpecID |
|--------|----|---|---------------------------|--|-------|-----|-----|------|--------|
| | | | | | Min | Typ | Max | | |
| Rtt | SR | C | Effective impedance value | Rainbow supports only 150 ohm termination and that can be enabled by enabling any bit of the termination control register (all of them are OR'ed). | 120 | 150 | 180 | Ω | D9.98 |

Table 36. core_v_det_odt and core_v_det33_odt specifications

| VDDE | C | VDD | Vtrip max (V) | Vtrip min | Hysteresis min (V) |
|--------|---|---------|---------------|-----------|--------------------|
| 3.5 | C | Rising | 0.79 | 0.44 | 0.07 |
| | C | Falling | 0.56 | 0 | |
| 1.62 | C | Rising | 0.65 | 0.3 | 0.16 |
| | C | Falling | 0.33 | 0 | |
| Rising | C | 0.0 | 1.40 | 0.3 | — |

4.9 $\overline{\text{RESET}}$ electrical characteristics

The device implements a dedicated bidirectional RESET pin.

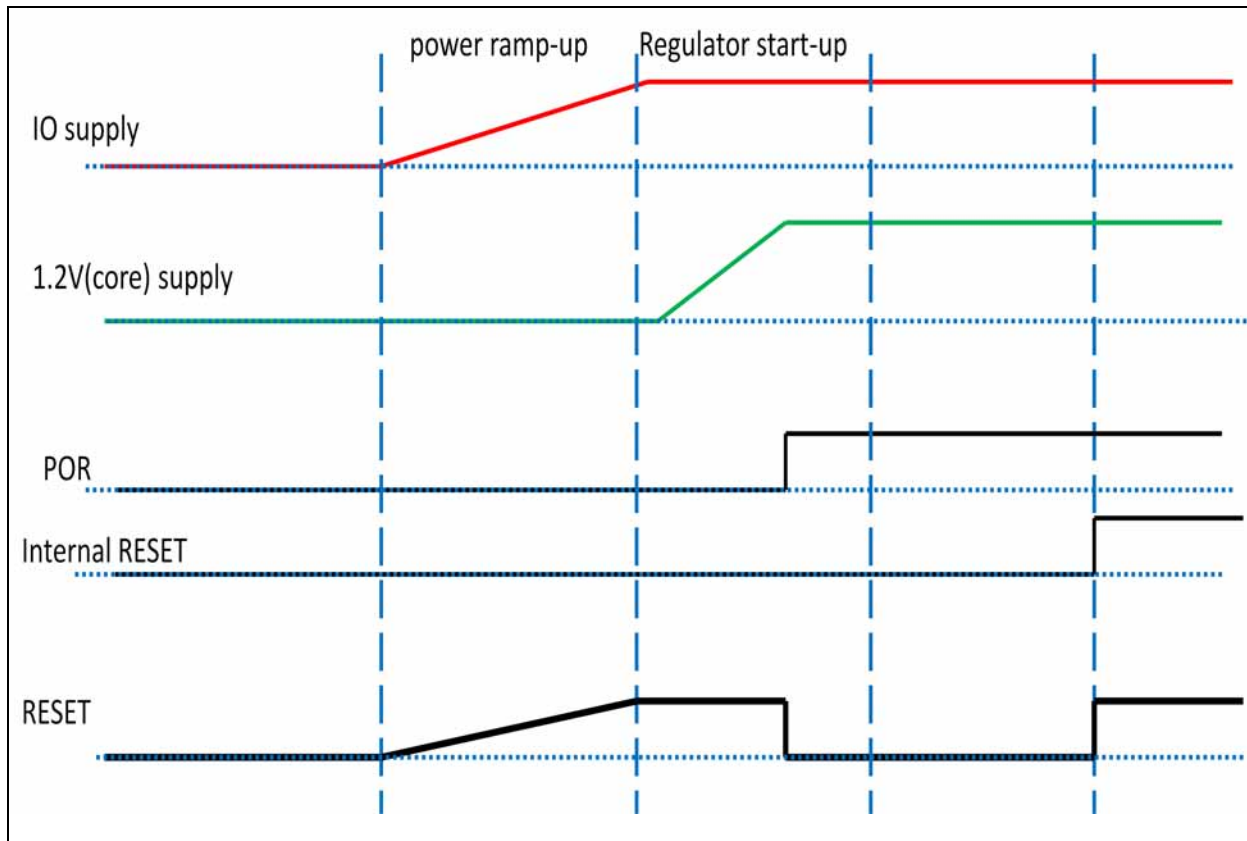


Figure 7. Startp reset requirements

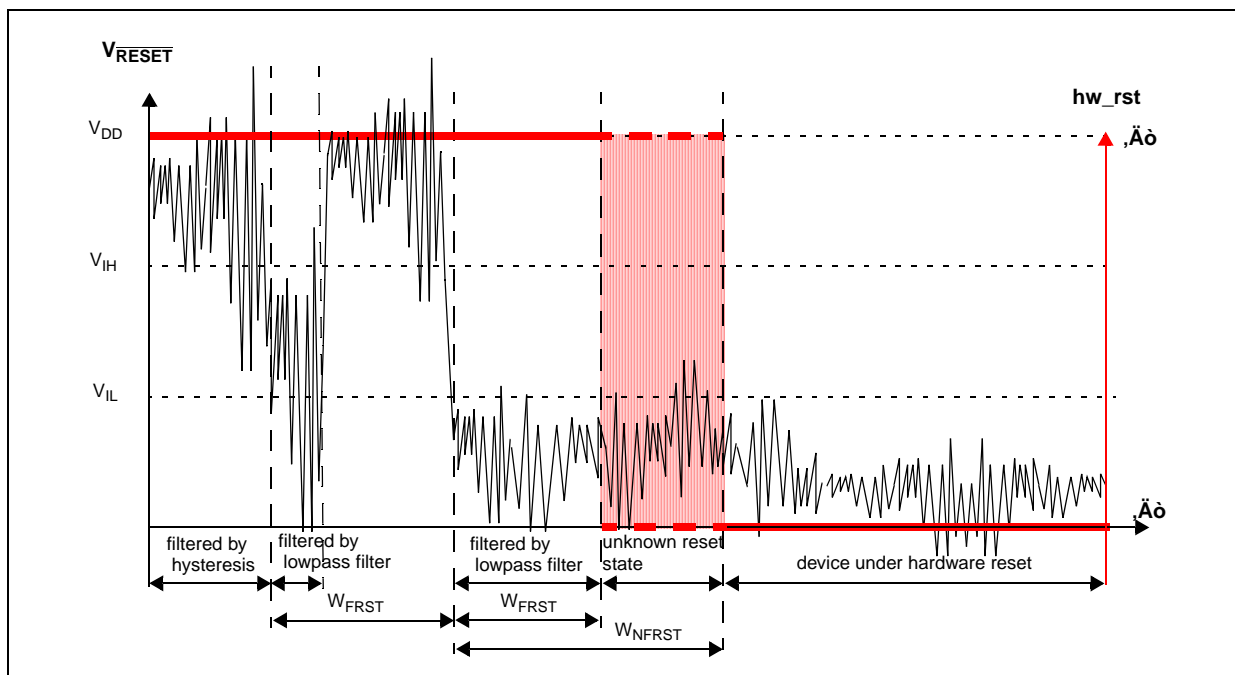


Figure 8. Noise filtering on reset signal

Table 37. Reset electrical characteristics

| Symbol | | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID |
|--------------------|-----------------|---|---|---|---------------------|-----|----------------------|------|--------|
| | | | | | Min | Typ | Max | | |
| V _{IH} | SR | P | Input High Level CMOS Schmitt Trigger | — | 0.65V _{DD} | — | V _{DD} +0.4 | V | D8.1 |
| V _{IL} | SR | P | Input low Level CMOS Schmitt Trigger | — | -0.4 | — | 0.35V _{DD} | V | D8.2 |
| V _{HYS} | CC ³ | D | Input hysteresis CMOS Schmitt Trigger | — | 0.1V _{DD} | — | — | V | D8.3 |
| V _{OL} | CC ⁴ | P | Output low level | Push Pull, I _{OL} = 2mA, V _{DD} = 5.0V ± 10%, ipp_hve = 0 (recommended) | — | — | 0.1V _{DD} | V | D8.4 |
| | | D | | Push Pull, I _{OL} = 1mA, V _{DD} = 5.0V ± 10%, ipp_hve = 1 ⁵ | — | — | 0.1V _{DD} | | |
| | | C | | Push Pull, I _{OL} = 1mA, V _{DD} = 3.3V ± 10%, ipp_hve = 1 (recommended) | — | — | 0.5 | | |
| T _{tr} | CC ⁴ | T | Output transition time output pin ⁶ MEDIUM configuration | C _L = 25pF, V _{DD} = 5.0V ± 10%, ipp_hve = 0 | — | — | 10 | ns | D8.5 |
| | | | | C _L = 50pF, V _{DD} = 5.0V ± 10%, ipp_hve = 0 | — | — | 20 | | |
| | | | | C _L = 100pF, V _{DD} = 5.0V ± 10%, ipp_hve = 0 | — | — | 40 | | |
| | | | | C _L = 25pF, V _{DD} = 3.3V ± 10%, ipp_hve = 1 | — | — | 12 | | |
| | | | | C _L = 50pF, V _{DD} = 3.3V ± 10%, ipp_hve = 1 | — | — | 25 | | |
| | | | | C _L = 100pF, V _{DD} = 3.3V ± 10%, ipp_hve = 1 | — | — | 40 | | |
| W _{FRST} | SR | T | $\overline{\text{RESET}}$ Input Filtered Pulse | — | — | — | 70 | ns | D8.6 |
| W _{NFRST} | SR | T | $\overline{\text{RESET}}$ Input Not Filtered Pulse | — | 400 | — | — | ns | D8.7 |
| I _{WPUL} | CC ⁴ | T | Weak pull-up current absolute value | — | 10 | — | — | μA | D8.8 |

¹ V_{DD} = 3.3V ± 10% / 5.0V ± 10%, T_A = -40 / +105°C, unless otherwise specified.

² All values need to be confirmed during device validation.

³ Data based on characterization results, not tested in production.

- ⁴ Guaranteed by design simulation.
- ⁵ This is a transient configuration during power-up, up to the end of reset PHASE2 (refer to RGM module section of the reference manual).
- ⁶ C_L calculation should include device and package capacitance ($C_{PKG} < 5\text{pF}$).

4.10 Fast external crystal oscillator (4–16 MHz) electrical characteristics

This device implements the fast external oscillator (FXOSC) using a low power Loop Controlled Pierce Oscillator (LCP) configuration.

Table 38. Fast external crystal oscillator electrical characteristics

| Symbol | Parameter | Conditions | Value | | | Unit | SpecID | |
|-----------------|-----------|---|------------------------|-------------------------|----------------|-------------------------|---------------|-------|
| | | | Min | Typ | Max | | | |
| f_{OSC} | C | Crystal oscillator range | Loop controlled Pierce | 4.0 | — | 16 | MHz | O9.1 |
| i_{OSC} | D | Startup current | — | 100 | — | — | μA | O9.2 |
| t_{UPOSC} | C | Oscillator start-up time | Loop controlled Pierce | — | 4 ¹ | 50 ² | ms | O9.3 |
| t_{CQOUT} | D | Clock quality check time-out | — | 0.45 | — | 2.5 | s | O9.4 |
| f_{CMFA} | D | Clock monitor failure assert frequency | — | 200 | 400 | 800 | kHz | O9.5 |
| f_{EXT} | D | External square wave input frequency ² | — | 2.0 | — | 50 | MHz | O9.6 |
| t_{EXTL} | D | External square wave pulse width low | — | 9.5 | — | — | ns | O9.7 |
| t_{EXTH} | D | External square wave pulse width high | — | 9.5 | — | — | ns | O9.8 |
| t_{EXTR} | D | External square wave rise time | — | — | — | 1 | ns | O9.9 |
| t_{EXTF} | D | External square wave fall time | — | — | — | 1 | ns | O9.10 |
| C_{IN} | D | Input capacitance | EXTAL and XTAL pins | — | 7 | — | pF | O9.11 |
| $V_{IH,EXTAL}$ | P | EXTAL pin input high voltage ² | — | $0.75 \times V_{DDPLL}$ | — | — | V | O9.12 |
| | T | | | — | — | $V_{DDPLL} + 0.3$ | | |
| $V_{IL,EXTAL}$ | P | EXTAL pin input low voltage ² | — | — | — | $0.25 \times V_{DDPLL}$ | V | O9.13 |
| | T | | | $V_{SSPLL} - 0.3$ | — | — | | |
| $V_{HYS,EXTAL}$ | C | EXTAL pin input hysteresis ² | — | — | 180 | — | mV | O9.14 |
| $V_{PP,EXTAL}$ | C | EXTAL pin oscillation amplitude | Loop controlled Pierce | — | 1.0 | — | V | O9.15 |

¹ $f_{OSC} = 4\text{ MHz}$, $C = 22\text{ pF}$.

² Maximum value is for extreme cases using high Q, low frequency crystals.

4.11 Slow external crystal oscillator (32 KHz) electrical characteristics

The device provides a slow external oscillator/resonator driver (SXOSC).

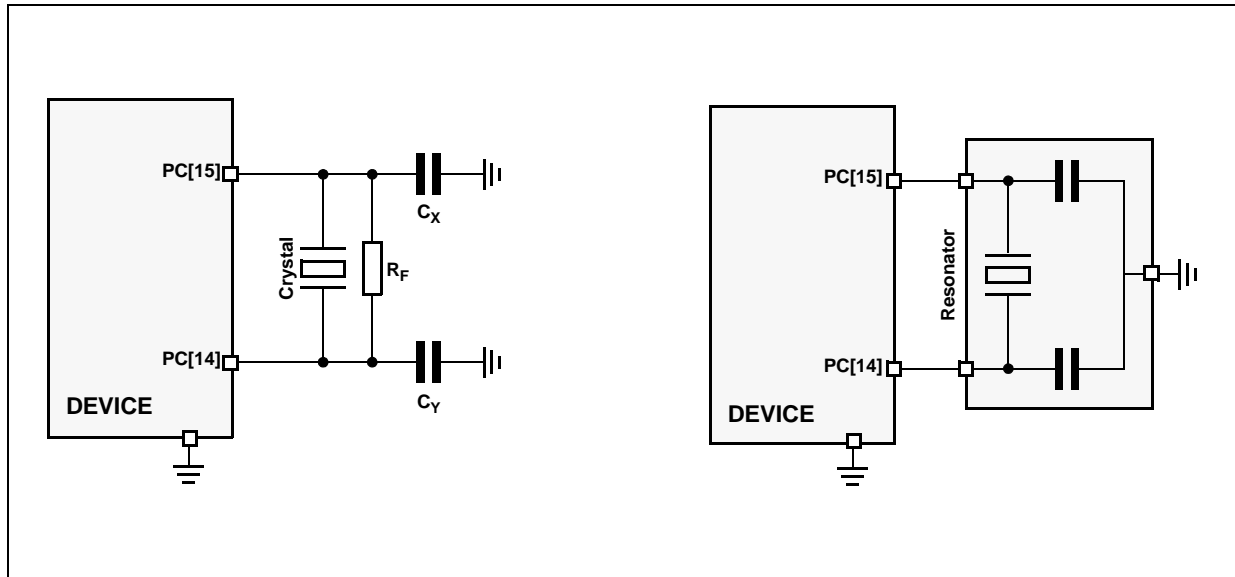


Figure 9. Crystal oscillator and resonator connection scheme

NOTE

PC[14]/PC[15] must not be directly used to drive external circuits.

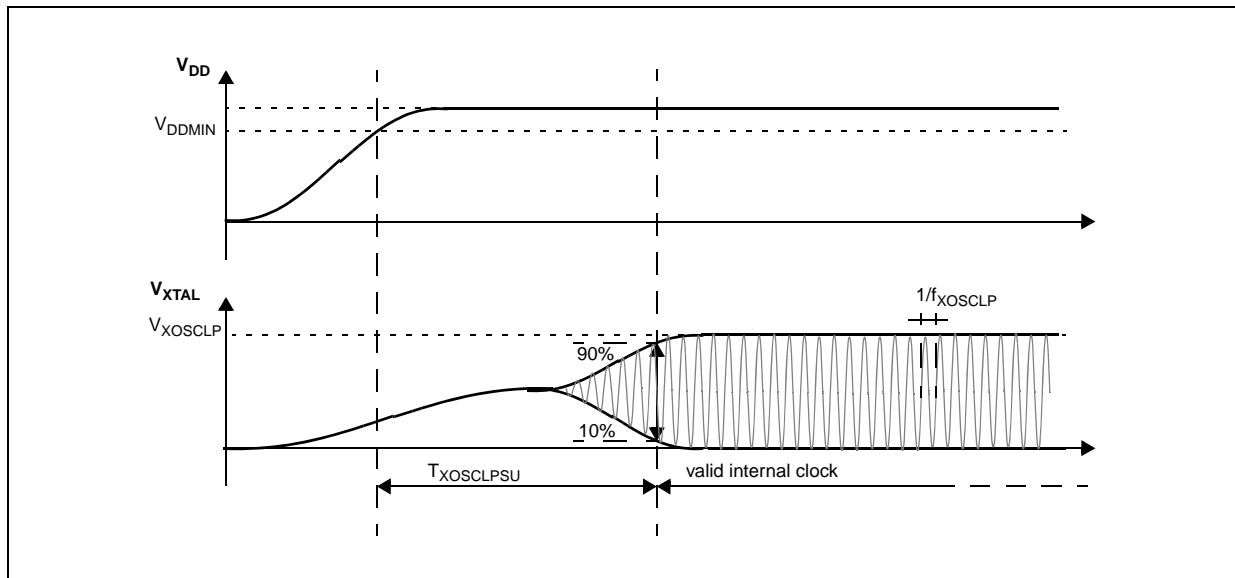


Figure 10. Slow external crystal oscillator electrical characteristics

Table 39. Slow external crystal oscillator electrical characteristics

| Symbol | | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID |
|----------------------------|-----------------|---|---------------------------------------|---|--|------|--|------|--------|
| | | | | | Min | Typ | Max | | |
| f _{XOSCLP} | SR | C | Oscillator frequency | — | 32 | — | 40 | kHz | O10.1 |
| V _{XOSCLP} | CC ³ | C | Oscillation amplitude | V _{DDA} =3.3V±10%, V _{DDE_A} =3.3V±10% | 1.12 | 1.33 | 1.74 | V | O10.2 |
| | | | | V _{DDA} =5.0V±10%, V _{DDE_A} =5.0V±10% | 1.12 | 1.37 | 1.74 | | |
| I _{XOSCLP} | CC ³ | D | Oscillator consumption | — | — | — | 5 | µA | O10.3 |
| T _{XOSCLPS U} | CC ³ | D | Oscillator start-up time | — | — | — | 2 | s | O10.4 |
| V _{IH} | SR | C | Input high level CMOS Schmitt Trigger | Oscillator bypass mode | 0.65V _{DDA} 0.65V _{DDE_A} | — | V _{DDA} +0.4 V _{DDE_A} +0.4 | V | O10.5 |
| V _{IL} | SR | C | Input low level CMOS Schmitt Trigger | Oscillator bypass mode | V _{SS} -0.4 | — | 0.35V _{DDA} 0.35V _{DDE_A} | V | O10.6 |

¹ V_{DD} = 3.3 V ± 10% / 5.0 V ± 10%, T_A = -40 to +105 °C, unless otherwise specified.

² All values need to be confirmed during device validation.

³ Granted by device validation.

4.12 FMPLL electrical characteristics

The device provides a frequency-modulated phase-locked loop (FMPLL) module to generate a fast system clock from the fast external oscillator driver.

Table 40. FMPLL electrical characteristics

| Symbol | | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID |
|---------------------|-----------------|---|---|--|--------------------|-----|------------------|------|--------|
| | | | | | Min | Typ | Max | | |
| f _{PLLIN} | SR | T | PLL reference clock ³ | — | 4 | — | 120 | MHz | O11.1 |
| Δ _{PLLIN} | SR | T | PLL reference clock duty cycle ³ | — | 47.5 | — | 52.5 | % | O11.2 |
| f _{PLLOUT} | CC ⁴ | T | PLL output clock frequency | — | 15 | — | 250 ⁵ | MHz | O11.3 |
| f _{CPU} | CC ⁴ | T | System clock frequency | — | — | — | 125 ⁶ | MHz | O11.4 |
| T _{LOCK} | CC ⁴ | T | PLL lock time | Stable oscillator (f _{PLLIN} = 10 MHz) | — | — | 100 | µs | O11.5 |
| ΔT _{PKJIT} | CC ⁴ | T | PLL jitter | f _{PLLOUT} (PHI i.e. FMPLL O/P) = 15.625 MHz @ 10 MHz resonator | -509 | — | 509 | ps | O11.6 |
| ΔT _{LTJIT} | CC ⁴ | T | PLL long term jitter | f _{PLLIN} = 10 MHz (resonator) | -2.4 | — | 2.4 | ns | O11.7 |
| I _{PLL} | CC ⁷ | D | Current Consumption (Normal Mode for Analog Supply) | T _A = 25°C | — | — | 500 | µA | O11.8 |

¹ V_{DDPLL} = 1.2 V ± 10%, T_A = -40 to +105 °C, unless otherwise specified.

² All values need to be confirmed during device validation.

³ PLLIN clock retrieved directly from XOSCHS clock. Input characteristics are granted when oscillator is used in functional mode. When bypass mode is used, oscillator input clock should verify f_{PLLIN} and Δ_{PLLIN}.

- 4 Data based on device simulation.
 5 2x sys clock required for generation of DDR timing.
 6 f_{CPU} of 125 MHz can be achieved only at temperatures up to 105 °C with a maximum FM depth of 2%.
 7 Data based on characterization results, not tested in production

4.13 Fast internal RC oscillator (16 MHz) electrical characteristics

The device provides a fast internal RC oscillator (FIRC). This is used as the default clock at the power-up of the device.

Table 41. Fast internal oscillator electrical characteristics

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID |
|-------------------|-----------------|--|--------------------------------|--------------------|-----|-----|------|--------|
| | | | | Min | Typ | Max | | |
| f_{RCM} | CC ³ | P RC oscillator high frequency | $T_A = 25\text{ °C}$, trimmed | — | 16 | — | MHz | O12.1 |
| I_{RCMRUN} | CC ³ | D RC oscillator high frequency current in running mode | $T_A = 25\text{ °C}$, trimmed | — | — | 200 | μA | O12.2 |
| I_{RCMPWD} | CC ³ | D RC oscillator high frequency current in power down mode | $T_A = 25\text{ °C}$ | — | — | 10 | μA | O12.3 |
| Δ_{RCMVAR} | CC ⁴ | C RC oscillator variation in temperature and supply with respect to f_{RC} at $T_A = 55\text{ °C}$ in high-frequency configuration | — | -5 | — | +5 | % | O12.5 |

¹ $V_{DD} = 3.3\text{ V} \pm 10\% / 5.0\text{ V} \pm 10\%$, $T_A = -40$ to $+105\text{ °C}$, unless otherwise specified.

² All values need to be confirmed during device validation.

³ Guaranteed by device simulation, not tested in production.

⁴ Guaranteed by device characterization, not tested in production.

4.14 Slow internal RC oscillator (128 kHz) electrical characteristics

The device provides a slow internal RC oscillator (SIRC). This can be used as the reference clock for the RTC module.

Table 42. Slow internal RC oscillator electrical characteristics

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID |
|--------------------------------|-----------------|--|--------------------------------|--------------------|-----|-----|------|--------|
| | | | | Min | Typ | Max | | |
| f_{RCL} | CC ³ | P RC oscillator low frequency | $T_A = 25\text{ °C}$, trimmed | — | 128 | — | kHz | O13.1 |
| I_{RCL} | CC ³ | D RC oscillator low frequency current | $T_A = 25\text{ °C}$, trimmed | — | — | 5 | μA | O13.2 |
| Δ_{RCLVAR} ₃ | CC ³ | C RC oscillator variation in temperature and supply with respect to f_{RC} at $T_A = 55\text{ °C}$ in high frequency configuration | High frequency configuration | -10 | — | +10 | % | O13.4 |

¹ $V_{DD} = 3.3\text{ V} \pm 10\% / 5.0\text{ V} \pm 10\%$, $T_A = -40$ to $+105\text{ °C}$, unless otherwise specified.

² All values need to be confirmed during device validation.

³ Guaranteed by device simulation, not tested in production

4.15 Flash memory electrical characteristics

Table 43. Program and erase specifications

| Symbol | C | Parameter | Min Value | Typical Value ¹ | Initial Max ² | Max ³ | Unit | SpecID |
|--------------------------|---|---|-----------|----------------------------|--------------------------|------------------|------|--------|
| T _{dwprogram} | C | Double Word (64 bits) Program Time ⁴ | — | — | 22 | 500 | μs | D14.1 |
| T _{16kpperase} | C | 16 KB Block Pre-program and Erase Time | — | — | 500 | 5000 | ms | D14.2 |
| T _{32kpperase} | C | 32 KB Block Pre-program and Erase Time | — | — | 600 | 5000 | ms | D14.3 |
| T _{128kpperase} | C | 128 KB Block Pre-program and Erase Time | — | — | 1300 | 7500 | ms | D14.4 |

¹ Typical program and erase times assume nominal supply values and operation at 25 °C. All times are subject to change pending device characterization.

² Initial factory condition: < 100 program/erase cycles, 25 °C, typical supply voltage.

³ The maximum program & erase times occur after the specified number of program/erase cycles. These maximum values are characterized but not guaranteed.

⁴ Actual hardware programming times. This does not include software overhead.

Table 44. Flash module life

| Symbol | C | Parameter | Conditions | Value | | Unit | SpecID |
|----------------|---|--|---|---------|---------|------------|--------|
| | | | | Min | Typ | | |
| P/E | C | Number of program/erase cycles per block for 16 KB, 48KB and 64KB blocks, across full operating temperature range (Tj) | — | 100,000 | — | P/E cycles | D14.5 |
| P/E | C | Number of program/erase cycles per block for 128KB and 256KB blocks, across full operating temperature range (Tj) | — | 1,000 | 100,000 | P/E cycles | D14.6 |
| Data retention | C | Minimum data retention at 85 °C average ambient temperature ¹ | Blocks with 0 - 1,000 P/E cycles | 20 | — | Years | D14.8 |
| | | | Blocks with 1,001 - 10,000 P/E cycles | 10 | — | Years | |
| | | | Blocks with 10,001 - 100,000 P/E cycles | 5 | — | Years | |

¹ Ambient temperature averaged over duration of application, not to exceed recommended product operating temperature range.

4.16 ADC parameters

The device provides a 10-bit Successive Approximation Register (SAR) Analog to Digital Converter.

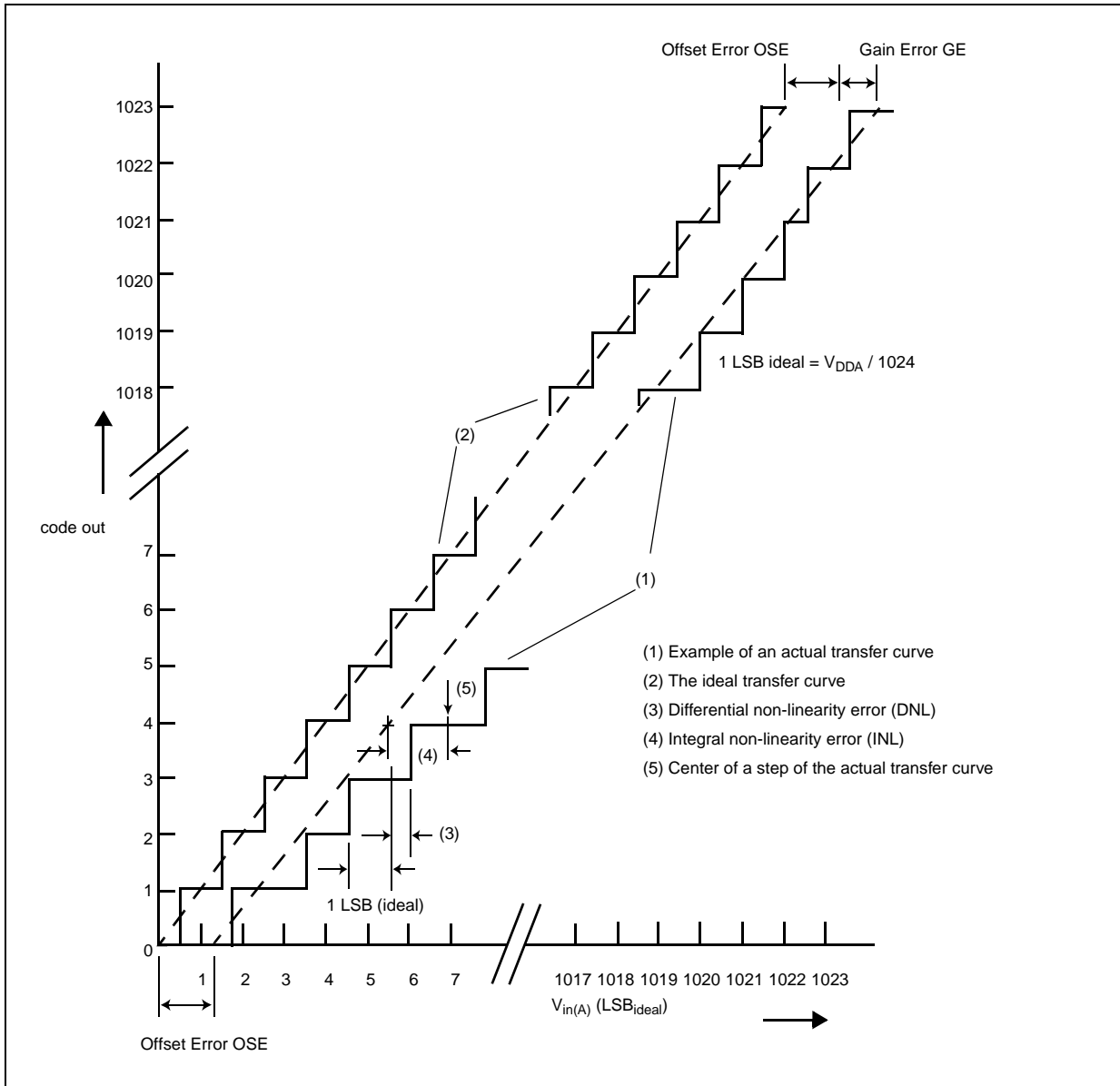


Figure 11. ADC Characteristics and Error Definitions

4.16.1 Input Impedance and ADC Accuracy

In the following analysis, the input circuit corresponding to the precise channels is considered.

To preserve the accuracy of the A/D converter, it is necessary that analog input pins have low AC impedance. Placing a capacitor with good high frequency characteristics at the input pin of the device can be effective: the capacitor should be as large as possible, ideally infinite. This capacitor contributes to attenuating the noise present on the input pin; furthermore, it sources charge during the sampling phase, when the analog signal source is a high-impedance source.

A real filter can typically be obtained by using a series resistance with a capacitor on the input pin (simple RC filter). The RC filtering may be limited according to the value of source impedance of the transducer or circuit supplying the analog signal to be measured. The filter at the input pins must be designed taking into account the dynamic characteristics of the input signal (bandwidth) and the equivalent input impedance of the ADC itself.

In fact a current sink contributor is represented by the charge sharing effects with the sampling capacitance: C_S being substantially a switched capacitance, with a frequency equal to the conversion rate of the ADC, it can be seen as a resistive path to ground. For instance, assuming a conversion rate of 1 MHz, with C_S equal to 3 pF, a resistance of 330k Ω is obtained ($R_{EQ} = 1 / (f_c * C_S)$), where f_c represents the conversion rate at the considered channel). To minimize the error induced by the voltage partitioning between this resistance (sampled voltage on C_S) and the sum of $R_S + R_F + R_L + R_{SW} + R_{AD}$, the external circuit must be designed to respect the [Equation 5](#):

Eqn. 5

$$V_A \cdot \frac{R_S + R_F + R_L + R_{SW} + R_{AD}}{R_{EQ}} < \frac{1}{2} \text{LSB}$$

[Equation 5](#) generates a constraint for external network design, in particular on resistive path. Internal switch resistances (R_{SW} and R_{AD}) can be neglected with respect to external resistances.

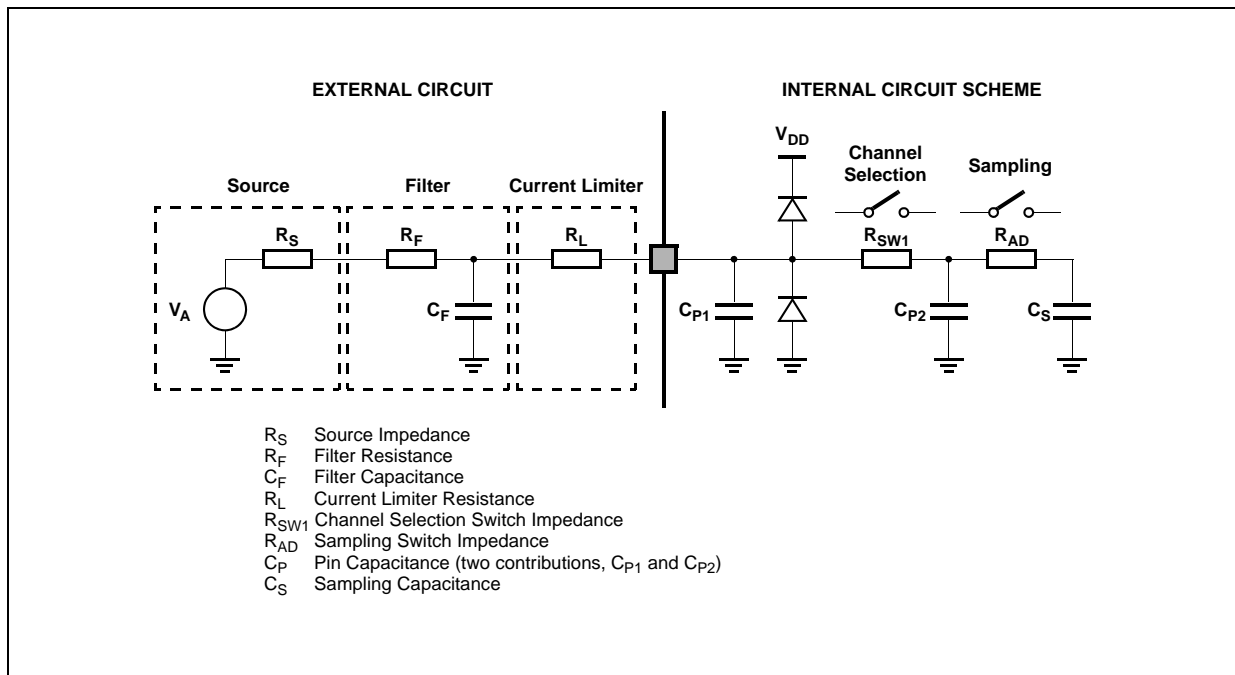


Figure 12. Input Equivalent Circuit (Precise Channels)

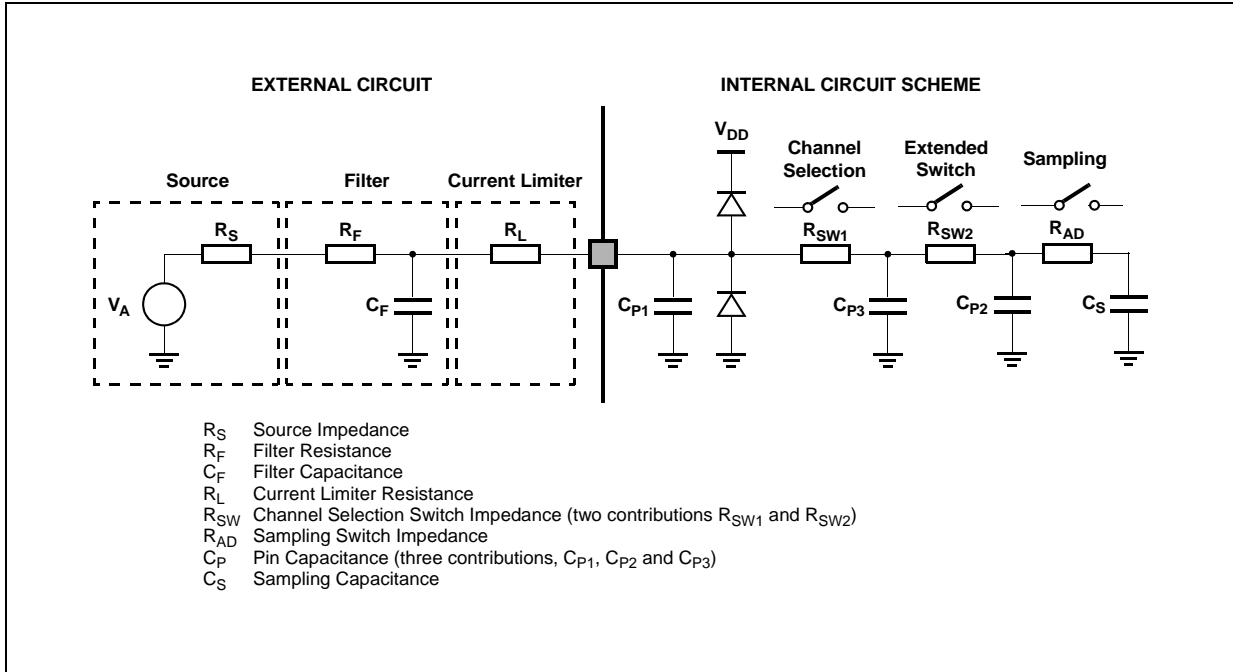


Figure 13. Input Equivalent Circuit (Extended Channels)

A second aspect involving the capacitance network shall be considered. Assuming the three capacitances C_F , C_{P1} and C_{P2} are initially charged at the source voltage V_A (refer to the equivalent circuit reported in Figure 12): A charge sharing phenomenon is installed when the sampling phase is started (A/D switch close).

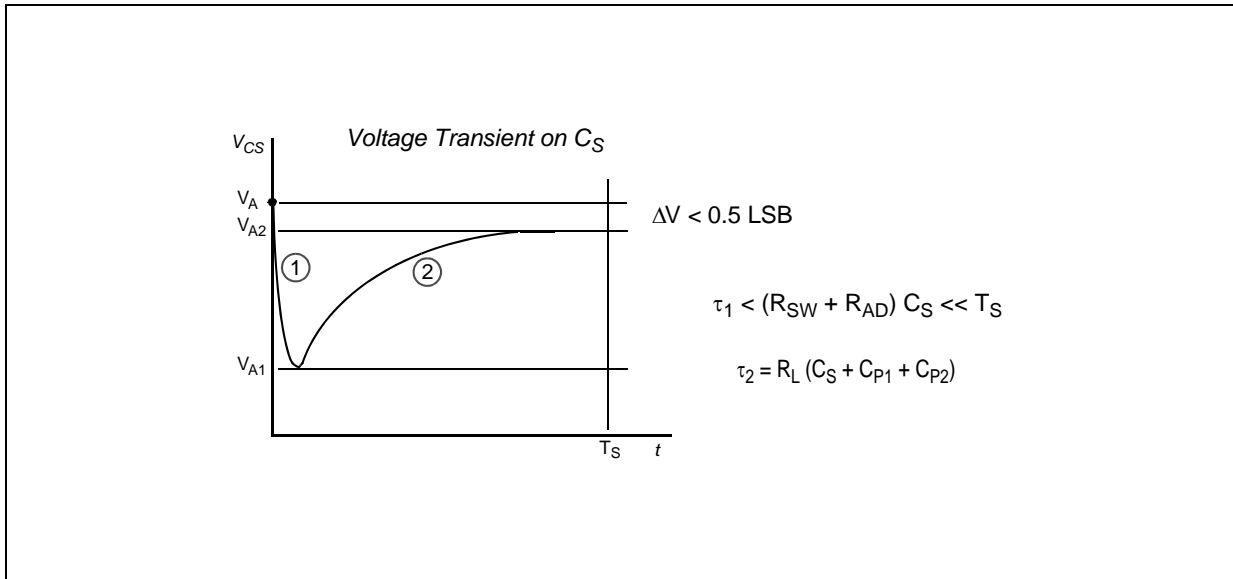


Figure 14. Transient Behavior during Sampling Phase

In particular two different transient periods can be distinguished:

- A first and quick charge transfer from the internal capacitance C_{P1} and C_{P2} to the sampling capacitance C_S occurs (C_S is supposed initially completely discharged): considering a worst case (since the time constant in reality would be faster) in which C_{P2} is reported in parallel to C_{P1} (call $C_P = C_{P1} + C_{P2}$), the two capacitances C_P and C_S are in series, and the time constant is

Eqn. 6

$$\tau_1 = (R_{SW} + R_{AD}) \cdot \frac{C_P \cdot C_S}{C_P + C_S}$$

Equation 6 can again be simplified considering only C_S as an additional worst condition. In reality, the transient is faster, but the A/D converter circuitry has been designed to be robust also in the very worst case: the sampling time T_S is always much longer than the internal time constant:

Eqn. 7

$$\tau_1 < (R_{SW} + R_{AD}) \cdot C_S \ll T_S$$

The charge of C_{P1} and C_{P2} is redistributed also on C_S , determining a new value of the voltage V_{A1} on the capacitance according to Equation 8:

Eqn. 8

$$V_{A1} \cdot (C_S + C_{P1} + C_{P2}) = V_A \cdot (C_{P1} + C_{P2})$$

- A second charge transfer involves also C_F (that is typically bigger than the on-chip capacitance) through the resistance R_L : again considering the worst case in which C_{P2} and C_S were in parallel to C_{P1} (since the time constant in reality would be faster), the time constant is:

Eqn. 9

$$\tau_2 < R_L \cdot (C_S + C_{P1} + C_{P2})$$

In this case, the time constant depends on the external circuit: in particular imposing that the transient is completed well before the end of sampling time T_S , a constraints on R_L sizing is obtained:

Eqn. 10

$$10 \cdot \tau_2 = 10 \cdot R_L \cdot (C_S + C_{P1} + C_{P2}) < T_S$$

Of course, R_L shall be sized also according to the current limitation constraints, in combination with R_S (source impedance) and R_F (filter resistance). Being C_F definitively bigger than C_{P1} , C_{P2} and C_S , then the final voltage V_{A2} (at the end of the charge transfer transient) will be much higher than V_{A1} . Equation 11 must be respected (charge balance assuming now C_S already charged at V_{A1}):

Eqn. 11

$$V_{A2} \cdot (C_S + C_{P1} + C_{P2} + C_F) = V_A \cdot C_F + V_{A1} \cdot (C_{P1} + C_{P2} + C_S)$$

The two transients above are not influenced by the voltage source that, due to the presence of the $R_F C_F$ filter, is not able to provide the extra charge to compensate the voltage drop on C_S with respect to the ideal source V_A ; the time constant $R_F C_F$ of the filter is very high with respect to the sampling time (T_S). The filter is typically designed to act as anti-aliasing.

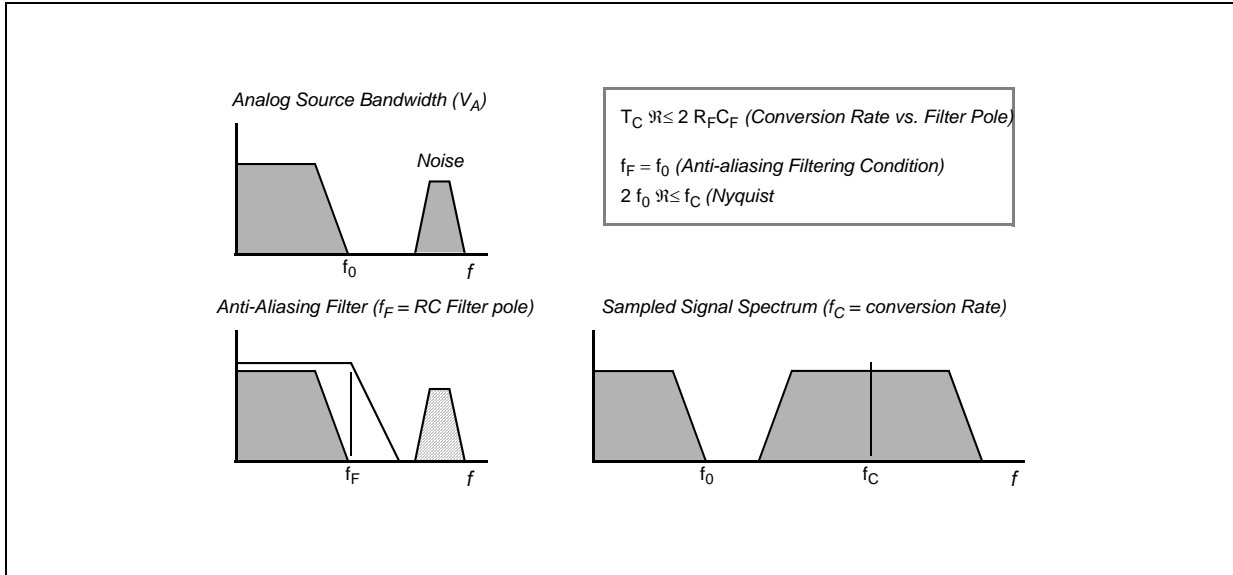


Figure 15. Spectral Representation of Input Signal

Calling f_0 the bandwidth of the source signal (and as a consequence the cut-off frequency of the anti-aliasing filter, f_F), according to the Nyquist theorem the conversion rate f_C must be at least $2f_0$; it means that the constant time of the filter is greater than or at least equal to twice the conversion period (T_C). Again the conversion period T_C is longer than the sampling time T_S , which is just a portion of it, even when fixed channel continuous conversion mode is selected (fastest conversion rate at a specific channel): in conclusion it is evident that the time constant of the filter $R_F C_F$ is definitively much higher than the sampling time T_S , so the charge level on C_S cannot be modified by the analog signal source during the time in which the sampling switch is closed.

The considerations above lead to impose new constraints on the external circuit, to reduce the accuracy error due to the voltage drop on C_S ; from the two charge balance equations above, it is simple to derive Equation 12 between the ideal and real sampled voltage on C_S :

Eqn. 12

$$\frac{V_A}{V_{A2}} = \frac{C_{P1} + C_{P2} + C_F}{C_{P1} + C_{P2} + C_F + C_S}$$

From this formula, in the worst case (when V_A is maximum, that is for instance 5V), assuming to accept a maximum error of half a count, a constraint is evident on C_F value:

Eqn. 13

$$C_F > 2048 \cdot C_S$$

4.16.2 ADC electrical characteristics

Table 45. ADC electrical characteristics

| Symbol | | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID |
|---------------------|-----------------|---|--|--|-------------------------|-----|-------------------------|------|--------|
| | | | | | Min | Typ | Max | | |
| V _{SSA} | SR | D | Voltage on VSSA (ADC reference) pin with respect to ground (V _{SS}) ³ | — | -0.1 | — | 0.1 | V | D15.1 |
| V _{DDA} | SR | D | Voltage on VDDA pin (ADC reference) with respect to ground (V _{SS}) | — | V _{DDE_A} -0.1 | — | V _{DDE_A} +0.1 | V | D15.2 |
| V _{AINx} | SR | D | Analog input voltage ⁴ | — | V _{SSA} -0.1 | — | V _{DDA} +0.1 | V | D15.3 |
| f _{ADC} | SR | D | ADC analog frequency | — | 6 | — | 32 | MHz | D15.4 |
| t _{ADC_PU} | SR | D | ADC power up delay | — | — | — | 1.5 | μs | D15.5 |
| t _{ADC_S} | CC ⁵ | T | Sample time ⁶ | f _{ADC} = 32 MHz, ADC_conf_sample_input = 17 | 0.5 | — | — | μs | D15.6 |
| | | | | f _{ADC} = 6 MHz, ADC_conf_sample_input = 127 | — | — | 21 | | |
| t _{ADC_C} | CC ⁵ | T | Conversion time ⁷ | f _{ADC} = 32 MHz, ADC_conf_comp = 2 | 0.625 | — | — | μs | D15.7 |
| C _S | CC ⁵ | D | ADC input sampling capacitance | — | — | — | 3 | pF | D15.8 |
| C _{P1} | CC ⁵ | D | ADC input pin capacitance 1 | — | — | — | 3 | pF | D15.9 |
| C _{P2} | CC ⁵ | D | ADC input pin capacitance 2 | — | — | — | 1 | pF | D15.10 |
| C _{P3} | CC ⁵ | D | ADC input pin capacitance 3 | — | — | — | 1 | pF | D15.11 |
| R _{SW1} | CC ⁵ | D | Internal resistance of analog source | — | — | — | 3 | kΩ | D15.12 |
| R _{SW2} | CC ⁵ | D | Internal resistance of analog source | — | — | — | 2 | kΩ | D15.13 |
| R _{AD} | CC ⁵ | D | Internal resistance of analog source | — | — | — | 0.1 | kΩ | D15.14 |
| I _{INJ} | SR | T | Input current Injection | Current injection on one ADC input, different from the converted one | -10 | — | 10 | mA | D15.15 |
| INL | CC ⁵ | P | Integral Non Linearity | No overload | -1.5 | — | 1.5 | LSB | D15.16 |
| DNL | CC ⁵ | P | Differential Non Linearity | No overload | -1.0 | — | 1.0 | LSB | D15.17 |
| OFS | CC ⁵ | T | Offset error | After offset cancellation | — | 0.5 | — | LSB | D15.18 |
| GNE | CC ⁵ | T | Gain error | — | — | 0.6 | — | LSB | D15.19 |

Table 45. ADC electrical characteristics (continued)

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID | |
|--------|-----------------|-----------|--|---|-----|-----|------|--------|--------|
| | | | | Min | Typ | Max | | | |
| TUEP | CC ⁵ | T | Total Unadjusted Error for precise channels, input only pins | No overload | -2 | — | 2 | LSB | D15.22 |
| | | | | overload conditions on adjacent channel | — | — | — | LSB | |
| TUEX | CC ⁵ | T | Total Unadjusted Error for extended channel, | No overload | -3 | — | 3 | LSB | D15.23 |
| | | | | overload conditions on adjacent channel | — | — | — | LSB | |

¹ $V_{DDA} = 3.3\text{ V} \pm 10\% / 5.0\text{ V} \pm 10\%$, $T_A = -40$ to $+105\text{ }^\circ\text{C}$, unless otherwise specified.

² All values need to be confirmed during device validation.

³ Analog and digital V_{SS} **must** be common (to be tied together externally).

⁴ V_{AINx} may exceed V_{SSA} and V_{DDA} limits, remaining on absolute maximum ratings, but the results of the conversion will be clamped respectively to 0x000 or 0x3FF.

⁵ Guaranteed by design.

⁶ During the sample time the input capacitance C_S can be charged/discharged by the external source. The internal resistance of the analog source must allow the capacitance to reach its final voltage level within t_{ADC_S} . After the end of the sample time t_{ADC_S} , changes of the analog input voltage have no effect on the conversion result. Values for the sample clock t_{ADC_S} depend on programming.

⁷ This parameter does not include the sample time t_{ADC_S} , but only the time for determining the digital result and the time to load the result's register with the conversion result.

4.17 AC specifications

4.17.1 AC specification for CMOS090LP2 library @ VDDE = 3.3 V

Table 46. Functional pad type AC specifications

| Name | C | Prop. delay (ns) L>H / H>L ¹ | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select |
|---------|---|--|-----------|---------------------|-----------|--------------------|---------------------------|
| | | Min | Max | Min | Max | | MSB, LSB |
| pad_ssr | C | — | 4.5 / 4.5 | — | 2.2 / 2.2 | 50 | 11 ² |
| | | — | 8 / 8 | — | 6 / 6 | 200 | |
| | | — | 45 / 45 | — | 22 / 22 | 50 | 10 |
| | | — | 60 / 60 | — | 28 / 28 | 200 | |
| | | — | 90 / 90 | — | 42 / 42 | 50 | 01 |
| | | — | 110 / 110 | — | 50 / 50 | 200 | |
| | | — | 430 / 430 | — | 210 / 210 | 50 | 00 |
| | | — | 480 / 480 | — | 220 / 220 | 200 | |

Table 46. Functional pad type AC specifications (continued)

| Name | C | Prop. delay (ns) L>H / H>L ¹ | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select |
|---------|---|--|-----------|---------------------|------------|--------------------|---------------------------|
| | | Min | Max | Min | Max | | MSB, LSB |
| pad_fc | C | — | 2.5 / 2.5 | — | 1.2 / 1.2 | 10 | 00 |
| | | — | 2.5 / 2.5 | — | 1.2 / 1.2 | 20 | 01 |
| | | — | 2.5 / 2.5 | — | 1.2 / 1.2 | 30 | 10 |
| | | — | 2.5 / 2.5 | — | 1.2 / 1.2 | 50 | 11 ² |
| pad_msr | C | — | 4.0 / 4.5 | — | 1.02 / 1.4 | 50 | 11 ² |
| | | — | 7.3 / 8.3 | — | 3.5 / 4.2 | 200 | |
| | | — | 24 / 22 | — | 9.1 / 10.3 | 50 | 10 |
| | | — | 33 / 31 | — | 14 / 15 | 200 | |
| | | — | 49 / 44 | — | 18 / 21 | 50 | 01 |
| | | — | 60 / 53 | — | 24 / 25 | 200 | |
| | | — | 332 / 302 | — | 126 / 151 | 50 | 00 |
| | | — | 362 / 325 | — | 136 / 158 | 200 | |

¹ L>H signifies low-to-high propagation delay and H>L signifies high-to-low propagation delay.

² Can be used on the tester.

4.17.2 AC specification for CMOS090LP2fg library @ VDDE = 5.0 V

Table 47. Functional pad type AC specifications

| Name | C | Prop. delay (ns) L>H / H>L ¹ | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select | |
|-------------------------|---|--|-----------|---------------------|-----------|--------------------|---------------------------|-----------------|
| | | Min | Max | Min | Max | | MSB, LSB | |
| pad_msr_hv ² | C | 4.6 / 3.7 | 12 / 12 | 2.2 / 2.2 | 5.3 / 5.9 | 50 | 11 ³ | |
| | | 13 / 10 | 32 / 32 | 9 / 9 | 22 / 22 | 200 | | |
| | | N/A | | | | | | 10 ⁴ |
| | | 12 / 13 | 28 / 34 | 5.6 / 6 | 12 / 15 | 50 | 01 | |
| | | 23 / 23 | 52 / 59 | 11 / 14 | 28 / 31 | 200 | | |
| | | 69 / 71 | 152 / 165 | 34 / 35 | 70 / 74 | 50 | 00 | |
| | | 95 / 90 | 205 / 220 | 44 / 51 | 96 / 96 | 200 | | |

Table 47. Functional pad type AC specifications (continued)

| Name | C | Prop. delay (ns) L>H / H>L ¹ | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select | |
|-------------------------|---|--|-----------|---------------------|-----------|--------------------|---------------------------|-----------------|
| | | Min | Max | Min | Max | | MSB, LSB | |
| pad_ssr_hv ² | C | 7.3 / 5.7 | 19 / 18 | 4.4 / 4.3 | 10 / 11 | 50 | 11 ³ | |
| | | 24 / 19 | 58 / 58 | 17 / 15 | 40 / 42 | 200 | | |
| | | N/A | | | | | | 10 ⁴ |
| | | 26 / 27 | 61 / 69 | 13 / 13 | 30 / 34 | 50 | 01 | |
| | | 49 / 45 | 115 / 115 | 27 / 23 | 61 / 61 | 200 | | |
| | | 137 / 142 | 320 / 330 | 72 / 74 | 156 / 164 | 50 | 00 | |
| | | 182 / 172 | 420 / 420 | 90 / 85 | 200 / 200 | 200 | | |
| pad_i_hv | C | 0.5 / 0.5 | 1.9 / 1.9 | 0.3 / 0.3 | 1.5 / 1.5 | 0.5 | N/A | |

¹ L>H signifies low-to-high propagation delay and H>L signifies high-to-low propagation delay.

² For input buffer timing, look at pad_i_hv.

³ Can be used on the tester.

⁴ This drive select value is not supported. If selected, it will be approximately equal to 11.

4.17.3 AC specification for CMOS090LP2fg library @ VDDE = 3.3 V

Table 48. Functional pad AC type specifications

| Name | Prop. delay (ns) L>H / H>L | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select | |
|------------|-------------------------------|-----------|---------------------|-----------|--------------------|---------------------------|----|
| | Min | Max | Min | Max | | MSB, LSB | |
| pad_msr_hv | 5.8 / 4.4 | 18 / 17 | 2.7 / 2.1 | 7.6 / 8.5 | 50 | 11 | |
| | 16 / 13 | 46 / 49 | 11.2 / 8.6 | 30 / 34 | 200 | | |
| | N/A | | | | | | 10 |
| | 14 / 16 | 37 / 45 | 6.5 / 6.7 | 15.5 / 19 | 50 | 01 | |
| | 27 / 27 | 69 / 82 | 15 / 13 | 38 / 43 | 200 | | |
| | 83 / 86 | 200 / 210 | 38 / 38 | 86 / 86 | 50 | 00 | |
| | 113 / 109 | 270 / 285 | 53 / 46 | 120 / 120 | 200 | | |

Table 48. Functional pad AC type specifications (continued)

| Name | Prop. delay (ns) L>H / H>L | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select |
|------------|-------------------------------|-----------|---------------------|-----------|--------------------|---------------------------|
| | Min | Max | Min | Max | | MSB, LSB |
| pad_ssr_hv | 9.2 / 6.9 | 27 / 28 | 5.5 / 4.1 | 15 / 17 | 50 | 11 |
| | 30 / 23 | 81 / 87 | 21 / 16 | 57 / 63 | 200 | |
| | N/A | | | | | 10 |
| | 31 / 31 | 80 / 90 | 15.4 / 15.4 | 38 / 42 | 50 | 01 |
| | 58 / 52 | 144 / 155 | 32 / 26 | 82 / 85 | 200 | |
| | 162 / 168 | 415 / 415 | 80 / 82 | 190 / 190 | 50 | 00 |
| | 216 / 205 | 533 / 540 | 106 / 95 | 250 / 250 | 200 | |
| pad_i_hv | 0.5 / 0.5 | 3 / 3 | 0.4 / 0.4 | 1.5 / 1.5 | 0.5 | N/A |

4.17.4 Pad AC specifications (3.3 V, PAD3V5V = 1)

Table 49. Pad AC specifications (3.3 V, PAD3V5V = 1)¹

| No. | Pad | Tswitchon ¹ (ns) | | | Rise/Fall ² (ns) | | | Frequency (MHz) | | | Current slew (mA/ns) | | | Load drive (pF) |
|-----------------------------|-----------------------------|--------------------------------|-----|-----|--------------------------------|-----|------|--------------------|-----|-----|-------------------------|-----|-----|--------------------|
| | | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max | |
| 1 | Slow | 3 | — | 40 | 4 | — | 40 | — | — | 4 | 0.01 | — | 2 | 25 |
| | | 3 | — | 40 | 6 | — | 50 | — | — | 2 | 0.01 | — | 2 | 50 |
| | | 3 | — | 40 | 10 | — | 75 | — | — | 2 | 0.01 | — | 2 | 100 |
| | | 3 | — | 40 | 14 | — | 100 | — | — | 2 | 0.01 | — | 2 | 200 |
| 2 | Medium | 1 | — | 15 | 2 | — | 12 | — | — | 40 | 2.5 | — | 7 | 25 |
| | | 1 | — | 15 | 4 | — | 25 | — | — | 20 | 2.5 | — | 7 | 50 |
| | | 1 | — | 15 | 8 | — | 40 | — | — | 13 | 2.5 | — | 7 | 100 |
| | | 1 | — | 15 | 14 | — | 70 | — | — | 7 | 2.5 | — | 7 | 200 |
| 3 | Fast | 1 | — | 6 | 1 | — | 4 | — | — | 72 | 3 | — | 40 | 25 |
| | | 1 | — | 6 | 1.5 | — | 7 | — | — | 55 | 3 | — | 40 | 50 |
| | | 1 | — | 6 | 3 | — | 12 | — | — | 40 | 3 | — | 40 | 100 |
| | | 1 | — | 6 | 5 | — | 18 | — | — | 25 | 3 | — | 40 | 200 |
| 4 | Pull Up/Down (3.6 V max) | — | — | — | — | — | 7500 | — | — | — | — | — | — | 50 |
| Parameter Classification | | D | | | C | | | C | | | C | | | n/a |

¹ Propagation delay from $V_{DD}/2$ of internal signal to Pchannel/Nchannel on condition.

² Slope at rising/falling edge.

4.17.5 AC specification for CMOS090_dds library @ VDDE = 3.3 V

Table 50. AC specifications at 3.3 V VDDE

| Name | C | Prop. delay (ns) L>H / H>L | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select | Libraries |
|------------|---|-------------------------------|---------|---------------------|---------|--------------------|---------------------------|-----------|
| | | Min | Max | Min | Max | | MSB, LSB | |
| pad_st_acc | C | 1.4/1.4 | 2.4/2.4 | 3.1/2.5 | 5.6/5.4 | 5 | 111 | 6MDDR |
| | | 1.7/1.7 | 2.7/2.7 | 0.9/1.1 | 1.7/2.0 | 20 | | |
| pad_st_dq | C | 1.4/1.4 | 2.4/2.4 | 3.1/2.5 | 5.6/5.4 | 5 | 111 | 6MDDR |
| | | 1.7/1.7 | 2.7/2.7 | 0.9/1.1 | 1.7/2.0 | 20 | | |
| pad_st_clk | C | 1.4/1.4 | 2.4/2.4 | 3.1/2.5 | 5.7/5.7 | 5 | 111 | 6MDDR |
| | | 1.6/1.6 | 2.6/2.6 | 1.1/1.3 | 2.3/2.3 | 20 | | |

4.17.6 AC specification for CMOS090_dds library @ VDDE = 2.5 V

Table 51. AC specifications at 2.5 V VDDE

| Name | C | Prop. delay (ns) L>H / H>L | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select | Libraries |
|------------|---|-------------------------------|---------|---------------------|---------|--------------------|---------------------------|-----------|
| | | Min | Max | Min | Max | | MSB, LSB | |
| pad_st_acc | C | 1.4/1.5 | 2.5/2.4 | 2.1/2.1 | 4.3/4.1 | 5 | 011 | 6MDDR |
| | | 1.7/1.7 | 2.8/2.7 | 0.6/0.7 | 1.1/1.3 | 20 | | |
| pad_st_dq | C | 1.4/1.5 | 2.5/2.4 | 2.1/2.1 | 4.3/4.1 | 5 | 011 | 6MDDR |
| | | 1.7/1.7 | 2.8/2.7 | 0.6/0.7 | 1.1/1.3 | 20 | | |
| pad_st_clk | C | 1.4/1.4 | 2.4/2.4 | 2.1/2.1 | 4.4/4.1 | 5 | 011 | 6MDDR |
| | | 1.1/1.6 | 2.7/2.7 | 0.6/0.7 | 1.6/1.8 | 20 | | |

4.17.7 AC specification for CMOS090_ ddr library @ VDDE = 1.8 V

Table 52. AC electrical specifications at 1.8 V VDD

| Name | C | Prop. delay (ns) L>H / H>L | | Rise/fall edge (ns) | | Drive load (pF) | Drive/slew rate select | Libraries |
|------------|---|-------------------------------|---------|---------------------|---------|--------------------|---------------------------|-----------|
| | | Min | Max | Min | Max | | MSB, LSB | |
| pad_st_acc | C | 1.4/1.4 | 2.4/2.4 | 0.6/1.0 | 2.7/2.6 | 5 | 000 | 6MDDR |
| | | 1.7/1.7 | 2.8/2.7 | 0.2/0.4 | 0.5/0.6 | 20 | | |
| | | 1.4/1.5 | 2.4/2.5 | 1.1/1.1 | 3.0/2.7 | 5 | 001 | |
| | | 1.7/1.7 | 2.8/2.8 | 0.4/0.4 | 0.7/0.7 | 20 | | |
| | | 1.4/1.5 | 2.4/2.4 | 1.0/1.1 | 2.9/2.7 | 5 | 010 | |
| | | 1.7/1.7 | 2.8/2.7 | 0.3/0.4 | 0.6/0.7 | 20 | | |
| | | 1.4/1.5 | 2.5/2.5 | 1.5/1.1 | 3.1/2.6 | 5 | 110 | |
| | | 1.7/1.8 | 2.8/2.8 | 0.4/0.4 | 0.7/0.6 | 20 | | |
| pad_st_dq | C | 1.4/1.4 | 2.4/2.4 | 0.6/1.0 | 2.7/2.6 | 5 | 000 | 6MDDR |
| | | 1.7/1.7 | 2.8/2.7 | 0.2/0.4 | 0.5/0.6 | 20 | | |
| | | 1.4/1.5 | 2.4/2.5 | 1.1/1.1 | 3.0/2.7 | 5 | 001 | |
| | | 1.7/1.7 | 2.8/2.8 | 0.4/0.4 | 0.7/0.7 | 20 | | |
| | | 1.4/1.5 | 2.4/2.4 | 1.0/1.1 | 2.9/2.7 | 5 | 010 | |
| | | 1.7/1.7 | 2.8/2.7 | 0.3/0.4 | 0.6/0.7 | 20 | | |
| | | 1.4/1.5 | 2.5/2.5 | 1.5/1.1 | 3.1/2.6 | 5 | 110 | |
| | | 1.7/1.8 | 2.8/2.8 | 0.4/0.4 | 0.7/0.6 | 20 | | |
| pad_st_clk | C | 1.4/1.4 | 2.4/2.4 | 0.4/0.6 | 2.7/2.7 | 5 | 000 | 6MDDR |
| | | 1.6/1.6 | 2.7/2.7 | 0.7/0.9 | 1.8/3.4 | 20 | | |
| | | 1.4/1.4 | 2.4/2.4 | 1.1/1.1 | 3.0/2.8 | 5 | 001 | |
| | | 1.7/1.7 | 2.7/2.7 | 0.3/0.4 | 1.0/1.1 | 20 | | |
| | | 1.4/1.4 | 2.4/2.4 | 0.9/1.1 | 3.0/2.8 | 5 | 010 | |
| | | 1.6/1.6 | 2.7/2.7 | 0.3/0.4 | 0.9/1.0 | 20 | | |
| | | 1.4/1.5 | 2.5/2.5 | 1.5/1.2 | 3.2/2.6 | 5 | 110 | |
| | | 1.7/1.8 | 2.7/2.7 | 0.4/0.4 | 1.1/1.2 | 20 | | |

4.18 AC timing

4.18.1 IEEE 1149.1 interface timing

Table 53. JTAG Interface Timing¹

| Num | Symbol | CC ² | C | Characteristic | Min | Max | Unit | SpecID |
|-----|----------------------|-----------------|---|--|-----|-----|------|--------|
| 1 | t_{JCYC} | CC ² | D | TCK Cycle Time | 100 | — | ns | A1.1 |
| 2 | t_{JDC} | CC ² | D | TCK Clock Pulse Width (Measured at $V_{DD}/2$) | 40 | 60 | ns | A1.2 |
| 3 | $t_{TCKRISE}$ | CC ² | D | TCK Rise and Fall Times (40% – 70%) | — | 3 | ns | A1.3 |
| 4 | t_{TMSS}, t_{TDIS} | CC ² | D | TMS, TDI Data Setup Time | 5 | — | ns | A1.4 |
| 5 | t_{TMSH}, t_{TDIH} | CC ² | D | TMS, TDI Data Hold Time | 25 | — | ns | A1.5 |
| 6 | t_{TDOV} | CC ² | D | TCK Low to TDO Data Valid | — | 35 | ns | A1.6 |
| 7 | t_{TDOI} | CC ² | D | TCK Low to TDO Data Invalid | 0 | — | ns | A1.7 |
| 8 | t_{TDOHZ} | CC ² | D | TCK Low to TDO High Impedance | — | 30 | ns | A1.8 |
| 9 | t_{BSDV} | CC ² | D | TCK Falling Edge to Output Valid | — | 35 | ns | A1.9 |
| 10 | t_{BSDVZ} | CC ² | D | TCK Falling Edge to Output Valid out of High Impedance | — | 50 | ns | A1.10 |
| 11 | t_{BSDHZ} | CC ² | D | TCK Falling Edge to Output High Impedance | — | 50 | ns | A1.11 |
| 12 | t_{BSDST} | CC ² | D | Boundary Scan Input Valid to TCK Rising Edge | 50 | — | ns | A1.12 |
| 13 | t_{BSDHT} | CC ² | D | TCK Rising Edge to Boundary Scan Input Invalid | 50 | — | ns | A1.13 |

¹ These specifications apply to JTAG boundary scan only. JTAG timing specified at $V_{DD} = 3.0\text{ V to }3.6\text{ V}$, $T_A = -40\text{ to }105\text{ }^\circ\text{C}$, and $CL = 50\text{ pF}$ with $SRC = 0b01$.

² Parameter values guaranteed by design.

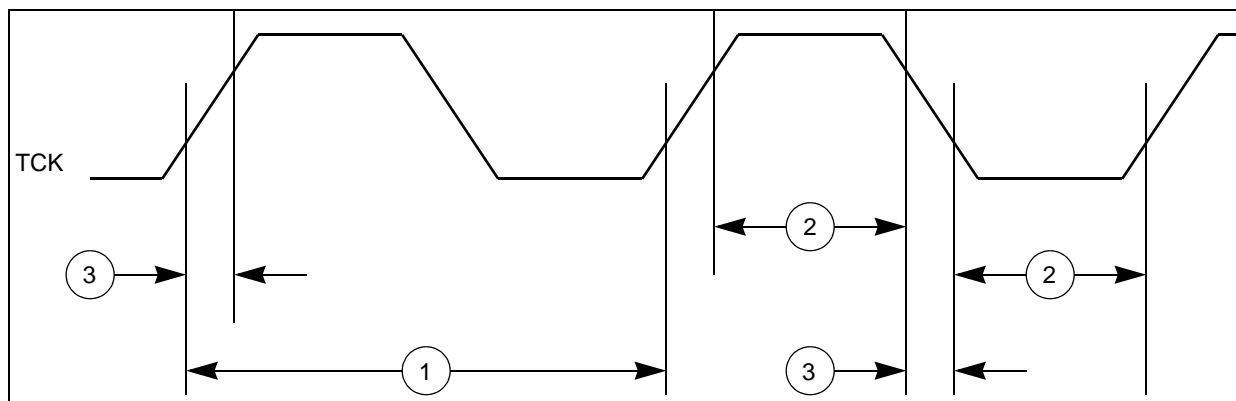


Figure 16. JTAG Test Clock Input Timing

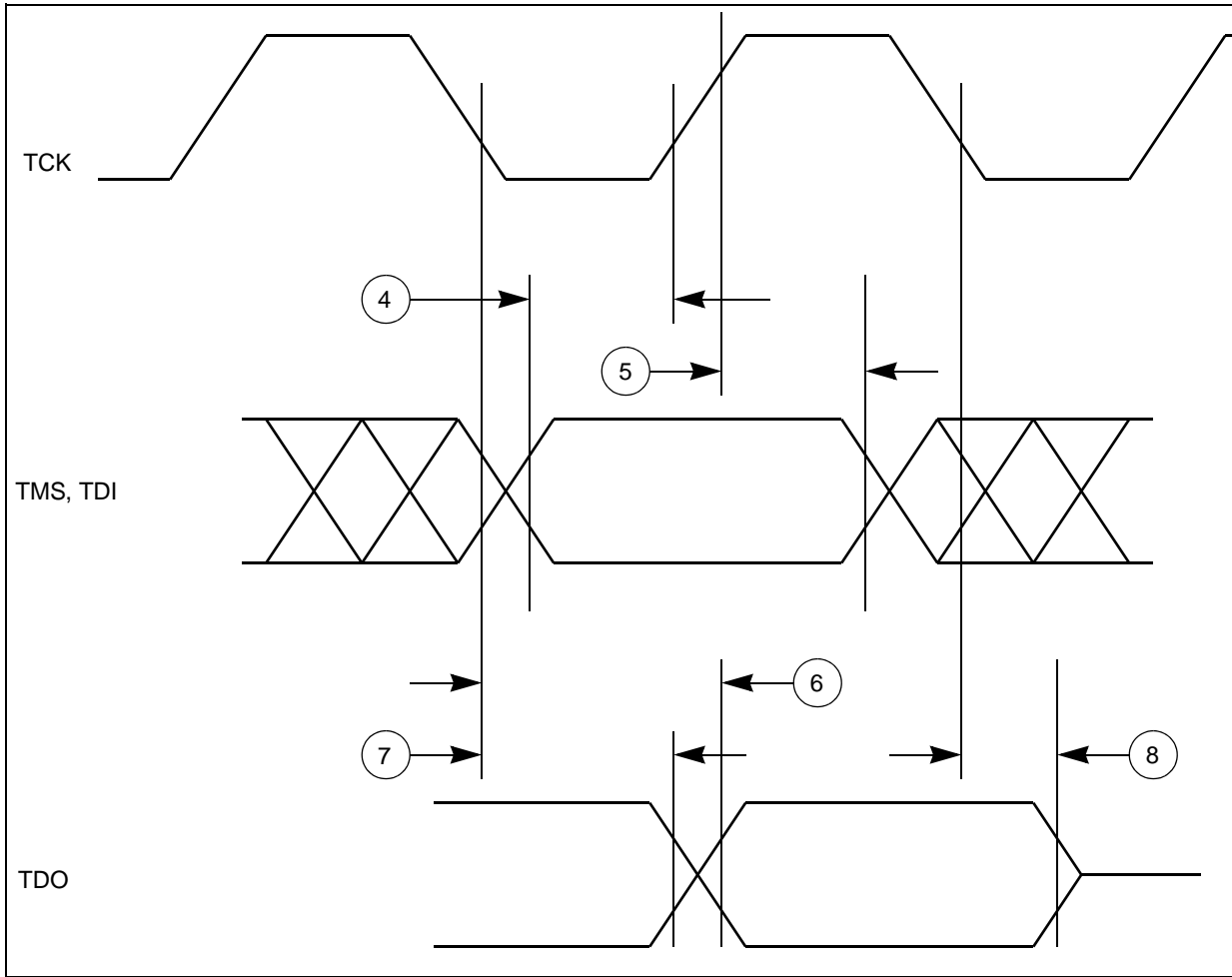


Figure 17. JTAG Test Access Port Timing

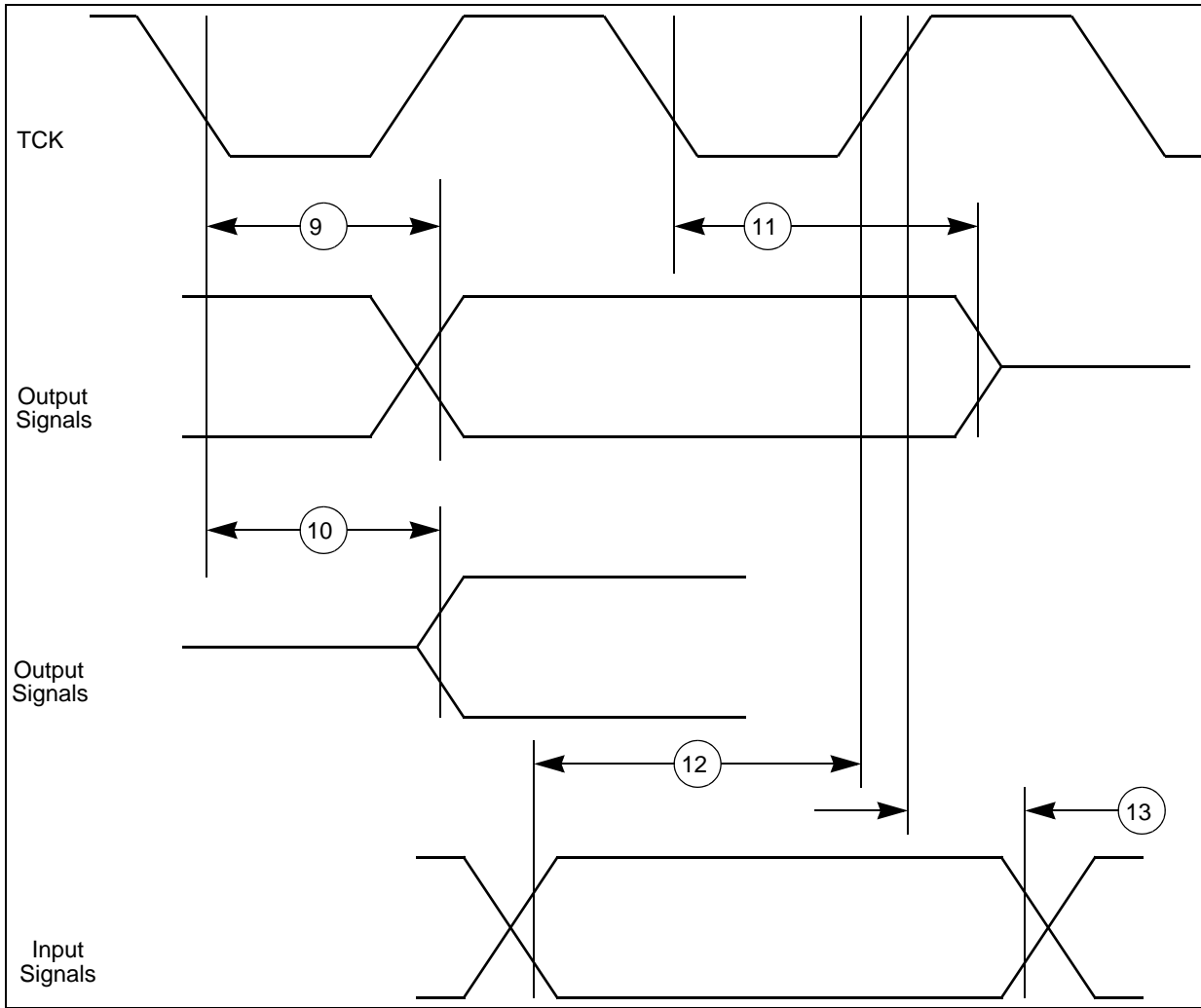


Figure 18. JTAG Boundary Scan Timing

4.18.2 Nexus Debug Interface

Table 54. Nexus Debug Port Timing¹

| Num | Symbol | C | Characteristic | Min | Max | Unit | SpecID |
|-----|------------------------|-----------------|---|-----|-----|-------------|--------|
| 1 | t_{MCCYC} | CC ² | D MCKO Cycle Time | 15 | — | ns | A2.1 |
| 2 | t_{MDC} | CC ² | D MCKO Duty Cycle | 40 | 60 | % | A2.2 |
| 3 | t_{MDOV} | CC ² | D MCKO Low to MDO Data Valid ³ | 0.1 | 0.2 | t_{MCCYC} | A2.3 |
| 4 | t_{MSEOV} | CC ² | D MCKO Low to \overline{MSEO} Data Valid ³ | 0.1 | 0.2 | t_{MCCYC} | A2.4 |
| 5 | t_{EVTOV} | CC ² | D MCKO Low to \overline{EVTO} Data Valid ³ | 0.1 | 0.2 | t_{MCCYC} | A2.5 |
| 6 | t_{EVTIPW} | CC ² | D \overline{EVTI} Pulse Width | 4 | — | t_{TCYC} | A2.6 |
| 7 | t_{EVTOPW} | CC ² | D \overline{EVTO} Pulse Width | 1 | — | t_{MCCYC} | A2.7 |
| 8 | t_{TCYC} | CC ² | D TCK Cycle Time ⁴ | 100 | — | ns | A2.8 |
| 9 | t_{TDC} | CC ² | D TCK Duty Cycle | 40 | 60 | % | A2.9 |
| 10 | t_{NTDIS}, t_{NTMSS} | CC ² | D TDI, TMS Data Setup Time | 25 | — | ns | A2.10 |
| 11 | t_{NTDIH}, t_{NTMSH} | CC ² | D TDI, TMS Data Hold Time | 5 | — | ns | A2.11 |
| 12 | t_{JOV} | CC ² | D TCK Low to TDO Data Valid | 0 | 35 | ns | A2.12 |

¹ JTAG specifications in this table apply when used for debug functionality. All Nexus timing relative to MCKO is measured from 50% of MCKO and 50% of the respective signal. Nexus timing specified at $V_{DD} = 3.0$ V to 3.6 V, $T_A = -40$ to 105 °C, and $CL = 50$ pF ($CL = 30$ pF on MCKO), with $SRC = 0b10$ for MCKO and $0b11$ for others.

² Parameter values guaranteed by design.

³ MDO, \overline{MSEO} , and \overline{EVTO} data is held valid until next MCKO low cycle.

⁴ The system clock frequency needs to be three times faster than the TCK frequency.

NOTE

Nexus Dual Data Rate is not supported. The timings are mentioned for dedicated pins on 416BGA. The max value for #2, 3 and 4 above, are 0.3 of t_{MCCYC} for shared nexus ports.

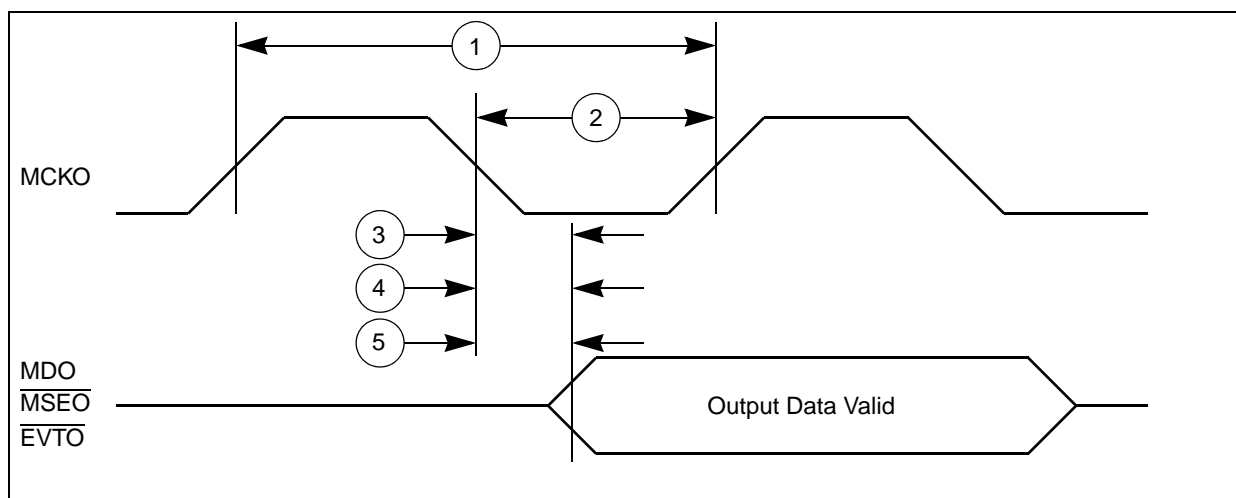


Figure 19. Nexus Output Timing

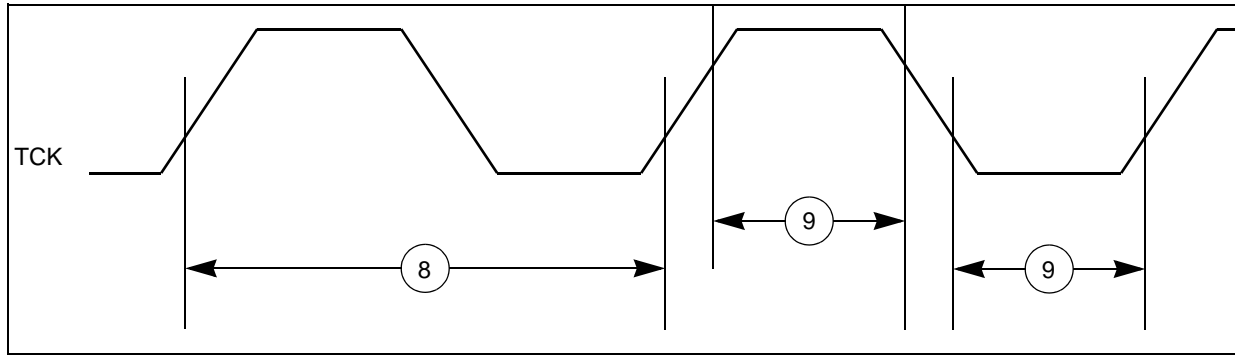


Figure 20. Nexus TCK Timing

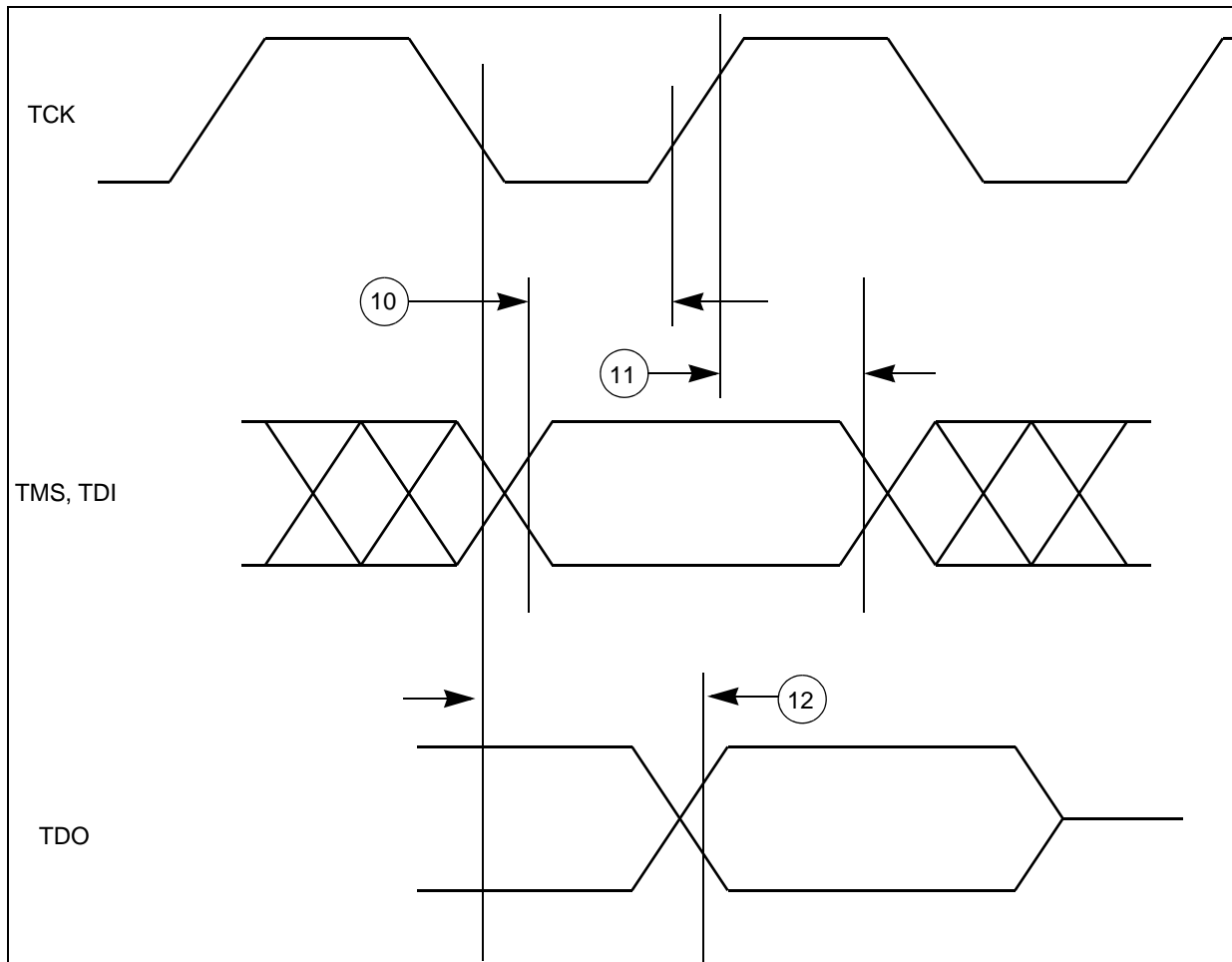


Figure 21. Nexus TDI, TMS, TDO Timing

4.18.3 Interface to TFT LCD Panels (DCU3 and DCULite)

Figure 22 depicts the LCD interface timing for a generic active matrix color TFT panel. In this figure signals are shown with positive polarity. The sequence of events for active matrix interface timing is:

- PCLK latches data into the panel on its positive edge (when positive polarity is selected). In active mode, PCLK runs continuously. This signal frequency could be from 5 to 66 MHz depending on the panel type.
- HSYNC causes the panel to start a new line. It always encompasses at least one PCLK pulse.
- VSYNC causes the panel to start a new frame. It always encompasses at least one HSYNC pulse.
- DE acts like an output enable signal to the LCD panel. This output enables the data to be shifted onto the display. When disabled, the data is invalid and the trace is off.

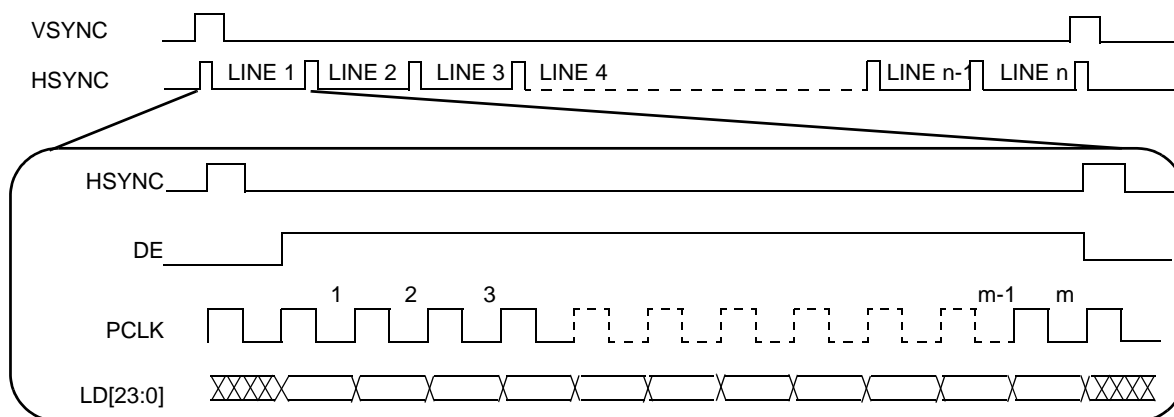


Figure 22. TFT LCD interface timing overview¹

4.18.3.1 Interface to TFT LCD Panels—Pixel Level Timings

Figure 23 depicts the horizontal timing (timing of one line), including both the horizontal sync pulse and data. All parameters shown in the diagram are programmable. This timing diagram corresponds to positive polarity of the PCLK signal (meaning the data and sync signals change on the rising edge) and active-high polarity of the HSYNC, VSYNC and DE signals. The user can select the polarity of the HSYNC and VSYNC signals via the SYN_POL register, whether active-high or active-low. The default is active-high. The DE signal is always active-high.

Pixel clock inversion and a flexible programmable pixel clock delay are also supported. They are programmed via the DCU Clock Confide Register (DCCR) in the system clock module.

The DELTA_X and DELTA_Y parameters are programmed via the DISP_SIZE register. The PW_H, BP_H and FP_H parameters are programmed via the HSYN PARA register. The PW_V, BP_V and FP_V parameters are programmed via the VSYN_PARA register.

1. In Figure 22, the “LD[23:0]” signal is “line data,” an aggregation of the DCU’s RGB signals—R[0:7], G[0:7] and B[0:7].

Table 55. LCD interface timing parameters—horizontal and vertical

| Num | Symbol | C | Characteristic | Value | Unit | SpecID | |
|-----|-----------|-----------------|----------------|----------------------------|--|--------|-------|
| 1 | t_{PCP} | CC ¹ | D | Display pixel clock period | 31.25 | ns | A3.1 |
| 2 | t_{PWH} | CC ¹ | D | HSYNC pulse width | $PW_H * t_{PCP}$ | ns | A3.2 |
| 3 | t_{BPH} | CC ¹ | D | HSYNC back porch width | $BP_H * t_{PCP}$ | ns | A3.3 |
| 4 | t_{FPH} | CC ¹ | D | HSYNC front porch width | $FP_H * t_{PCP}$ | ns | A3.4 |
| 5 | t_{SW} | CC ¹ | D | Screen width | $DELTA_X * t_{PCP}$ | ns | A3.5 |
| 6 | t_{HSP} | CC ¹ | D | HSYNC (line) period | $(PW_H + BP_H + FP_H + DELTA_X) * t_{PCP}$ | ns | A3.6 |
| 7 | t_{PWV} | CC ¹ | D | VSYNC pulse width | $PW_V * t_{HSP}$ | ns | A3.7 |
| 8 | t_{BPV} | CC ¹ | D | VSYNC back porch width | $BP_V * t_{HSP}$ | ns | A3.8 |
| | t_{FPV} | CC ¹ | D | VSYNC front porch width | $FP_V * t_{HSP}$ | ns | A3.9 |
| | t_{SH} | CC ¹ | D | Screen height | $DELTA_Y * t_{HSP}$ | ns | A3.10 |
| | t_{VSP} | CC ¹ | D | VSYNC (frame) period | $(PW_V + BP_V + FP_V + DELTA_Y) * t_{HSP}$ | ns | A3.11 |

¹ Parameter values guaranteed by design.

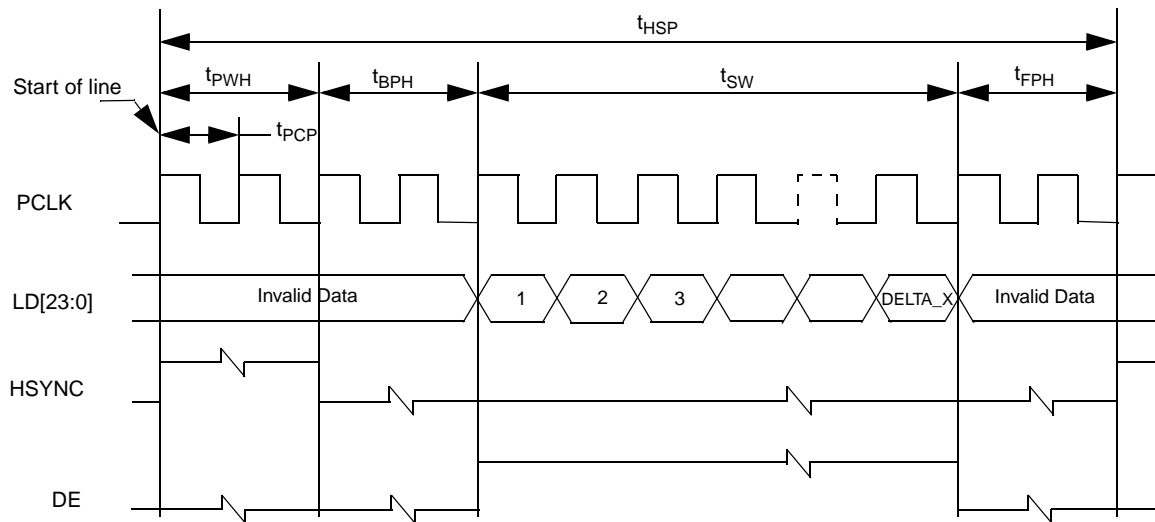


Figure 23. Horizontal sync timing

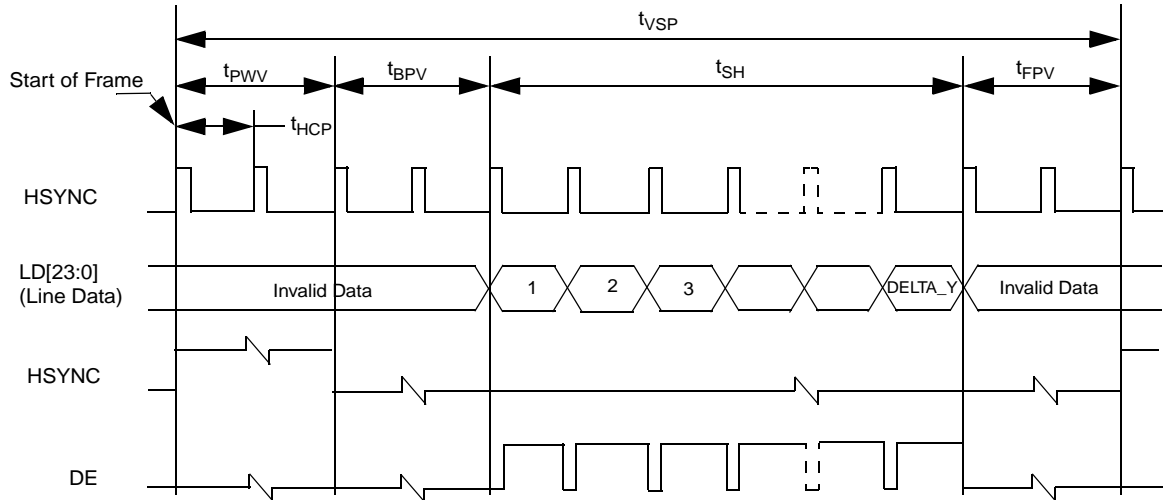


Figure 24. Vertical sync pulse

4.18.3.2 Interface to TFT LCD panels—access level

Table 56. LCD Interface Timing Parameters^{1,2,3,4}—Access Level

| Num | Symbol | C | Characteristic | Min. Value | Typical Value | Max. Value | Unit | SpecID |
|-----|-----------|-----------------|---|------------|---------------|------------|------|--------|
| 1 | t_{CKP} | CC ⁵ | D PDI Clock Period | 31.25 | — | — | ns | A3.12 |
| 2 | t_{CHD} | CC ⁵ | D Duty cycle | 40 | — | 60 | % | A3.13 |
| 3 | t_{DSU} | CC ⁵ | D interface data setup time | 6 | — | — | ns | A3.14 |
| 4 | t_{DHD} | CC ⁵ | D PDI interface data access hold time | 1 | — | — | ns | A3.15 |
| 5 | t_{CSU} | CC ⁵ | D PDI interface control signal setup time | 3 | — | — | ns | A3.16 |
| 6 | t_{CHD} | CC ⁵ | D PDI interface control signal hold time | 1 | — | — | ns | A3.17 |
| 7 | | CC ⁵ | D TFT interface data valid after pixel clock | — | — | 6 | ns | A3.18 |
| 8 | | CC ⁵ | D TFT interface HSYNC valid after pixel clock | — | — | 5 | ns | A3.19 |
| 9 | | CC ⁵ | D TFT interface VSYNC valid after pixel clock | — | — | 5.5 | ns | A3.20 |
| 10 | | CC ⁵ | D TFT interface DE valid after pixel clock | — | — | 5.6 | ns | A3.21 |
| 11 | | CC ⁵ | D TFT interface hold time for data and control bits | 2 | — | — | ns | A3.22 |
| 12 | | CC ⁵ | D Relative skew between the data bits | — | — | 3.7 | ns | A3.23 |

¹ The characteristics in this table are based on the assumption that data is output at +ve edge and displays latch data on -ve edge.

² Intra bit skew is less than 2 ns.

³ Load CL = 50 pf for frequency up to 20 MHz.

⁴ Load CL = 25 pf for display freq from 20 to 32 MHz.

⁵ Parameter values guaranteed by design.

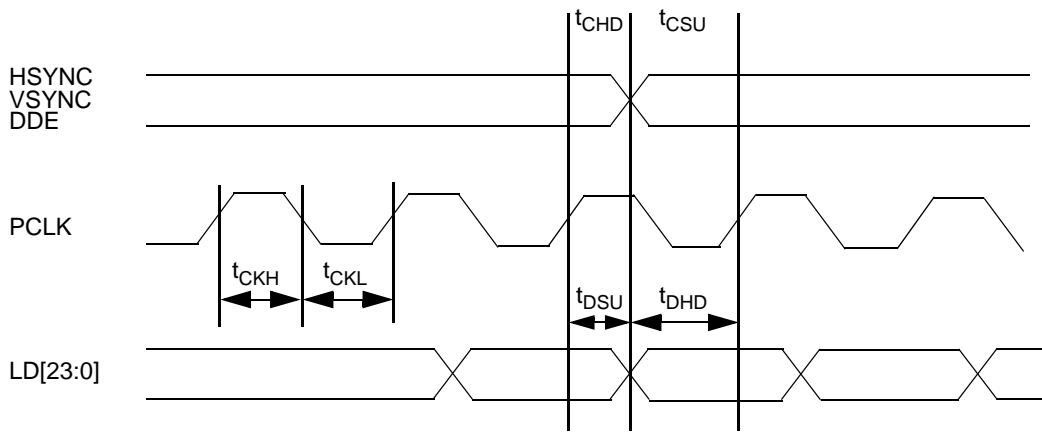


Figure 25. LCD Interface Timing Parameters—Access Level

4.18.4 RSDS Interface to TFT LCD Panels

Table 57. RSDS Electrical Characteristics

| Symbol | C | Parameter | Conditions ¹ | Value ² | | | Unit | SpecID | |
|---------------------------------|----|-----------|---|---|-----|-----|------|--------|-------|
| | | | | Min | Typ | Max | | | |
| AVDD | SR | D | Voltage on VSSE_A pin with respect to ground (V _{SS}) | — | 3.0 | 3.3 | 3.6 | V | A4.1 |
| I _{DDTX} | SR | D | Current Consumption: RSDS Transmitter - Single Cell | — | — | 2.7 | — | mA | A4.2 |
| I _{DDPD} | SR | D | Power Down Current | — | — | 10 | — | μA | A4.3 |
| I _{DDBG} | SR | D | Current Consumption of Bandgap and buffer | — | — | 100 | — | μA | A4.4 |
| F _{max} | SR | D | Data Frequency | — | — | 60 | 85 | MHz | A4.5 |
| V _{OD} | SR | D | Differential Output Voltage | R _L = 100 Ω | — | 200 | 400 | mV | A4.6 |
| V _{OFF} | SR | D | Offset Voltage | V _{CM} +/-5% | 0.5 | 1.2 | 1.5 | V | A4.7 |
| t _R / t _F | SR | D | Output Rise / Fall times | 20% to 80%, V _{OD} =200mV, C _L = 5pF | — | 500 | — | ps | A4.8 |
| t _{Xdelay} | SR | D | Tx Delay | — | — | 3 | — | ns | A4.9 |
| | SR | D | Termination Resistance (external) | 5% variation | — | 100 | — | Ω | A4.10 |
| | SR | D | Transmitter Settling time | After power down, high to low | — | 10 | — | μs | A4.11 |
| | SR | D | Transmitter Delay | Data in to Tx out | — | 8 | — | ns | A4.12 |

¹ V_{DDA} = 3.3 V ± 10% T_A = -40 to +105 °C, unless otherwise specified.

² All values need to be confirmed during device validation.

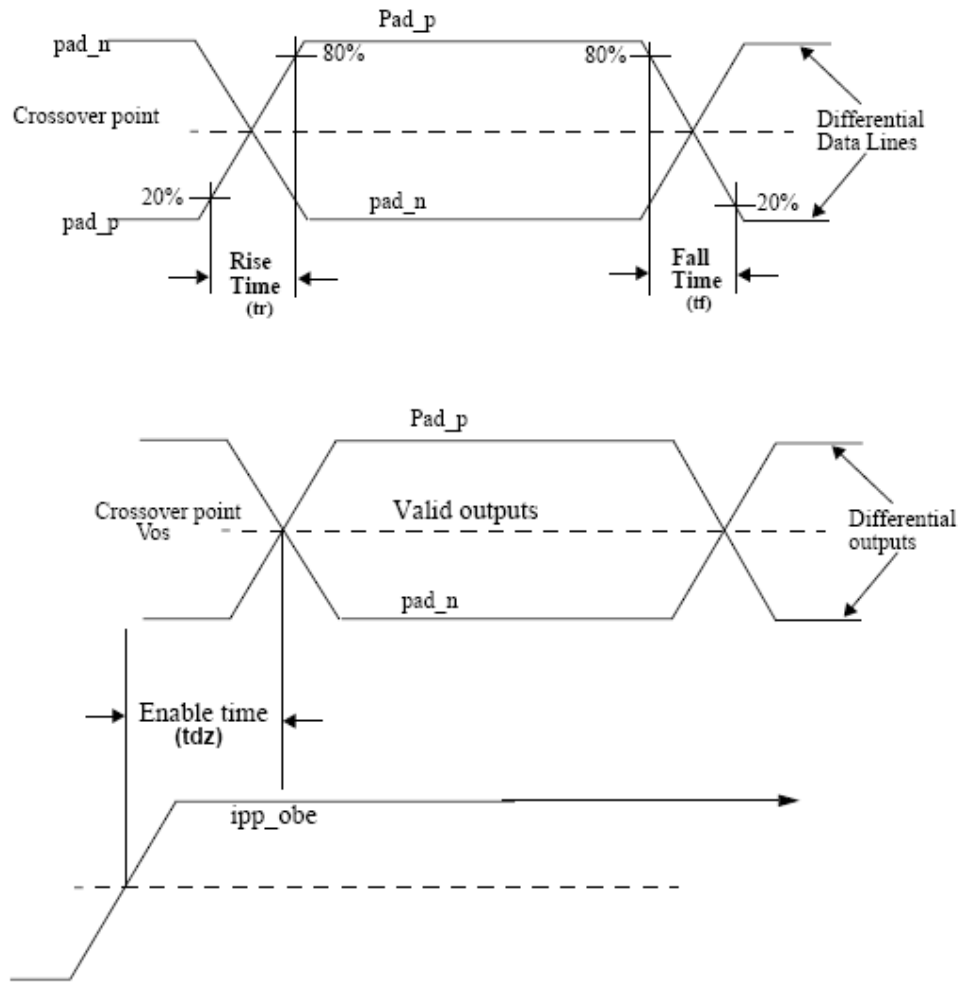


Figure 26. TCON/RSDS Timing Diagram

4.18.5 DRAM Interface

DDR Interface specification from ‘MCD - 32 Bit Automotive MCU - CMOS090LP2’ I/O Pad Specification Revision 1.5 - May14th 2008.

This device supports SDR, DDR1, DDR2 half and full strengths, as well as LPDDR half and full speeds. Table 58 shows the SRE settings for the different modes.

Table 58. Pad mode configurations

| ipp_sre[2:0] | Mode |
|--------------|-------------------------|
| 000 | 1.8V LPDDR Half Speed |
| 001 | 1.8V LPDDR Full Speed |
| 010 | 1.8V DDR2 Half Strength |
| 011 | 2.5V DDR1 |
| 100 | Not supported |
| 101 | Not supported |
| 110 | 1.8V DDR2 Full Strength |
| 111 | SDR |

NOTE

The specs mentioned in the following table are preliminary.

Table 59. LPDDR, DDR and DDR2 (DDR2-250) SDRAM timing specifications^{1 2}

At recommended operating conditions with V_{DDE_DR} of $\pm 5\%$

| No. | Symbol | | Parameter | Min | Max | Unit |
|-----|-----------------|----|---|--------------------------------|--------------------------------|------|
| 1 | F | CC | Frequency of Operation (Clock Period) | N/A | 125 | MHz |
| 1.1 | t_{CK} | CC | Clock period | N/A | 8 | ns |
| 2 | V_{IX-AC} | CC | MCK AC differential crosspoint voltage ³ | $V_{DDE_DR} \times 0.5 - 0.1$ | $V_{DDE_DR} \times 0.5 + 0.1$ | V |
| 3 | t_{CH} | CC | CK HIGH pulse width ^{3, 4} | 0.47 | 0.53 | TCK |
| 4 | t_{CL} | CC | CK LOW pulse width ^{3, 4} | 0.47 | 0.53 | tCK |
| 5 | t_{DQSS} | CC | Skew between MCK and DQS transitions ^{4, 5} | 150 | 150 | ps |
| 6 | $t_{OS(base)}$ | CC | Address and control output setup time relative to MCK rising edge ^{4, 5} | $(t_{CK}/2) - 1000$ | N/A | ps |
| 7 | $t_{OH(base)}$ | CC | Address and control output hold time relative to MCK rising edge ^{4, 5} | $(t_{CK}/2) + 1000$ | N/A | ps |
| 8 | $t_{DS1(base)}$ | CC | DQ and DM output setup time relative to DQS ^{4, 5} | $(t_{CK}/4) - 750$ | N/A | ps |
| 9 | $t_{DH1(base)}$ | CC | DQ and DM output hold time relative to DQS ^{4, 5} | $(t_{CK}/4) + 750$ | N/A | ps |
| 10 | t_{DQSQ} | CC | DQS-DQ skew for DQS and associated DQ inputs ⁴ | $-(t_{CK}/4) - 600$ | $(t_{CK}/4) - 600$ | ps |
| 11 | t_{DQSEN} | CC | DQS window start position related to CAS read command ^{3, 4, 5, 6, 7} | TBD | TBD | ps |

- 1 V_{DDE_DR} value is 1.8 V for DDR2 mode, 2.5 V for DDR1 mode, and 1.8 V for LPDDR mode.
- 2 C_Z at -40, 140, 25 °C.
- 3 Measured with clock pin loaded with differential 100 ohm termination resistor.
- 4 All transitions measured at mid-supply ($V_{DDE_DR}/2$).
- 5 Measured with all outputs except the clock loaded with 50 ohm termination resistor to $V_{DDE_DR}/2$.
- 6 In this window, the first rising edge of DQS should occur. From the start of the window to DQS rising edge, DQS should be low.
- 7 Window position is given for $t_{DQSEN} = 2.0 t_{CK}$. For other values of t_{DQSEN} , window position is shifted accordingly.

Figure 27 shows the DDR SDRAM write timing.

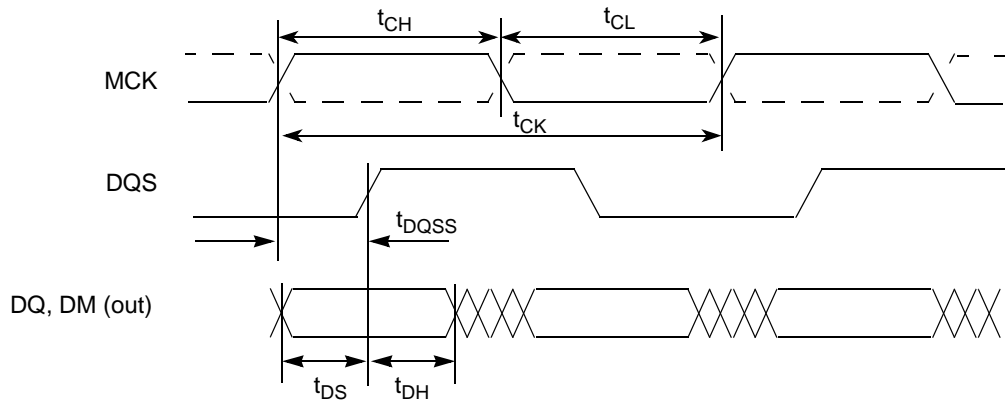


Figure 27. DDR write timing

Figure 28 and Figure 29 show the DDR SDRAM read timing.

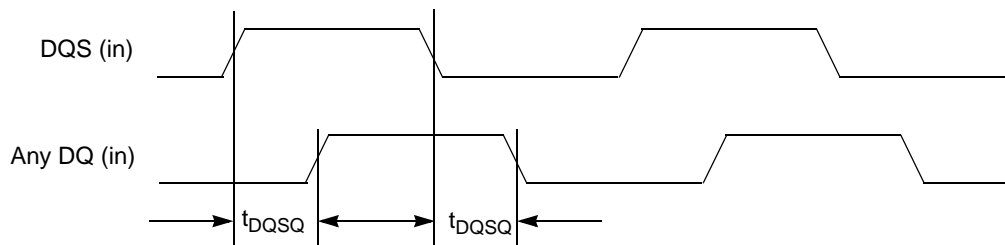


Figure 28. DDR read timing, DQ vs. DQS

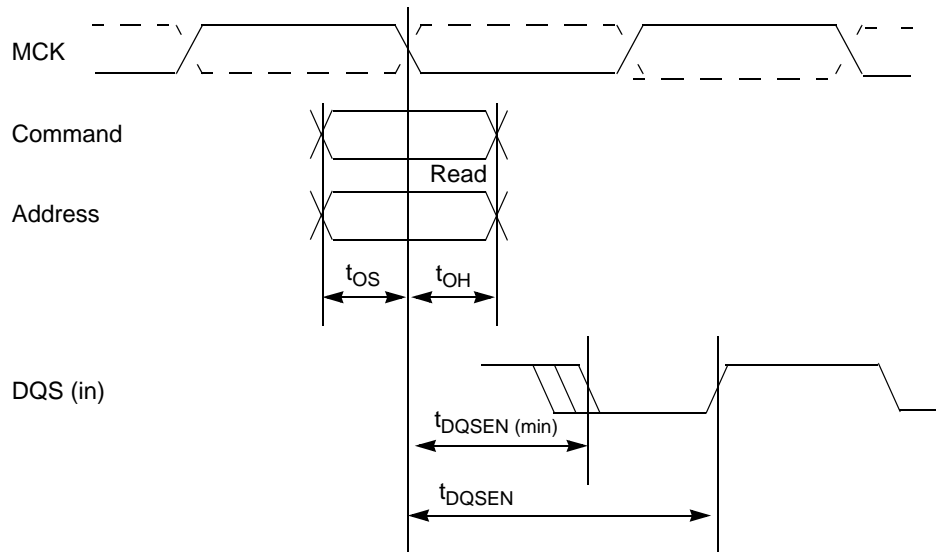


Figure 29. DDR read timing, DQSEN

Figure 30 provides the AC test load for the DDR bus.

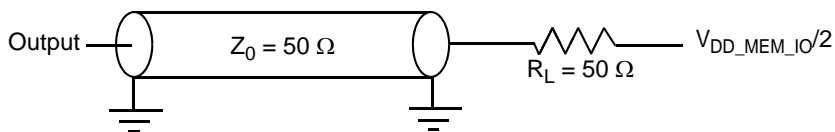


Figure 30. DDR AC test load

4.18.5.1 2.5 V DDR1

Table 60. SSTL_2 Class II 2.5 V DDR DC Specifications

| Symbol | C | Parameter | Condition | Min | Nom | Max | Units | Notes | SpecID |
|----------|---|---------------------------|-----------|-----------|------|-----------|-------|----------|--------|
| vddet | P | I/O Supply Voltage | — | 2.30 | 2.50 | 2.70 | V | JESD8-9B | A5.1 |
| vdd | P | Core Supply Voltage | — | 1.08 | 1.20 | 1.32 | V | — | A5.2 |
| Vref(dc) | P | Input Reference Voltage | — | 1.13 | 1.25 | 1.38 | V | JESD8-9B | A5.3 |
| Vtt | P | Termination Voltage | — | Vref-0.04 | vref | Vref+0.04 | V | JESD8-9B | A5.4 |
| Vih(dc) | C | DC Input Logic High | — | Vref+0.15 | — | vddet+0.3 | V | JESD8-9B | A5.5 |
| Vil(dc) | C | DC Input Logic Low | — | -0.3 | — | Vref-0.15 | V | JESD8-9B | A5.6 |
| Vih(ac) | C | AC Input Logic High | — | Vref+0.31 | — | — | V | JESD8-9B | A5.7 |
| Vil(ac) | C | AC Input Logic Low | — | — | — | Vref-0.31 | V | JESD8-9B | A5.8 |
| Iin | P | Pad input Leakage Current | — | — | — | +/-10 | μA | — | A5.9 |

Table 60. SSTL_2 Class II 2.5 V DDR DC Specifications (continued)

| Symbol | C | Parameter | Condition | Min | Nom | Max | Units | Notes | SpecID |
|--------------|---|------------------------------|------------------|--------------|-----|------|-------|------------------------------------|--------|
| V_{oh} | C | Output High Voltage Level | — | $vddet-0.35$ | — | — | V | — | A5.10 |
| V_{ol} | C | Output Low Voltage Level | — | — | — | 0.35 | V | | A5.11 |
| $I_{oh(dc)}$ | C | Output min source dc current | $V_{out}=V_{oh}$ | -16.2 | — | — | mA | $vddet = 2.3V$ $V_{oh} = 1.95V$ | A5.12 |
| $I_{ol(dc)}$ | C | Output min sink dc current | $V_{out}=V_{ol}$ | 16.2 | — | — | mA | $vddet = 2.3V$ $V_{ol} = 0.35V$ | A5.13 |

The SSTL_2 differential input switch point is at $v_{ref} = 0.50 * vddet$.

NOTE

The JEDEC SSTL_2 specifications (JESD8-9B) for a SSTL interface for class II operation supersedes any specification in this document.

The SSTL_2 Class II output with $ipp_sre[2:0]$ set to enabling SSTL_2 2.5V DDR1 mode, at the destination, have a rise/fall time (10%-90%) between 1 ns and 2 ns over process, voltage, and temperature driving a 70 ohm transmission line with 0.167 ns t_d terminated at the destination with 70 ohms to V_{tt} ($0.5 * vddet$) with 4.0 pf, representing the DDR input capacitance.

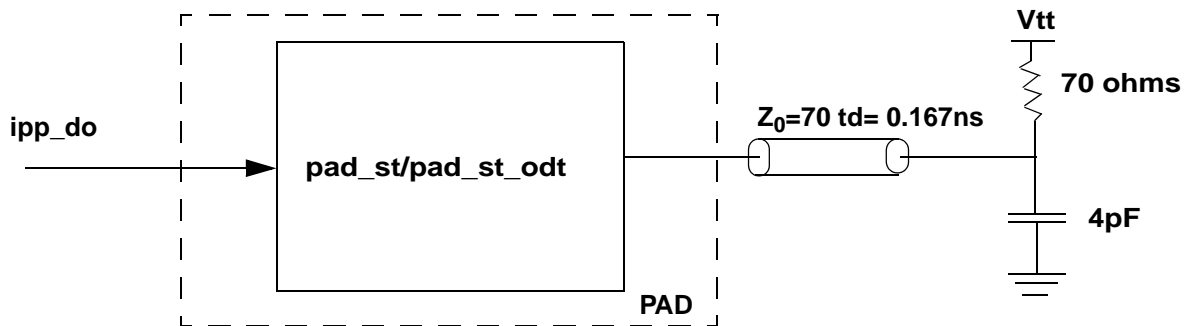


Figure 31. SSTL_2 CLASS II Test Load

4.18.5.2 1.8 V DDR2

Table 61. SSTL_18 Class II 1.8 V DDR2 DC Specifications

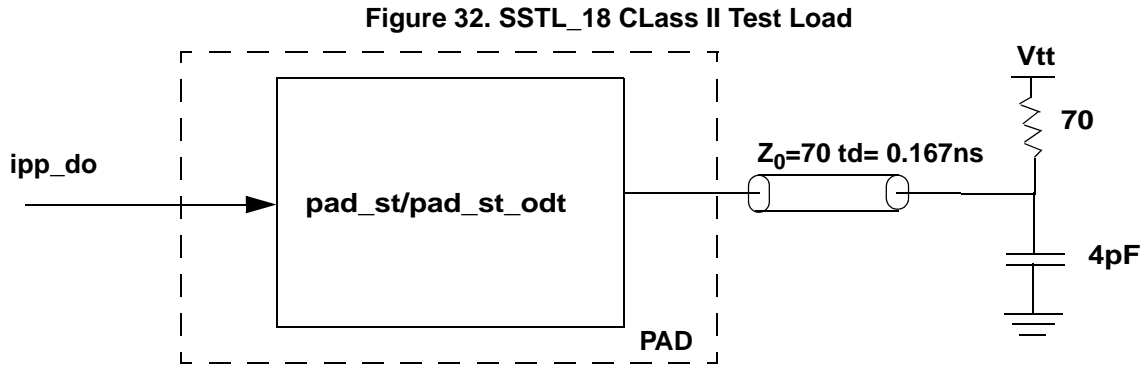
| Symbol | C | Parameter | Condition | Min | Nom | Max | Units | Notes | SpecID |
|---------------------|---|------------------------------|-----------|------------|------|------------|-------|--|--------|
| vddet | P | I/O Supply Voltage | — | 1.7 | 1.8 | 1.9 | V | JESD8-15A | A5.14 |
| vdd | P | Core Supply Voltage | — | 1.08 | 1.2 | 1.32 | V | | A5.15 |
| Vref(dc) | P | Input Reference Voltage | — | 0.833 | 0.9 | 1.0869 | V | JESD8-15A | A5.16 |
| Vtt | P | Termination Voltage | — | Vref-0.04 | Vref | Vref+0.04 | V | JESD8-15A | A5.17 |
| V _{ih(dc)} | C | DC Input Logic High | — | Vref+0.125 | — | vddet+0.3 | V | JESD8-15A | A5.18 |
| V _{il(dc)} | C | DC Input Logic Low | — | -0.3 | — | Vref-0.125 | V | JESD8-15A | A5.19 |
| V _{ih(ac)} | C | AC Input Logic High | — | Vref+0.25 | — | — | V | JESD8-15A | A5.20 |
| V _{il(ac)} | C | AC Input Logic Low | — | — | — | Vref-0.25 | V | JESD8-15A | A5.21 |
| I _{in} | T | Pad input Leakage Current | — | — | — | +/-10 | μA | — | A5.22 |
| V _{oh} | C | Output High Voltage Level | — | vddet-0.28 | — | — | V | — | A5.23 |
| V _{ol} | C | Output Low Voltage Level | — | — | — | 0.28 | V | — | A5.24 |
| I _{oh(dc)} | C | Output min source dc current | Vout=Voh | -13.4 | — | — | mA | JESD8-15A vddet = 1.7V Voh = 1.42V | A5.25 |
| I _{ol(dc)} | C | Output min sink dc current | Vout=Vol | 13.4 | — | — | mA | JESD8-15A vddet = 1.7V Vol = 0.28V | A5.26 |

The SSTL_18 differential input switch point is at $vref = 0.50 * vddet$.

Note that the Jedec SSTL_18 specifications (JESD8-15a) for a SSTL interface for class II operation supersedes any specification in this document.

The SSTL_18 Class II output with `ipp_sre[2:0]` set to enabling `sstl_2` 1.8V DDR2 mode, at the destination, have a rise/fall time (10%-90%) between 0.4 ns and 1.0 ns over process, voltage, and temperature driving a 70 ohm transmission line with 0.167 ns

td terminated at the destination with 70 ohms to Vtt (0.5*vddet) with 4.0 pf, representing the DDR2 input capacitance. See (Figure 32. "SSTL_18 CClass II Test Load").



4.18.5.3 1.8V LPDDR

Table 62. 1.8V LPDDR DC Specifications

| Symbol | C | Parameter | Condition | Min | Nom | Max | Units | Notes | SpecID |
|---------------------------|---|---------------------------|-------------------------|-----------|-----|-----------|-------|----------|--------|
| vddet | P | I/O Supply Voltage | — | 1.7 | 1.8 | 1.9 | V | JESD79-4 | A5.27 |
| vdd | P | Core Supply Voltage | — | 1.08 | 1.2 | 1.32 | V | — | A5.28 |
| Data Inputs (DQ, DM, DQS) | | | | | | | | | A5.29 |
| V _{ih(dc)} | C | DC Input Logic High | — | vddet*0.7 | — | vddet+0.3 | V | JESD79-4 | A5.30 |
| V _{il(dc)} | C | DC Input Logic Low | — | -0.3 | — | vddet*0.3 | V | JESD79-4 | A5.31 |
| V _{ih(ac)} | C | AC Input Logic High | — | vddet*0.8 | — | vddet+0.3 | V | JESD79-4 | A5.32 |
| V _{il(ac)} | C | AC Input Logic low | — | -0.3 | — | vddet*0.2 | V | JESD79-4 | A5.33 |
| Data Outputs (DQ, DQS) | | | | | | | | | A5.34 |
| V _{oh} | C | Output High Voltage Level | I _{oh} =-0.1mA | vddet*0.9 | — | — | V | JESD79-4 | A5.35 |
| V _{ol} | C | Output Low Voltage Level | I _{ol} =0.1mA | — | — | vddet*0.1 | V | JESD79-4 | A5.36 |

Note that the final JEDEC LPDDR SDRAM specifications (JESD79-4) for LPDDR operation supersedes any specification in this document.

The SSTL_18 output with ipp_sre[2:0] set to enabling 1.8V LPDDR mode, at the destination, have a rise/fall time (10%-90%) between 0.4 ns and 1.0 ns over process, voltage, and temperature driving a 70 ohm transmission line with 0.167 ns td terminated at the destination with 70 ohms to Vtt (0.5*vddet) with 4.0 pf, representing the DDR input capacitance. See Figure 27.

4.18.6 Video Input Unit timing

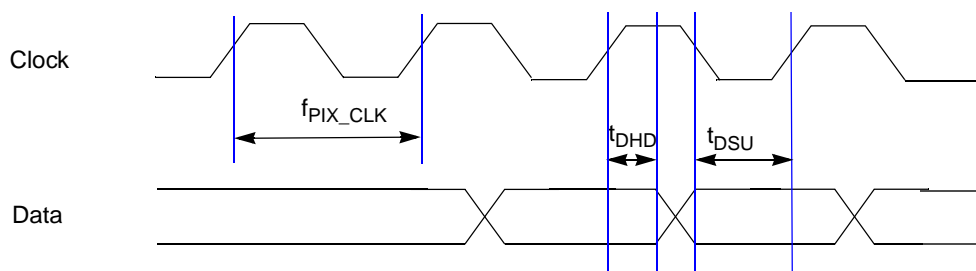


Figure 33. VIU2 timing diagram

Table 63. VIU2 timing parameters

| Parameter | C | Description | Min | Typ | Max | Unit | SpecID |
|---------------|---|----------------------------|-----|-----|-----|------|--------|
| f_{PIX_CK} | D | VIU2 pixel clock frequency | — | — | 64 | MHz | A6.1 |
| t_{DSU} | D | VIU2 data setup time | 4 | — | — | ns | A6.2 |
| t_{DHD} | D | VIU2 data hold time | 1 | — | — | ns | A6.3 |

4.18.7 External Interrupt (IRQ) and Non-Maskable Interrupt (NMI) Timing

Table 64. IRQ and NMI Timing

| Num | Symbol | C | Characteristic | Min. Value | Max. Value | Unit | SpecID | |
|-----|------------|-----------------|----------------|--|------------|------|--------|------|
| 1 | t_{IPWL} | CC ¹ | D | IRQ/NMI Pulse Width Low | 200 | — | ns | A7.1 |
| 2 | t_{IPWH} | CC ¹ | D | IRQ/NMI Pulse Width High | 200 | — | ns | A7.2 |
| 3 | t_{ICYC} | CC ¹ | D | IRQ/NMI Edge to Edge Time ² | 400 | — | ns | A7.3 |

¹ Parameter values guaranteed by design.

² Applies when IRQ/NMI pins are configured for rising edge or falling edge events, but not both.

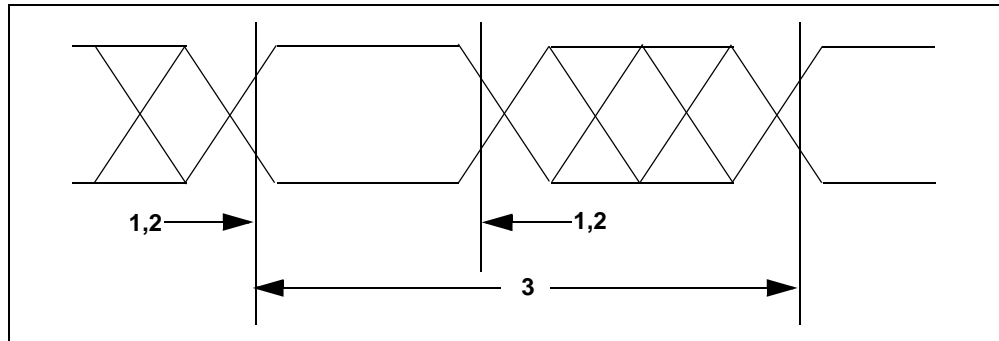


Figure 34. IRQ and NMI Timing

4.18.8 eMIOS timing

Table 65. eMIOS timing¹

| Num | Symbol | C | Characteristic | Min. value ² | Max. value | Unit | SpecID | |
|-----|------------|-----------------|----------------|--------------------------|------------|------|-----------|------|
| 1 | t_{MIPW} | CC ³ | D | eMIOS Input Pulse Width | 4 | — | t_{CYC} | A8.1 |
| 2 | t_{MOPW} | CC ³ | D | eMIOS Output Pulse Width | 1 | — | t_{CYC} | A8.2 |

¹ eMIOS timing specified at $f_{SYS} = 64$ MHz, $V_{DD12} = 1.14$ V to 1.32 V, $V_{DDE_x} = 3.0$ V to 5.5 V, $T_A = -40$ to 105 °C, and $CL = 50$ pF with $SRC = 0b00$.

² There is no limitation on the peripheral for setting the minimum pulse width, the actual width is restricted by the pad delays. Refer to the pad specification section for the details.

³ Parameter values guaranteed by design.

4.18.9 FlexCAN timing

The CAN functions are available as TX pins at normal IO pads and as RX pins at the always on domain. There is no filter for the wakeup dominant pulse. Any high-to-low edge can cause wakeup if configured.

Table 66. FlexCAN timing¹

| Num | Symbol | C | Characteristic | Min. value | Max. value | Unit | SpecID |
|-----|--------------------|-----------------|---|------------|------------|------|--------|
| 1 | t _{CANOV} | CC ² | D CTNX Output Valid after CLKOUT Rising Edge (Output Delay) | — | 22.48 | ns | A10.1 |
| 2 | t _{CANSU} | CC ² | D CNRX Input Valid to CLKOUT Rising Edge (Setup Time) | — | 12.46 | ns | A10.2 |

¹ FlexCAN timing specified at f_{SYS} = 64 MHz, V_{DD12} = 1.14 V to 1.32 V, VDDE_x = 3.0 V to 5.5 V, T_A = -40 to 105 °C, and CL = 50 pF with SRC = 0b00.

² Parameter values guaranteed by design.

4.18.10 Deserial Serial Peripheral Interface (DSPI)

Table 67. DSPI Timing¹

| Num | Symbol | CC ² | C | Characteristic | Min | Max | Unit | SpecID |
|-----|------------------|-----------------|---|---|-----------------------------|------------------------------|----------------------|--------|
| 1 | t _{SCK} | CC ² | D | SCK Cycle Time ^{3,4} | 60 ⁵ | — | ns | A11.1 |
| 2 | t _{CSC} | CC ² | D | PCS to SCK Delay ⁶ | - | — | ns | A11.2 |
| 3 | t _{ASC} | CC ² | D | After SCK Delay ⁷ | 20 | — | ns | A11.3 |
| 4 | t _{SDC} | CC ² | D | SCK Duty Cycle | t _{SCK} /2 -2ns | t _{SCK} /2 + 2ns | ns | A11.4 |
| 5 | t _A | CC ² | D | Slave Access Time (PCSx active to SOUT driven) | — | 25 | ns | A11.5 |
| 6 | t _{DIS} | CC ² | D | Slave SOUT Disable Time (PCSx inactive to SOUT High-Z or invalid) | — | 25 | ns | A11.6 |
| 7 | t _{SUI} | CC ² | D | Data Setup Time for Inputs Master (MTFE = 0) Slave Master (MTFE = 1, CPHA = 0) ⁸ Master (MTFE = 1, CPHA = 1) | 20 10 5 35 | — — — — | ns ns ns ns | A11.7 |
| 8 | t _{HI} | CC ² | D | Data Hold Time for Inputs Master (MTFE = 0) Slave Master (MTFE = 1, CPHA = 0) ⁸ Master (MTFE = 1, CPHA = 1) | -4 10 26 -4 | — — — — | ns ns ns ns | A11.8 |
| 9 | t _{SUO} | CC ² | D | Data Valid (after SCK edge) Master (MTFE = 0) Slave Master (MTFE = 1, CPHA=0) Master (MTFE = 1, CPHA=1) | — — — — | 15 20 30 15 | ns ns ns ns | A11.9 |
| 10 | t _{HO} | CC ² | D | Data Hold Time for Outputs Master (MTFE = 0) Slave Master (MTFE = 1, CPHA = 0) Master (MTFE = 1, CPHA = 1) | -15 5.5 0 -15 | — — — — | ns ns ns ns | A11.10 |

¹ DSPI timing specified at VDDE_x = 3.0 V to 3.6 V, T_A = -40 to 105 °C, and CL = 50 pF with SRC = 0b10.

² Parameter values guaranteed by design.

³ The minimum SCK Cycle Time restricts the baud rate selection for given system clock rate.

⁴ The actual minimum SCK Cycle Time is limited by pad performance.

⁵ Maximum clock possible is System clock/2.

⁶ The maximum value is programmable in DSPI_CTARx[PSSCK] and DSPI_CTARx[CSSCK], program PSSCK=2 & CSSCK = 2.

⁷ The maximum value is programmable in DSPI_CTARx[PASC] and DSPI_CTARx[ASC].

⁸ This delay value is corresponding to SMPL_PT=00b which is bit field 9 and 8 of DSPI_MCR register.

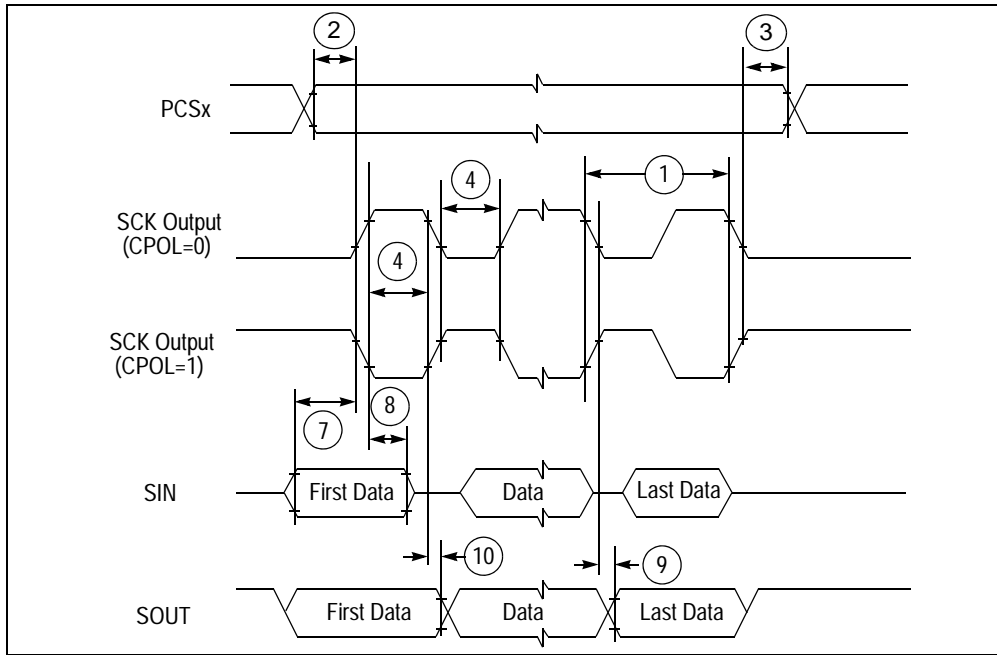


Figure 35. DSPI Classic SPI Timing — Master, CPHA = 0

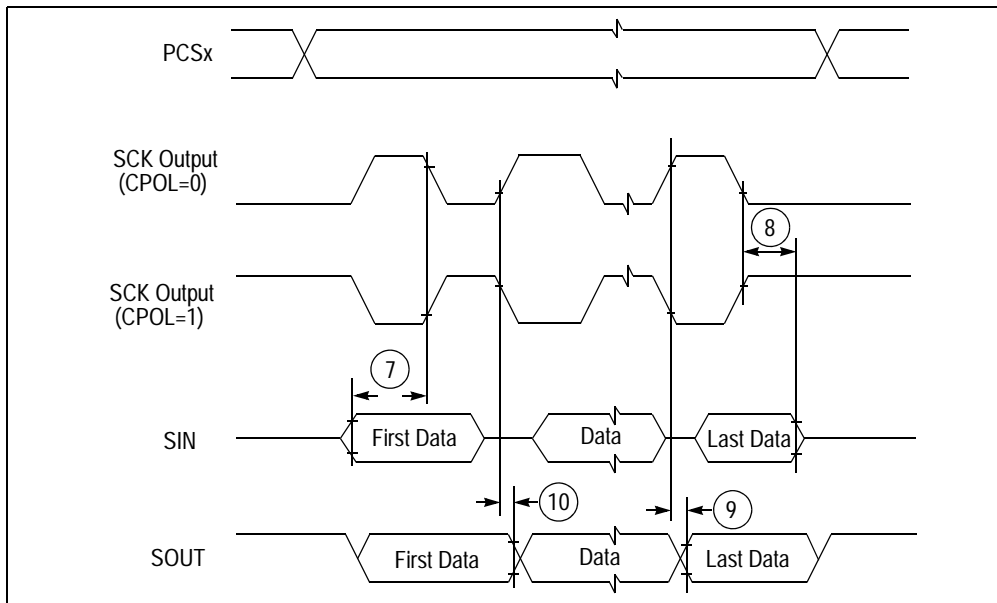


Figure 36. DSPI Classic SPI Timing — Master, CPHA = 1

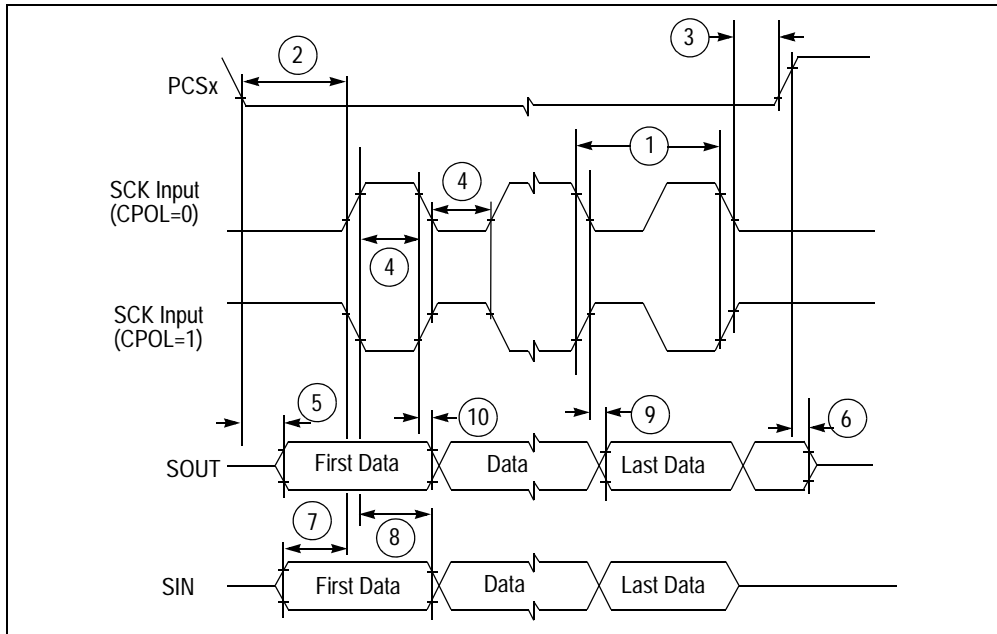


Figure 37. DSPI Classic SPI Timing — Slave, CPHA = 0

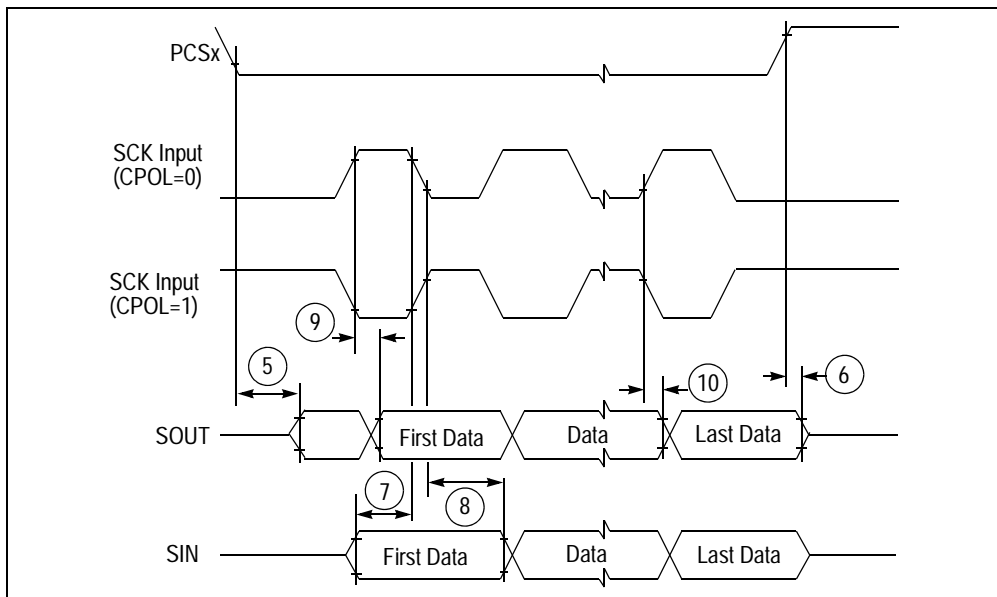


Figure 38. DSPI Classic SPI Timing — Slave, CPHA = 1

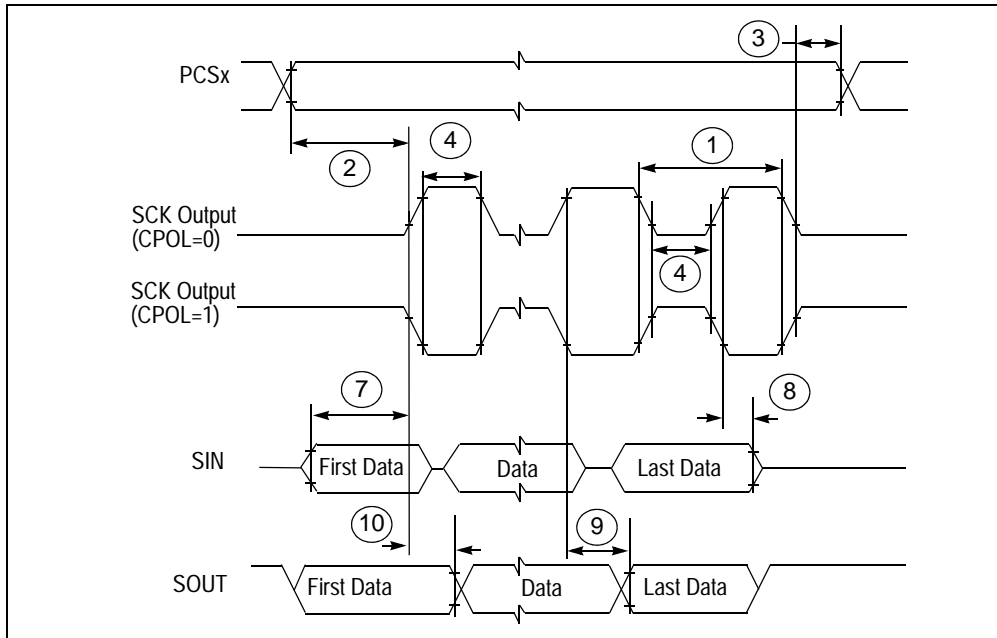


Figure 39. DSPI Modified Transfer Format Timing — Master, CPHA = 0

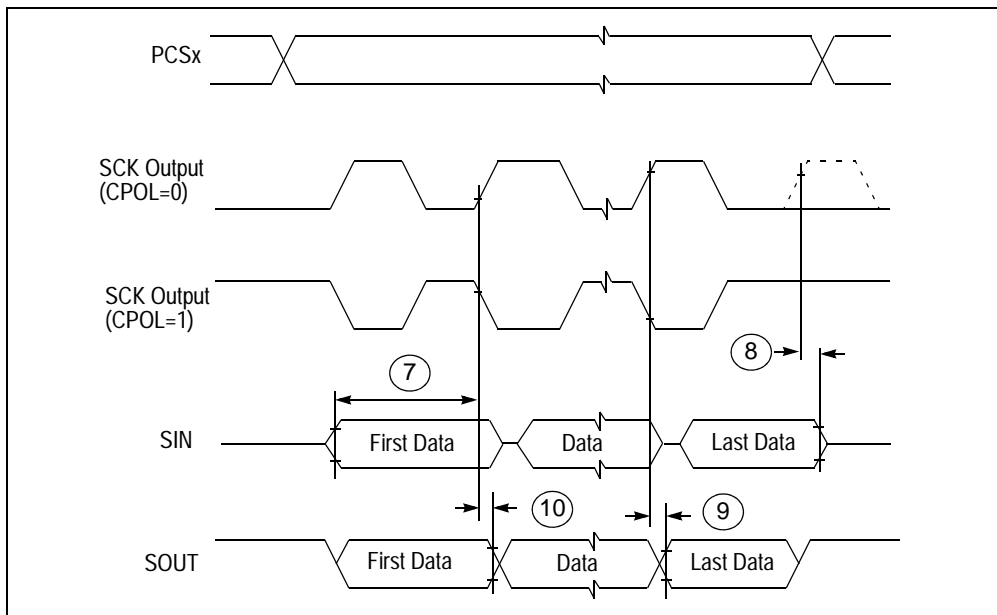


Figure 40. DSPI Modified Transfer Format Timing — Master, CPHA = 1

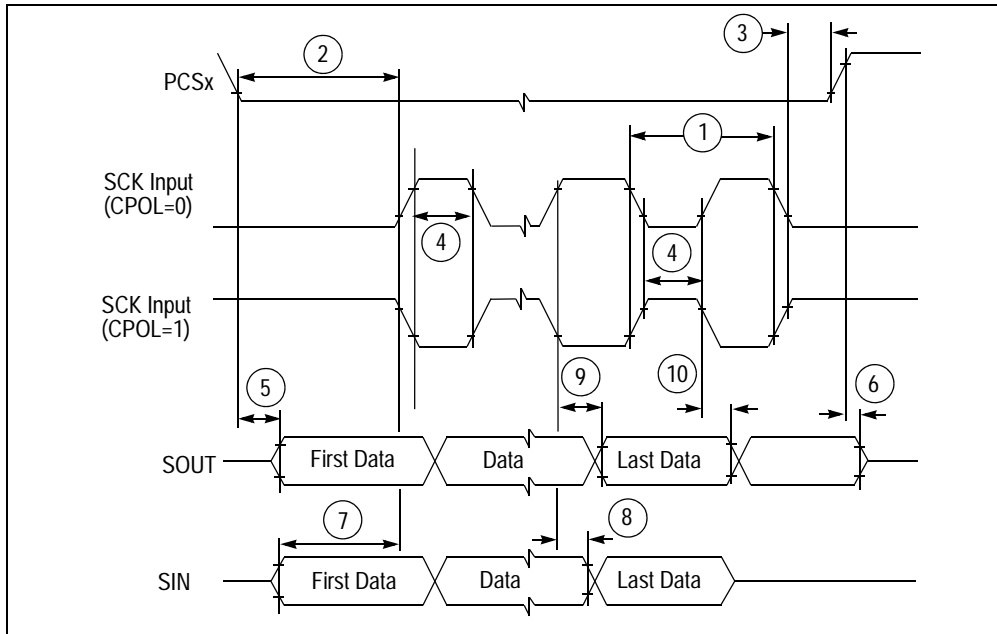


Figure 41. DSPI Modified Transfer Format Timing — Slave, CPHA = 0

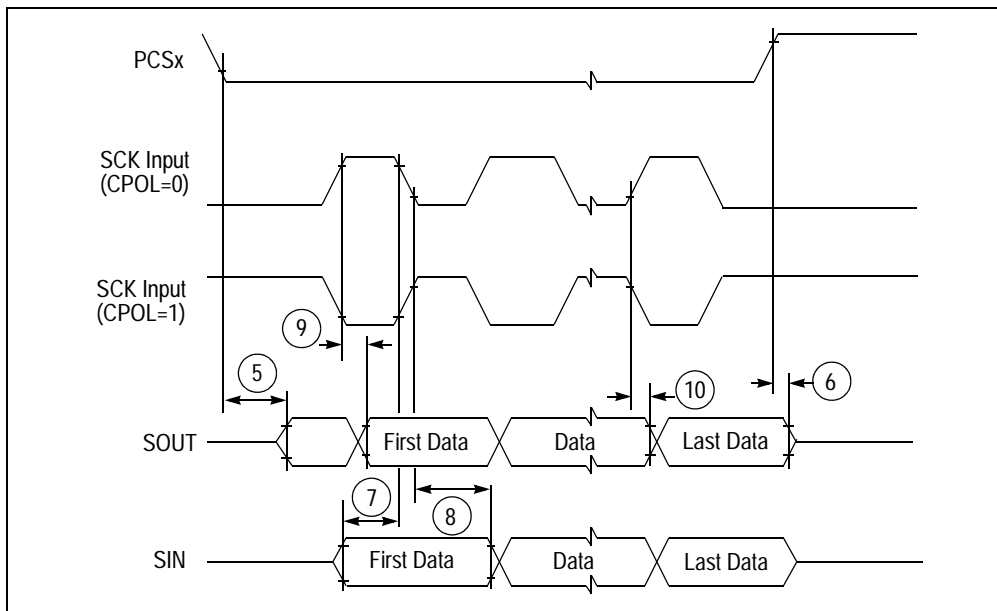


Figure 42. DSPI Modified Transfer Format Timing — Slave, CPHA = 1

4.18.11 I²C timing

Table 68. I²C Input Timing Specifications—SCL and SDA

| Num | Symbol | C | Characteristic | Min. Value | Max. Value | Unit | SpecID |
|-----|--------|-----------------|--|------------|------------|---------------------------|--------|
| 1 | — | CC ¹ | D Start condition hold time | 2 | — | IP-Bus Cycle ² | A12.1 |
| 2 | — | CC ¹ | D Clock low time | 8 | — | IP-Bus Cycle ² | A12.2 |
| 4 | — | CC ¹ | D Data hold time | 0.0 | — | ns | A12.3 |
| 6 | — | CC ¹ | D Clock high time | 4 | — | IP-Bus Cycle ² | A12.4 |
| 7 | — | CC ¹ | D Data setup time | 0.0 | — | ns | A12.5 |
| 8 | — | CC ¹ | D Start condition setup time (for repeated start condition only) | 2 | — | IP-Bus Cycle ² | A12.6 |
| 9 | — | CC ¹ | D Stop condition setup time | 2 | — | IP-Bus Cycle ² | A12.7 |

¹ Parameter values guaranteed by design.

² Inter Peripheral Clock is the clock at which the I²C peripheral is working in the device.

Table 69. I²C Output Timing Specifications—SCL and SDA

| Num | Symbol | C | Characteristic | Min. Value | Max. Value | Unit | SpecID |
|----------------|--------|-----------------|--|------------|------------|---------------------------|--------|
| 1 ¹ | — | CC ² | D Start condition hold time | 6 | — | IP-Bus Cycle ³ | A12.8 |
| 2 ¹ | — | CC ² | D Clock low time | 10 | — | IP-Bus Cycle ² | A12.9 |
| 3 ⁴ | — | CC ² | D SCL/SDA rise time | — | 99.6 | ns | A12.10 |
| 4 ¹ | — | CC ² | D Data hold time | 7 | — | IP-Bus Cycle ² | A12.11 |
| 5 ¹ | — | CC ² | D SCL/SDA fall time | — | 99.5 | ns | A12.12 |
| 6 ¹ | — | CC ² | D Clock high time | 10 | — | IP-Bus Cycle ² | A12.13 |
| 7 ¹ | — | CC ² | D Data setup time | 2 | — | IP-Bus Cycle ² | A12.14 |
| 8 ¹ | — | CC ² | D Start condition setup time (for repeated start condition only) | 20 | — | IP-Bus Cycle ² | A12.15 |
| 9 ¹ | — | CC ² | D Stop condition setup time | 10 | — | IP-Bus Cycle ² | A12.16 |

¹ Programming IBFD (I²C bus Frequency Divider) with the maximum frequency results in the minimum output timings listed. The I²C interface is designed to scale the data transition time, moving it to the middle of the SCL low period. The actual position is affected by the prescale and division values programmed in IFDR.

² Parameter values guaranteed by design.

³ Inter Peripheral Clock is the clock at which the I²C peripheral is working in the device.

⁴ Because SCL and SDA are open-drain-type outputs, which the processor can only actively drive low, the time SCL or SDA takes to reach a high level depends on external signal capacitance and pull-up resistor values.

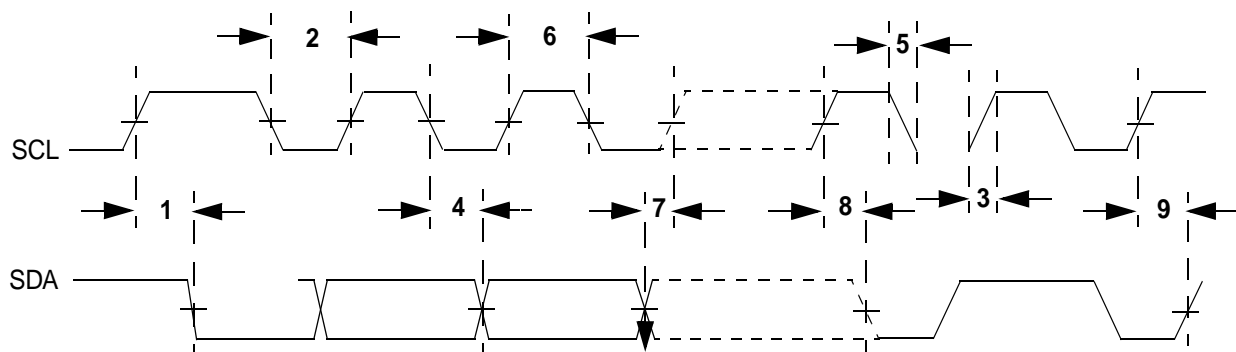


Figure 43. I²C Input/Output Timing

4.18.12 QuadSPI timing

The following notes apply to [Table 70](#) and [Table 71](#):

- All data is based on a negative edge data launch from MPC5645S and a positive edge data capture, as shown in the timing diagrams in this section.
- The supply conditions, over a temperature range of -45 °C to 125 °C/140 °C, are as follows:
 - IO voltage: 3.0 V, Core supply: 1.2 V
 - IO voltage: 3.3 V, Core supply: 1.2 V
 - IO voltage: 3.6 V, Core supply: 1.2 V
- The actual frequency at which the device can work will be a combination of this data and the clock pad profile.
- All measurements are considering 70% of VDDE levels for clock pin and 50% of VDDE level for data pins.
- Timings assume a setting of 0x0000_000x for QSPI_SMPR register (see the reference manual for details).
- A negative value of hold is an indication of pad delay on the clock pad (delay b/w actual edge capturing data in the device vs. edge appearing at the pin).
- Measurements are with a load of 50 pF on output pins
- The clock profile is measured at 30% to 70% levels of VDDE.

Table 70. QuadSPI timing specifications, maximum temperature 125 °C

| Symbol | C | Parameter | Value | | | Unit | SpecID |
|--------|----|-----------|-------|------|------|------|--------|
| | | | Min | Typ | Max | | |
| Tcq | CC | T | 3.8 | 5.3 | 12.1 | ns | A13.1 |
| Ts | CC | T | 7.6 | 9 | 13.2 | ns | A13.2 |
| Th | CC | T | -13 | -8.5 | -7.5 | ns | A13.3 |
| tr | CC | T | 0.5 | 0.7 | 1.0 | ns | A13.4 |
| tf | CC | T | 0.8 | 0.8 | 1.2 | ns | A13.5 |

The numbers in [Figure 44](#) and [Figure 45](#) correspond to events as described in [Table 71](#).

Table 71. QuadSPI timing events

| Number | Event |
|--------|--|
| 1 | Last address out |
| 2 | Address captured at flash memory |
| 3 | Data out from flash memory |
| 4 | Ideal data capture edge |
| 5 | Delayed data capture edge with QSPI_SMPR=0x0000_000X |
| 6 | Delayed data capture edge with QSPI_SMPR=0x0000_002X |
| 7 | Delayed data capture edge with QSPI_SMPR=0x0000_004X |
| 8 | Delayed data capture edge with QSPI_SMPR=0x0000_006X |

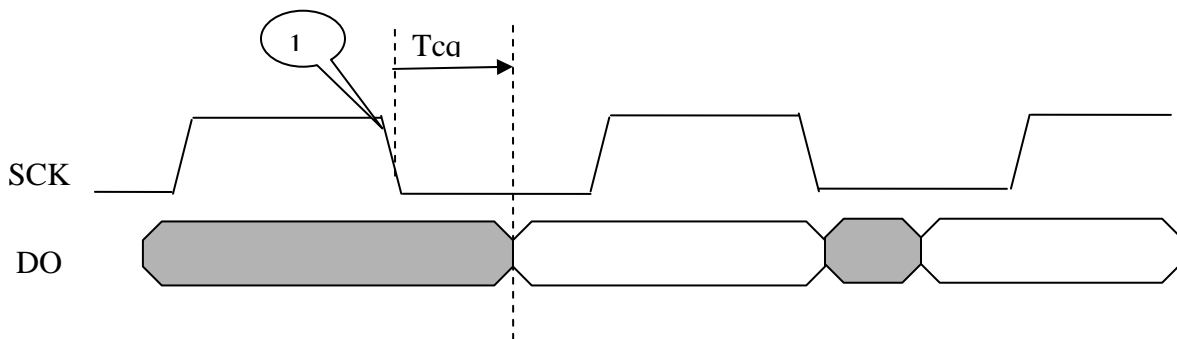
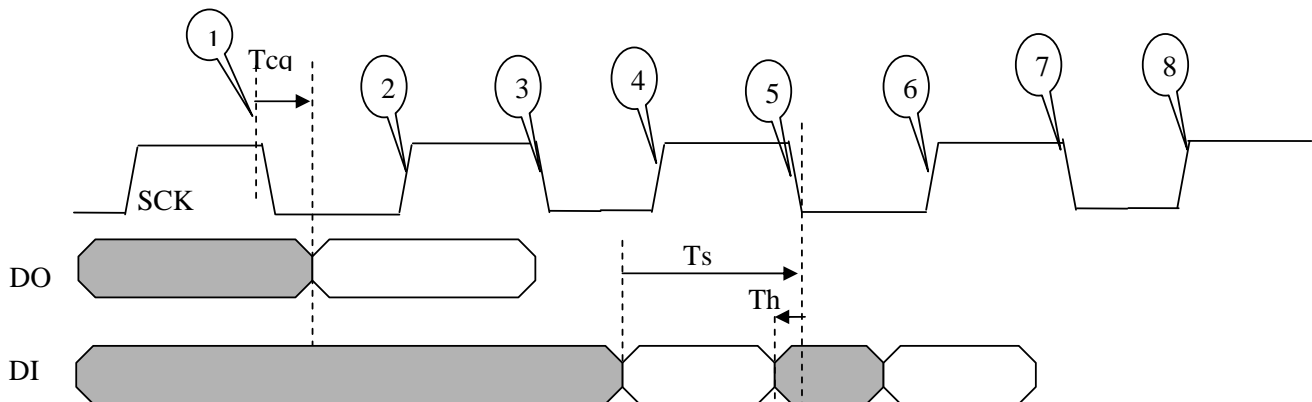
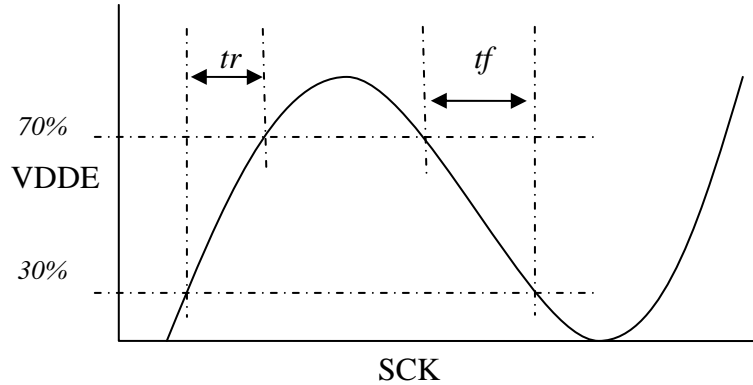


Figure 44. QuadSPI output timing



Note: T_s and T_h correspond to QSPI_SMPR = 0x0000_000X.

Figure 45. QuadSPI input timing



Note: t_r and t_f measured at 30% and 70% of VDDE

Figure 46. QuadSPI clock profile

4.18.13 TCON/RSDS timing

The following notes apply to [Table 72](#):

- Measurement condition: $v_{dde}/v_{dd33} = 3.3\text{ V} \pm 10\%$, $v_{dd} = 1.2\text{ V} \pm 10\%$, $v_{ss}/v_{sse} = 0\text{ V}$, $T = -40\text{--}140\text{ }^\circ\text{C}$
- Termination: $100\ \Omega \pm 5\%$
- VREFH_RSDS terminations of $47\ \mu\text{F}$

Table 72. TCON/RSDS timing

| Symbol | C | Parameter | Condition | Value | | | Unit | SpecID | |
|----------------------|----|-----------|-----------------------------------|--|------|------|------|---------------|-------|
| | | | | Min | Typ | Max | | | |
| V_{OD} | CC | C | Differential output voltage | RSDS mode | 391 | — | 471 | mV | A14.1 |
| V_{OS} | CC | C | Common mode voltage | 100 Ω termination between Pad_p and Pad_n | 1.17 | — | 1.4 | V | A14.2 |
| t_r | CC | C | Rise time | Transition from 20% to 80% | 606 | — | 844 | ps | A14.3 |
| t_f | CC | C | Fall time | Transition from 20% to 80% | 607 | — | 842 | ps | A14.4 |
| t_{plh} | CC | D | Propagation delay, low to high | — | — | 2.65 | — | ns | A14.5 |
| t_{phl} | CC | D | Propagation delay, high to low | — | — | 2.47 | — | ns | A14.6 |
| t_{dz} | CC | D | Start-up time | — | — | 200 | — | μs | A14.7 |
| $t_{skew}^{1\ 2\ 3}$ | CC | C | Skew between different RSDS lines | Max and min skew between clock and data pads | — | — | — | ps | A14.8 |

¹ There are eight programmable bits to provide 256 different skew numbers with various combinations of these bits.

² Default value of all the eight skew options are all "1".

³ All "0" combination of eight bits is not valid.

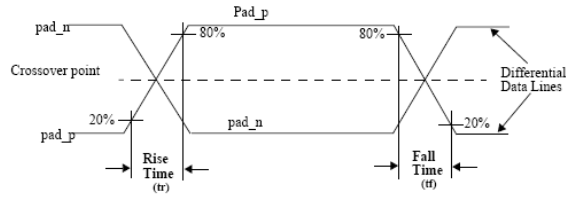


Figure 47. Rise/fall transition, part 1

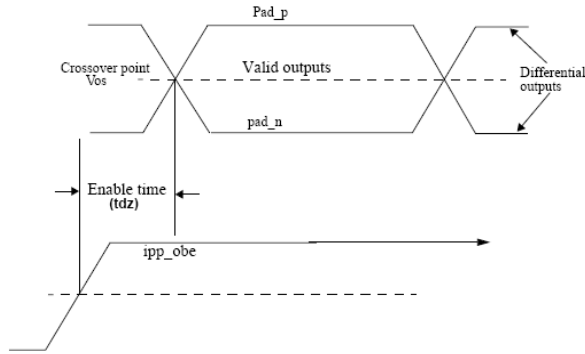


Figure 48. Rise/fall transition, part 2

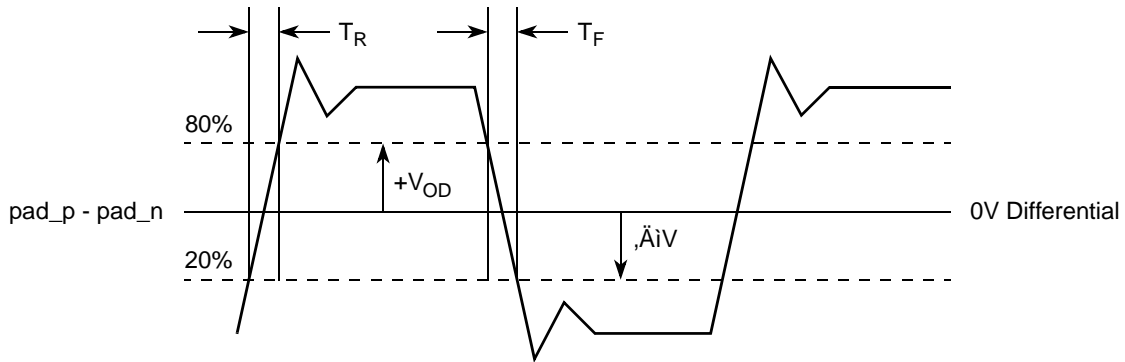
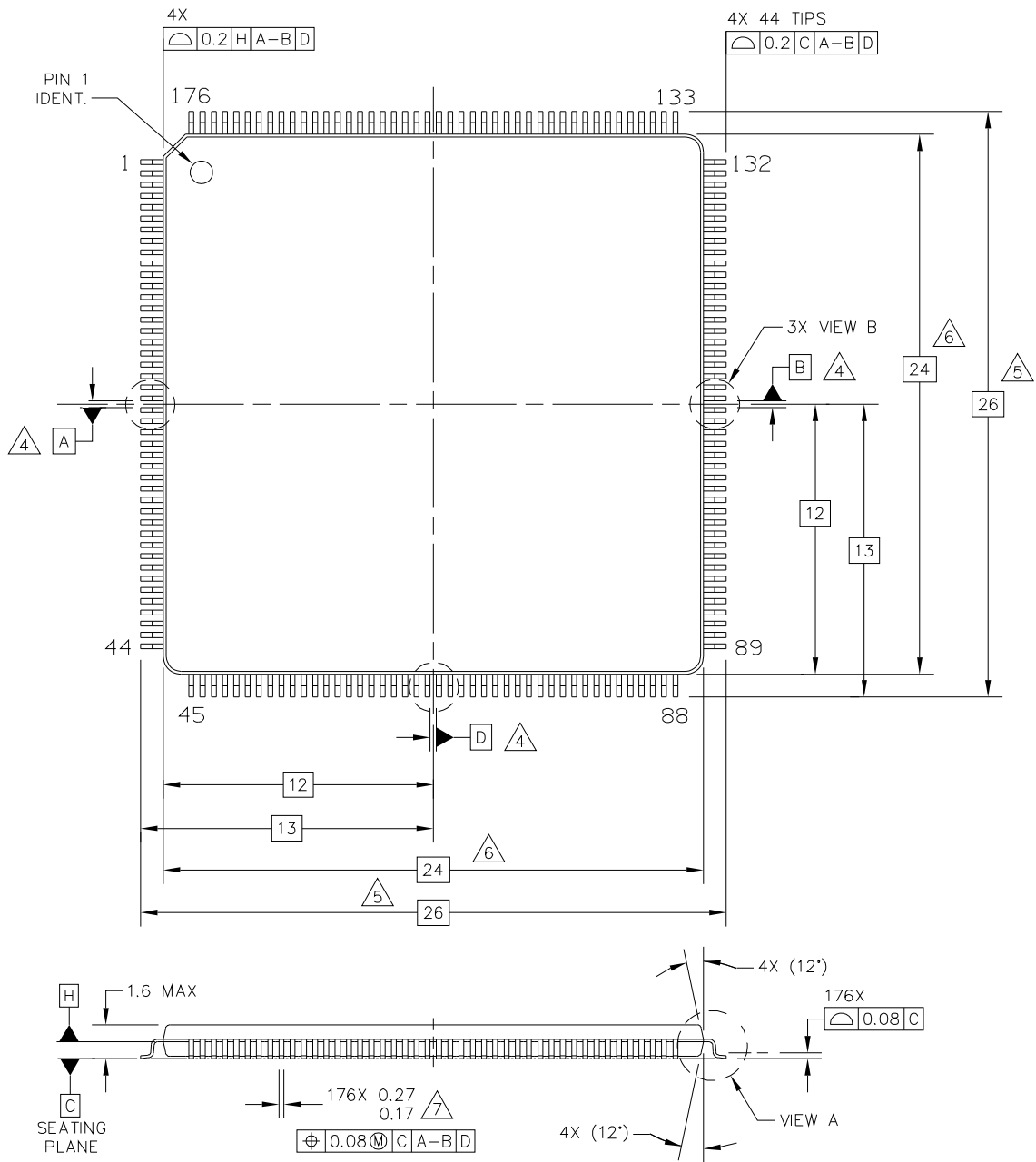


Figure 49. Illustration of t_r , t_f , and V_{OD}

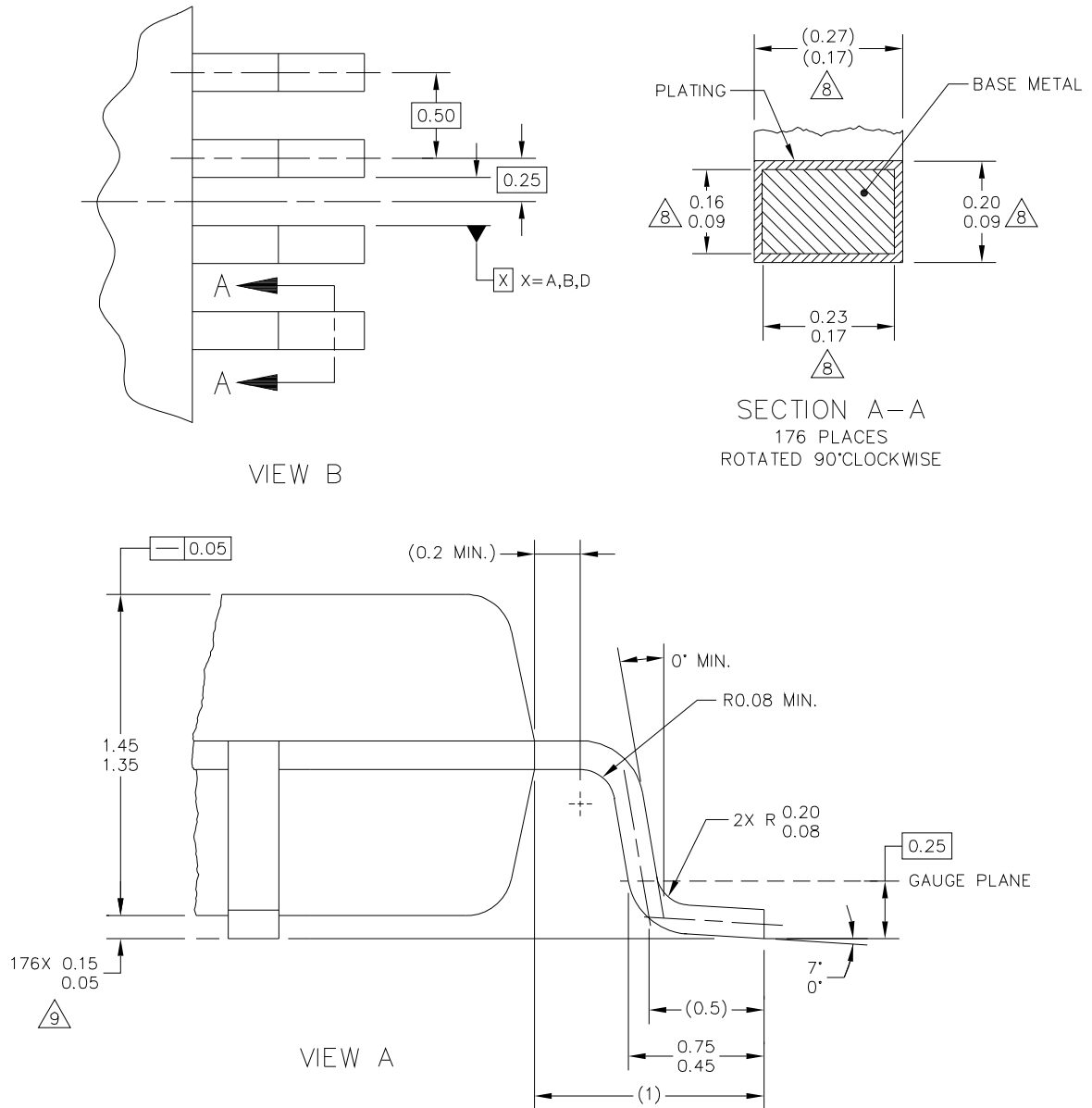
5 Package mechanical data

5.1 176 LQFP



| | | | |
|---|--------------------|----------------------------|-------------|
| © FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED. | MECHANICAL OUTLINE | PRINT VERSION NOT TO SCALE | |
| TITLE: 176 LD LQFP, 24 X 24 PKG, 0.5 PITCH, 1.4 THICK | | DOCUMENT NO: 98ASS23479W | REV: C |
| | | CASE NUMBER: 1101-02 | 29 SEP 2009 |
| | | STANDARD: JEDEC MS-026 BGA | |

Figure 50. LQFP176 Mechanical Drawing (Part 1 of 3)



| | | | |
|---|----------------------------|----------------------------|-------------|
| © FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED. | MECHANICAL OUTLINE | PRINT VERSION NOT TO SCALE | |
| TITLE: 176 LD LQFP, 24 X 24 PKG, 0.5 PITCH, 1.4 THICK | DOCUMENT NO: 98ASS23479W | | REV: C |
| | CASE NUMBER: 1101-02 | | 29 SEP 2009 |
| | STANDARD: JEDEC MS-026 BGA | | |

Figure 51. LQFP176 Mechanical Drawing (Part 2 of 3)

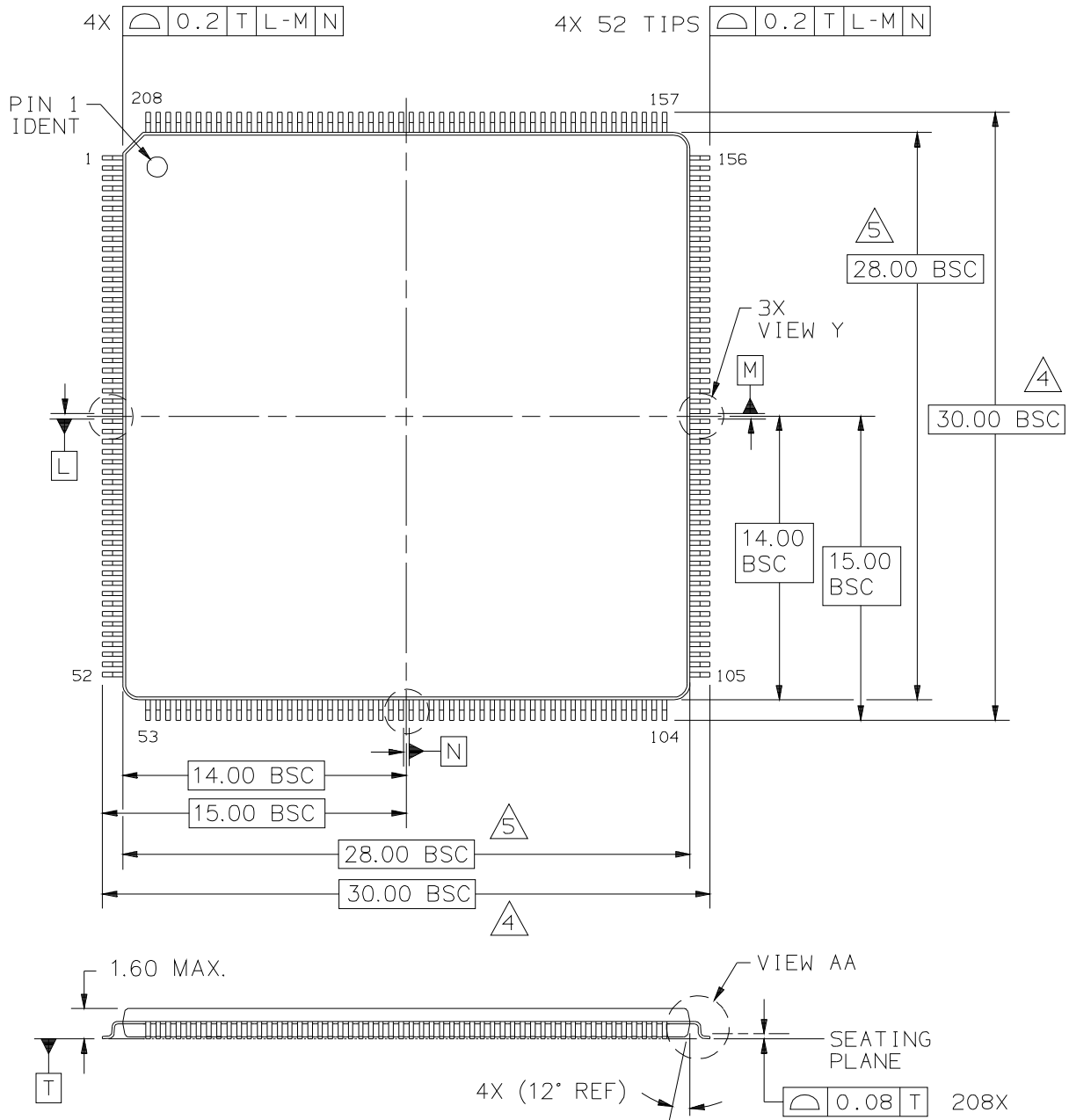
NOTES:

1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M-1994.
2. DIMENSIONS IN MILLIMETERS.
3. DATUM PLANE H IS LOCATED AT BOTTOM OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE BOTTOM OF THE PARTING LINE.
4. DATUMS A, B AND D TO BE DETERMINED AT DATUM PLANE H.
5. THIS DIMENSIONS TO BE DETERMINED AT SEATING PLANE, DATUM C.
6. THIS DIMENSIONS DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.25 PER SIDE. THIS DIMENSIONS INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.
7. THIS DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. DAMBAR PROTRUSION SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED 0.35. MINIMUM SPACE BETWEEN PROTRUSION AND ADJACENT LEAD 0.07.
8. THESE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.1 MM AND 0.25 MM FROM THE LEAD TIP.
9. DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

| | | | |
|---|----------------------------|----------------------------|--|
| © FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED. | MECHANICAL OUTLINE | PRINT VERSION NOT TO SCALE | |
| TITLE: 176 LD LQFP, 24 X 24 PKG, 0.5 PITCH, 1.4 THICK | DOCUMENT NO: 98ASS23479W | REV: C | |
| | CASE NUMBER: 1101-02 | 29 SEP 2009 | |
| | STANDARD: JEDEC MS-026 BGA | | |

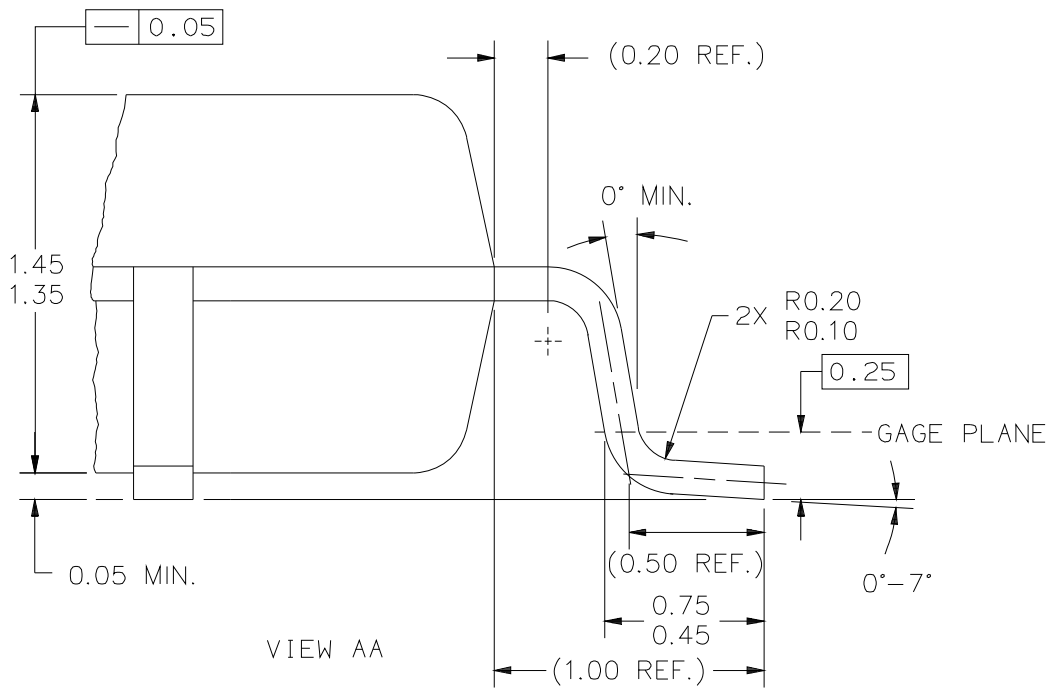
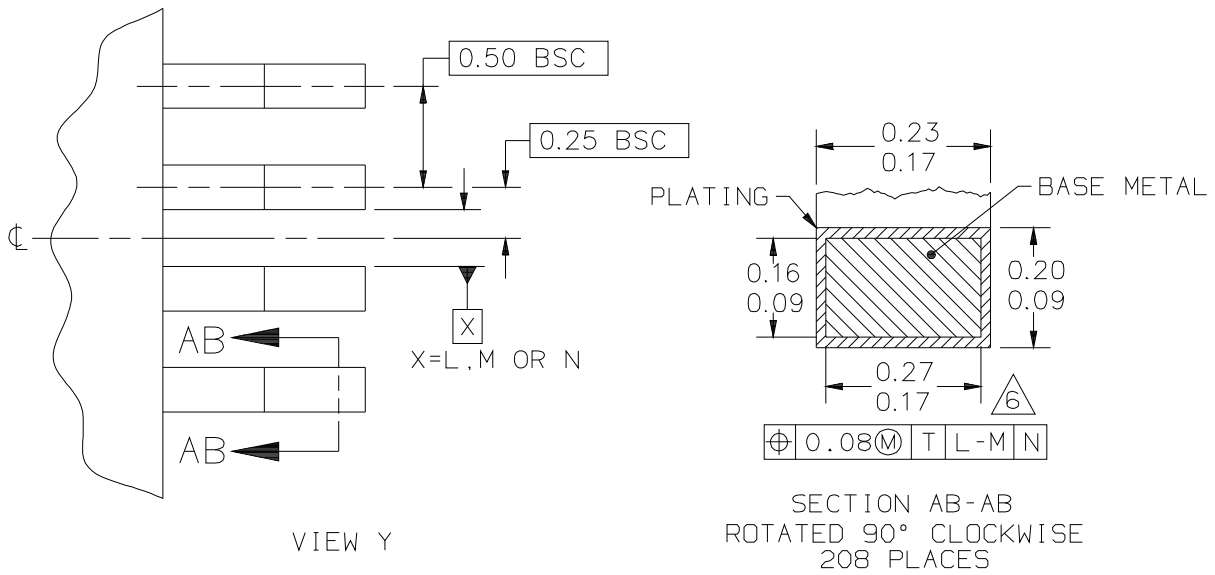
Figure 52. LQFP176 Mechanical Drawing (Part 3 of 3)

5.2 208 LQFP



| | | | |
|--|----------------------------|----------------------------|--|
| © FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED. | MECHANICAL OUTLINE | PRINT VERSION NOT TO SCALE | |
| TITLE: 208 LD TQFP, 28 X 28 PKG, 0.50 PITCH, 1.4 THICK | DOCUMENT NO: 98ASS23458W | REV: C | |
| | CASE NUMBER: 998-01 | 20 MAY 2005 | |
| | STANDARD: JEDEC MS-026 BJB | | |

Figure 53. LQFP208 Mechanical Drawing (Part 1 of 3)



| | | | |
|--|----------------------------|----------------------------|--|
| © FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED. | MECHANICAL OUTLINE | PRINT VERSION NOT TO SCALE | |
| TITLE: 208 LD TQFP, 28 X 28 PKG, 0.50 PITCH, 1.4 THICK | DOCUMENT NO: 98ASS23458W | REV: C | |
| | CASE NUMBER: 998-01 | 20 MAY 2005 | |
| | STANDARD: JEDEC MS-026 BJB | | |

Figure 54. LQFP208 Mechanical Drawing (Part 2 of 3)

NOTES

1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M-1994.
2. DIMENSIONS IN MILLIMETERS.
3. DATUMS L, M AND N TO BE DETERMINED AT THE SEATING PLANE, DATUM T.
4. DIMENSIONS TO BE DETERMINED AT SEATING PLANE, DATUM T.
5. DIMENSIONS DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.25 PER SIDE. DIMENSIONS INCLUDE MOLD MISMATCH.
6. DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. DAMBAR PROTRUSION SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED 0.35. MINIMUM SPACE BETWEEN PROTRUSION AND ADJACENT LEAD 0.07.

| | | | |
|--|----------------------------|----------------------------|--|
| © FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED. | MECHANICAL OUTLINE | PRINT VERSION NOT TO SCALE | |
| TITLE: 208 LD TQFP, 28 X 28 PKG, 0.50 PITCH, 1.4 THICK | DOCUMENT NO: 98ASS23458W | REV: C | |
| | CASE NUMBER: 998-01 | 20 MAY 2005 | |
| | STANDARD: JEDEC MS-026 BJB | | |

Figure 55. LQFP208 Mechanical Drawing (Part 3 of 3)

5.3 416 TEPBGA

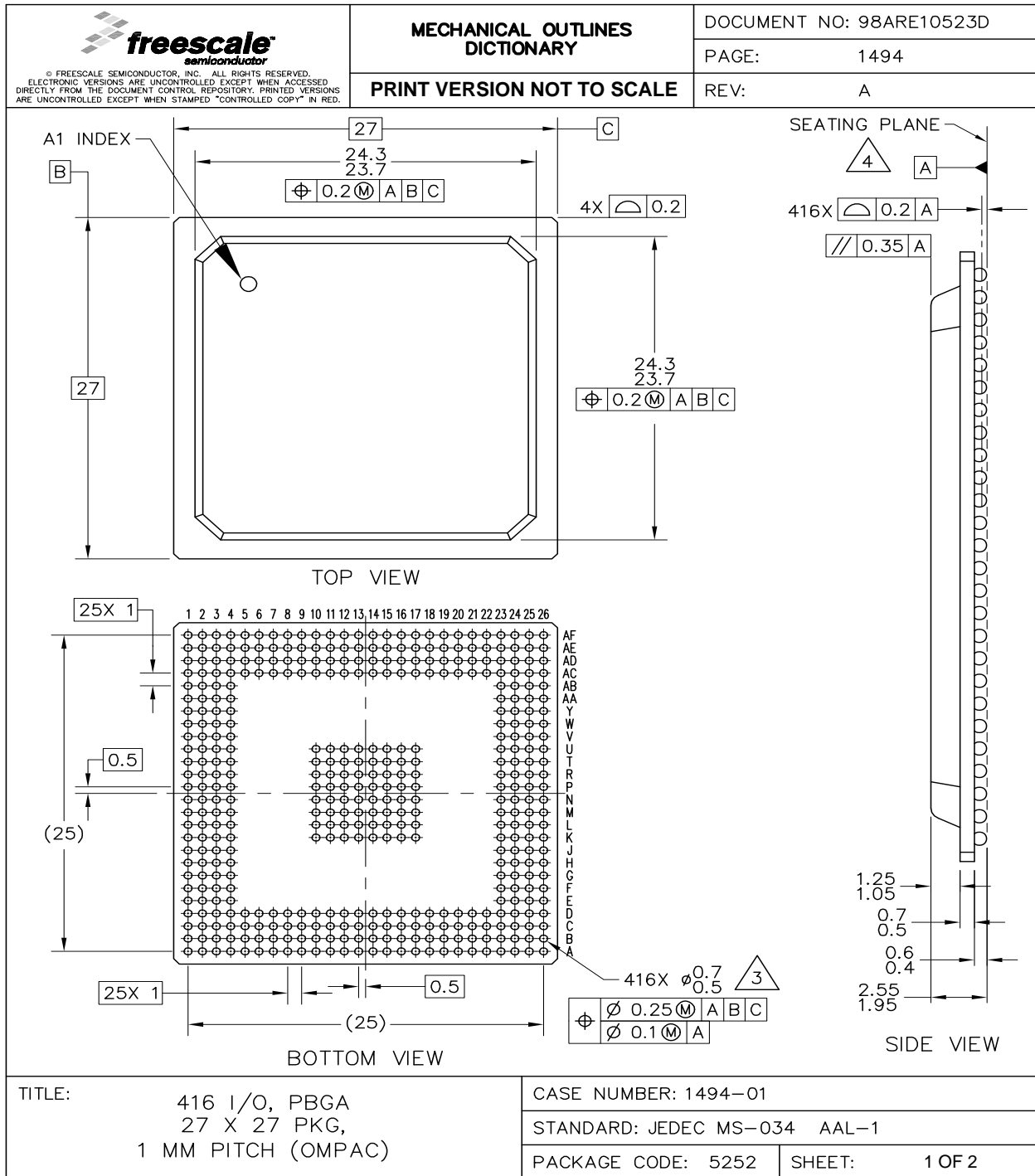


Figure 56. 416 TEPBGA Mechanical Drawing (Part 1 of 2)


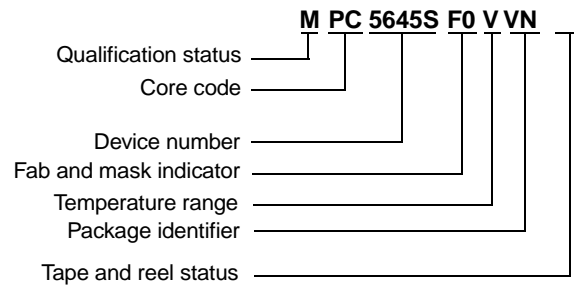
| | | | |
|---|---|------------------------------|---------------|
|  <small>© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED. ELECTRONIC VERSIONS ARE UNCONTROLLED EXCEPT WHEN ACCESSED DIRECTLY FROM THE DOCUMENT CONTROL REPOSITORY. PRINTED VERSIONS ARE UNCONTROLLED EXCEPT WHEN STAMPED "CONTROLLED COPY" IN RED.</small> | MECHANICAL OUTLINES DICTIONARY | DOCUMENT NO: 98ARE10523D | |
| | PRINT VERSION NOT TO SCALE | PAGE: | 1494 |
| REV: | | A | |
| <p>NOTES:</p> <ol style="list-style-type: none"> 1. ALL DIMENSIONS IN MILLIMETERS. 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994. 3. MAXIMUM SOLDER BALL DIAMETER MEASURED PARALLEL TO DATUM A. 4. DATUM A, THE SEATING PLANE, IS DETERMINED BY THE SPHERICAL CROWNS OF THE SOLDER BALLS. | | | |
| TITLE: 416 I/O, PBGA 27 X 27 PKG, 1 MM PITCH (OMPAC) | | CASE NUMBER: 1494-01 | |
| | | STANDARD: JEDEC MS-034 AAL-1 | |
| | | PACKAGE CODE: 5252 | SHEET: 2 OF 2 |

Figure 57. 416 TEPBGA Mechanical Drawing (Part 2 of 2)

6 Ordering information



Temperature range

C = ,Äi40 →x C to 85
V = ,Äi40 →x C to 105

Package identifier

LU = 176 LQFP Pb-free
LT = 208 LQFP Pb-free
VU = 416 TEPBGA Pb-free

Tape and reel status

R = Tape and reel
(blank) = Trays

Qualification status

P = Pre-qualification
M = Fully spec. qualified, general market flow
S = Fully spec. qualified, automotive flow

Note: Not all options are available on all devices. Refer to [Table 73](#).

Figure 58. Commercial product code structure

Table 73. Orderable part number summary

| Part number ¹ | Flash/SRAM | Package | Speed (MHz) |
|--------------------------|------------|----------------------|-------------|
| PPC5645SF0VLUA | 2 MB/64 KB | 176 LQFP (Pb free) | 125 |
| PPC5645SF0VLTA | 2 MB/64 KB | 208 LQFP (Pb free) | 125 |
| PPC5645SF0VVUA | 2 MB/64 KB | 416 TEPBGA (Pb free) | 125 |

¹ All packaged devices are PPC, rather than MPC or SPC, until product qualifications are complete. The unpackaged device prefix is PCC, rather than SCC, until product qualification is complete. Not all configurations are available in the PPC parts.

7 Revision history

Table 74. Revision history

| Revision (Date) | Description |
|--------------------|---|
| 1 (06 Oct 2009) | Initial release. |
| 2 (7 Dec 2009) | <p>Editorial changes.</p> <p>Extensive modifications throughout the “Pinout and signal descriptions” section.</p> <p>Revised the “Absolute maximum ratings” table.</p> <p>Revised the “Recommended operating conditions (3.3 V)” table.</p> <p>Revised the “Recommended operating conditions (5 V)” table.</p> <p>In the “Voltage regulator electrical characteristics” section, changed “NJD2783” to NJD2873”.</p> <p>Revised the “Interface to TFT LCD panels” section.</p> |
| 3 (3 Mar 2010) | <p>Editorial changes.</p> <p>Added the RoHS logo (indicating RoHS compliance).</p> <p>Added a “SpecID” column to specification tables throughout the document.</p> <p>In the device-comparison table:</p> <ul style="list-style-type: none"> • Revised the “Timed I/O” entry. • Changed “Nexus 3” to “Nexus Class 3”. <p>In the feature list:</p> <ul style="list-style-type: none"> • Revised the information for the TCON and RSDS interface. • In the ADC entry, changed “20 internal channels” to “Up to 20 internal channels”. • In the QuadSPI entry, changed “quad modes of operation” to “quad IO serial flash memory”. • In the DCU3 and DCULite entry, changed “WVGA” to “XGA”. <p>In the “Feature details” section:</p> <ul style="list-style-type: none"> • Revised some module abbreviations and names to be consistent with the rest of the documentation. • In the GFX2D section, deleted “and Adobe Flash 7”. • In the QuadSPI section, changed “Maximum frequency 80 MHz” to “Maximum serial clock frequency 80 MHz”. • In the FlexCAN section, changed “The FlexCan modules offer” to “Each FlexCAN module offers”. • In the DCULite section, changed “WVGA” to “XGA”. <p>In the 176-pin pinout, changed “MDD” to “MDO”.</p> <p>In the 208-pin pinout:</p> <ul style="list-style-type: none"> • For pin 105, changed “VDDE” to “VDDE_B”. • Renamed pin 145 (was VRSDS, is VREF_RSDS) • For pin 148, changed “RSRS3+P” to “RSDS3P”. • For pin 160, changed “SCL_D” to “SCL_3”. • For pin 161, changed “SDA_D” to “SDA_3”. • For pin 178, changed “DCULITE_G8” to “DCULITE_G6”. <p>In the 324-pin pinout:</p> <ul style="list-style-type: none"> • Renamed pin A1 (was VSS_DR, is VSS). • Renamed pin B2 (was VDDE_DDR, is VDD_DR). • Renamed pins D11 and J9 (were VDD33_DR, are VDDE_B). <p>Added the “Pad configuration during reset phases” section.</p> <p>In the “Voltage supply pin descriptions” table:</p> <ul style="list-style-type: none"> • Renamed V_{RSDS} to V_{REF_RSDS} and added a footnote about the pin’s required termination. • Added pin B2 to VDD_DR in the 324-pin package. • Moved pins D11 and J9 to V_{DDE_B}. <p>Revised the “System pin descriptions” table.</p> <p>Replaced the entire “DRAM interface pin summary” table.</p> <ul style="list-style-type: none"> • In the “Nexus pins” table, added a PCR column. |

Table 74. Revision history (continued)

| Revision (Date) | Description |
|-------------------------------|---|
| 3 (continued) (3 Mar 2010) | <p>Added the “VIU muxing” section.</p> <p>Added the “System design information” section and a “Power-up sequencing” subsection.</p> <p>In the “Recommended operating conditions (3.3 V)” table, revised footnotes 2 and 4.</p> <p>In the “Recommended operating conditions (5.0 V)” table, revised footnotes 3 and 5.</p> <p>Revised the text in the “Voltage regulator electrical characteristics” section.</p> <p>Added meaningful content to the “DC electrical characteristics” section.</p> <p>In the “Reset electrical characteristics” table, changed the specifications for W_{FRST} (was max 40 ns, is max 70 ns) and W_{NFRST} (was min 1000 ns, is min 400 ns).</p> <p>Replaced the entire “Pad AC specifications” section.</p> <p>Added meaningful content to the “Video Input Unit timing” section.</p> <p>Added orderable part numbers.</p> <p>Revised the “Commercial product code structure” figure.</p> |
| 4 (24 Jun 2010) | <p>Editorial changes and improvements.</p> <p>In the device-comparison table, changed the GPIO count for the 176-pin package (was 127, is 128).</p> <p>In the feature list:</p> <ul style="list-style-type: none"> • Changed “4 KB, 2-way instruction cache” to “4 KB, 2/4-way instruction cache”. • Changed “32 kHz crystal oscillator” to “32 KHz crystal oscillator”. • Changed “188 peripheral interrupt sources” to “181 peripheral interrupt sources”. • Changed “Primary FMPLL” to “Primary FMPLL (FMPLL0)”. • Changed “Auxiliary FMPLL” to “Auxiliary FMPLL (FMPLL1)”. • In the crossbar switch description, deleted the reference to AMBA. • In the SGM description, changed “WAV file” to “PCM wave”. • Revised the RLE decoder description. • In the SIUL description, deleted “resets”. • In the CMU section, changed “PLL” to “primary FMPLL (FMPLL0)”. <p>In the feature details:</p> <ul style="list-style-type: none"> • Changed “32 kHz oscillator” to “32 KHz oscillator”. • Changed “128 KHz oscillator” to “128 kHz oscillator”. • Revised the “Low-power operation” section. • In the ADC section, changed “0 to 5V common mode conversion range” to “0–5 V or 0–3.3 V common mode conversion range”. • Revised the DCU3 section. • In the “On-chip graphics SRAM” section, added an entry for independent data buffers. • In the MPU section, changed “Protection offered for 3 concurrent read ports” to “Protection offered for 4 concurrent read ports”. <p>In the 176-pin pinout:</p> <ul style="list-style-type: none"> • Added content to indicate which functions are available only in this package. • For pin 116, changed PD113 to PDI13. • For pin 117, changed PD114 to PDI14. • For pin 1, changed DCU_VSYNC_TCON2 to DCU_VSYNC. • For pin 2, changed DCU_HSYNC_TCON1 to DCU_HSYNC. • For pin 3, changed DCU_DE_TCON3 to DCU_DE. • For pin 16, changed DCU_TAG_TCON3 to DCU_TAG. • For pin 56, changed PDI0(VIU0) to PDI0_VIU0. • For pin 57, changed PD11(VIU1) to PDI1_VIU1. • For pin 58, changed PDI12(VIU2) to PDI2_VIU2. • For pin 59, changed PDI3(VIU3) to PDI3_VIU3. • For pin 148, deleted TCON0. • For pin 155, deleted DCULITE_G7. |

Table 74. Revision history (continued)

| Revision (Date) | Description |
|--|--|
| <p>4 (continued) (24 Jun 2010)</p> | <p>In the 208-pin pinout:</p> <ul style="list-style-type: none"> • For pin 68, changed eMIOA23 to eMIOS0[23]. • For pin 69, changed eMIOA16 to eMIOS0[16]. • For pin 70, changed eMIOA15 to eMIOS0[15]. • For pin 71, changed eMIOA14 to eMIOS0[14]. <p>In the 324-pin pinout:</p> <ul style="list-style-type: none"> • Added content to indicate which functions are available only in this package. • Renamed pin J10 (was VSS_DR, is VSS). <p>In the “Voltage supply pin descriptions” table:</p> <ul style="list-style-type: none"> • Deleted the entry for VSS_DR. • Added pin J10 to the VSS group in the 324-pin package. <p>Revised the “Nexus pins” table.</p> <p>In the “Recommended operating conditions (3.3 V)” table, changed the specification for TV_{DD} (was 0.25 V/μs, is 12 V/ms).</p> <p>In the “Recommended operating conditions (5.0 V)” table, changed the specification for TV_{DD} (was 0.25 V/μs, is 12 V/ms).</p> <p>In the “FMPLL electrical characteristics” table, changed footnote 6 (was “f_{CPU} 64 MHz can be achieved only at up to 105 °C”, is “f_{CPU} of 125 MHz can be achieved only at temperatures up to 105 °C with a maximum FM depth of 2%.”.)</p> <p>In the “DC specification for CMOS090LP2 library @ VDDE = 3.3 V” > “DC electrical specifications” table, deleted the specifications for Vih_pci and Vil_pci.</p> <p>Revised the “Low power oscillator electrical characteristics” table.</p> <p>In the “ADC electrical characteristics” table, changed “V_{DD}-0.1” to “V_{DDE_A}-0.1” and “V_{DD}+0.1” to “V_{DDE_A}+0.1”.</p> <p>Renamed “QuadSPI2 Timing” to “QuadSPI timing” and added meaningful content.</p> <p>Added the “TCON/RSDS timing” section.</p> |
| <p>5 (25 Feb 2011)</p> | <p>In the “Feature List” section:</p> <ul style="list-style-type: none"> • Changed RTC optional clocking from “main” to “fast” 4-16 MHz external oscillator. • Changed CMU monitor feature from “main crystal oscillator” to “fast (4–16 MHz) external crystal oscillator”. <p>In the “Feature details” section, changed “main oscillator” to “external oscillator” in the “System clocks and clock generation modules” section.</p> <p>In the “Pad configuration during reset phases” section, changed “Main oscillator pads” to “Fast (4-16 MHz oscillator pads”.</p> <p>In the “Voltage supply pin descriptions” table, changed V_{DD_DR} function from “DDR SDRAM interface supply” to “1.8V, 2.5V, and 3.3V SDRAM supply”.</p> <p>In the “System pin descriptions” table, specified an external capacitor value of 47pF in the footnote.</p> <p>In the “Functional ports” section, added list of pad types.</p> <p>In the “Power-up sequencing” section:</p> <ul style="list-style-type: none"> • Added list item that specifies VDDE_B and VDD33_DR are to be powered up first. • Added VDD33_DR to the list of generic I/O or noise-free supplies. • Added details to VREG HV list item. • Changed post-list text regarding DDR to be a separate NOTE, and identified the 3.3V supply as VDD33_DR. • Added power-up information to the LV supply (VDD12) list item. • Added “Parameter classification” section and accompanying table. <p>Added “C” classification column and values to tables throughout the “Electrical characteristics” section.</p> |

Table 74. Revision history (continued)

| Revision (Date) | Description |
|--------------------------------|--|
| 5 (continued) (25 Feb 2011) | <p>In the “Absolute maximum ratings” table:</p> <ul style="list-style-type: none"> • Changed max value for V_{DDE_B} from 5.5V to 3.6 V. • Changed max value for V_{DD_DR} from TBD to 3.6 V. • Changed max value for V_{RSDS} from TBD to 3.6 V. • Changed max value for V_{IN} from 5.5V to “V_{DDmax} (VDDE max of that segment)”. • Removed “Relative to V_{DD}” condition for V_{IN}. <p>In the “Recommended operating conditions (3.3 V)” table:</p> <ul style="list-style-type: none"> • Changed min value for “V_{DD}” from 3.0 V to “V_{DDmin}”. • Changed max value for “V_{DD}” from 3.6 V to “V_{DDmax}”. • Changed V_{DD} entry to include only V_{DDE_A}, V_{DDE_B}, V_{DD_DR}, and V_{DDM}. • Corrected error in V_{DDE_A} entry, changed reference in “parameter” column from V_{DDE_C} to V_{DDE_A}. • Added V_{DD_DR} to the V_{DD} footnote. <p>In the “Recommended operating conditions (5.0 V)” table:</p> <ul style="list-style-type: none"> • Added footnote for V_{DDE_B} max values. • Added footnote for V_{DD_DR} typ values. • Changed min and max values for V_{DD_DR} from 4.5V and 5.5V to 3.0V and 3.6V, respectively. • Changed max value for V_{DD_DR} (under “voltage drop” conditions) from 5.5V to 3.6V. • Changed min and max values for V_{DD} from 4.5V and 5.5V to V_{DDmin} and V_{DDmax}, also referenced footnote 6. • Removed V_{DDE_C} and V_{DDE_E} from the V_{DD} “parameter” description and footnote, and added V_{DD_DR}. • Changed min and max values for V_{DDE_B} from 4.5V and 5.5V to 3.0V and 3.6V, respectively. <p>Removed the “Libraries” column from the DC specifications “library” tables.</p> <p>Removed the 75Ω and 50Ω cases and added details on the 150Ω case in the “ODT DC electrical characteristics” table.</p> <p>Changed the “Main oscillator electrical characteristics” section name to “Fast external crystal oscillator (4-16 MHz) electrical characteristics” and modified text and table name within the section appropriately.</p> <p>Removed the “Full swing Pierce” condition and the relevant footnotes from the “Fast external crystal oscillator (4-16 MHz) electrical characteristics” table.</p> <p>Changed the “Low power oscillator electrical characteristics” section name to “Slow external crystal oscillator (32 KHz) electrical characteristics” and modified the text, figure, and table names within the section appropriately.</p> <p>Changed “main oscillator” to “fast external oscillator” in the “FMPLL electrical characteristics” table. Updated parameters, conditions, and values in the “FMPLL electrical characteristics” table.</p> <p>Changed the “Main RC oscillator electrical characteristics” section name to “Fast Internal RC oscillator (16 MHz) electrical characteristics” and modified the text and table name within the section appropriately.</p> <p>Changed the “Low power RC oscillator electrical characteristics” section name to “Slow Internal RC oscillator (128 KHz) electrical characteristics” and modified the text and table name within the section appropriately.</p> <p>Removed duplicate entry of TUEP in the “ADC electrical characteristics” table.</p> <p>Removed pad_pci and pad_osc48 from the “Functional pad type AC specifications” table because they are not used.</p> <p>Added new “Pad mode configurations” table to the “DRAM Interface” section.</p> <p>Changed the 324-pin TEPBGA pinout to 416-pin TEPBGA.</p> <p>Changed the 324-pin TEPBGA mechanical drawing to 416-pin TEPBGA.</p> |

Table 74. Revision history (continued)

| Revision (Date) | Description |
|--|--|
| <p>5 (continued) (25 Feb 2011)</p> | <p>In the "Operating mode summary" table:</p> <ul style="list-style-type: none"> • Changed the "RAM" column to "SRAM". • Changed "STOP" for "16MHz IRC" from "OP" to "On". • Changed "STOP" for "Graphics RAM" from "On" to "CG". • Changed "STANDBY" for "128KHz IRC" from "OP" to "ON" (both cases). <p>Changed "324BGA" to "416BGA" in the "Nexus Development Interface (NDI)" section. Updated all data in the "Thermal characteristics for 176-pin LQFP" table. Updated all data in the "Thermal characteristics for 208-pin LQFP" table. Changed "324" in the "Thermal characteristics for 324-pin TEPBGA" table title to "416". Added Spec ID numbers to the "DC electrical specifications" tables throughout the "DC electrical specifications" section. Updated the NOTE reference details in the "DC specification for CMOS090LP2 library @ VDDE = 3.3 V" and "DC specification for CMOS090LP2fg library @ VDDE = 5.0 V" sections. Added Spec ID numbers to the "QuadSPI timing specifications" tables. Added Spec ID numbers to the "TCON/RSDS timing" table. Added values into the empty cells in the "TCON/RSDS timing" table. In the "Orderable part number summary" table:</p> <ul style="list-style-type: none"> • Changed "324" to "416". • Updated the part numbers. <p>Corrected presentation problem with the 176 LQFP figure.</p> |
| <p>6 (09 Aug 2011)</p> | <p>Changed "324" to "416" in the "SC667108 device comparison" table. Changed I/O direction for EXTAL from "O" to "I" in the "System pin descriptions" table. Changed I/O direction for XTAL from "I" to "O" in the "System pin descriptions" table. In the "VDDE_A" entry of the "Recommended operating conditions (3.3 V)" table, changed "V_{SSE_C}" to "V_{SSE_A}". In the "VDDE_A" entry of the "Recommended operating conditions (5.0 V)" table, changed "VDDE_C" to "VDDE_A". In the "VDDE_A" entry of the "Recommended operating conditions (3.3 V)" table, changed "V_{SSE_C}" to "V_{SSE_A}". In the "V_{SS}" footnote of the "Recommended operating conditions (5.0 V)" table, changed "V_{SSE_C}" to "V_{SSE_A}". Removed "QuadSPI timing specifications, maximum temperature 150 C" table. Removed "DC electrical characteristics" table in "Low voltage domain power consumption" section and inserted a new table. In the "Supply leakage" table, changed "spor" to "sPCR". Removed "pad_multv_hv" and "pull_hv" entries from "Functional pad type AC specifications" table. Removed "pad_multv_hv", "pad_io_hv" and "lvds_ref_hv" entries from "Supply leakage" table. Updated values in "VIU2 timing parameters" table. Removed "pad_fsr" and "pad_pci" parameters from "Supply leakage" table. Added Figure 28 - RSDS/TCON Timing Diagram Added four tables in "DRAM interface" section.</p> |

Table 74. Revision history (continued)

| Revision (Date) | Description |
|----------------------------|--|
| <p>7 (7 Feb 2012)</p> | <p>I_{DDRUN} values updated in “DC electrical characteristics” table. Min and max values of V_{DD12} in “Voltage regulator electrical characteristics” table changed to 1.26 V and 1.29 V, respectively. T_B changed to T_A for IDDHALT value in “DC electrical characteristics” table. Removed ΔRCMTRIM values from “Fast internal RC oscillator (16 MHz) electrical characteristics” table. Removed ΔRCMTRIM values from “Slow internal RC oscillator (128 KHz) electrical characteristics” table. Changed max T_j to 140 C in “Recommended operating conditions (3.3V)” table. Changed max T_j to 140 C in “Recommended operating conditions (3.3V)” table. Changed max T_j to 140 C in “Voltage regulator electrical characteristics” table. Changed spec limits on VDD12 Post-Trimming, from min=1.270, max = 1.28 to min = 1.145, max = 1.32, in “Voltage regulator electrical characteristics” table. Added “Low-power voltage regulator electrical characteristics” table. Added “Ultra low-power voltage regulator electrical characteristics” table. Offset and gain error values changed to 0.5 and 0.6 Typ, respectively, in “ADC electrical characteristics” table. Added “Power-up sequencing” and “Power-down sequencing” diagrams in “Power-up Sequencing” section. Added “LPDDR, DDR and DDR2 (DDR2-250) SDRAM timing specifications” table in “DRAM Interface” section and removed specifications’ tables for DDR1 mode, DDR2 mode and LPDDR mode. Updated VLVDHV3H, VLVDHV3L, VLVDHV5H and VLVDHV5L values in “Low voltage monitor electrical characteristics” table. Updated I_{DDHALT} Typ and Max values in “DC electrical characteristics” table. Changed P25 pin to VSS pin in “416 TEPBGA pinout” figure.</p> |
| <p>8 (08 Aug 2012)</p> | <p>In “Absolute maximum Ratings” table, changed max value of V_{DDPLL} from 1.32 V to 1.4 V. In “DC Electrical Characteristics” table, updated max values of I_{DDMAX}, I_{DDHALT}, I_{DDSTOP} and I_{DDSTDBY1}. Removed 1.32 V value for V_{DD}, from “DC electrical specifications at 3.3 V VDDE”, “DC electrical specifications at 2.5 V VDDE” and “DC electrical specifications at 1.8 V VDDE”.</p> |

How to Reach Us:

Home Page:

www.freescale.com

Web Support:

<http://www.freescale.com/support>

USA/Europe or Locations Not Listed:

Freescale Semiconductor, Inc.
Technical Information Center, EL516
2100 East Elliot Road
Tempe, Arizona 85284
1-800-521-6274 or +1-480-768-2130
www.freescale.com/support

Europe, Middle East, and Africa:
Freescale Halbleiter Deutschland GmbH
Technical Information Center
Schatzbogen 7
81829 Muenchen, Germany
+44 1296 380 456 (English)
+46 8 52200080 (English)
+49 89 92103 559 (German)
+33 1 69 35 48 48 (French)
www.freescale.com/support

Japan:

Freescale Semiconductor Japan Ltd. Headquarters
ARCO Tower 15F
1-8-1, Shimo-Meguro, Meguro-ku,
Tokyo 153-0064
Japan
0120 191014 or +81 3 5437 9125
support.japan@freescale.com

Asia/Pacific:

Freescale Semiconductor China Ltd.
Exchange Building 23F
No. 118 Jianguo Road
Chaoyang District
Beijing 100022
China
+86 10 5879 8000
support.asia@freescale.com

Freescale Semiconductor Literature Distribution Center
1-800-441-2447 or +1-303-675-2140
Fax: +1-303-675-2150
LDCForFreescaleSemiconductor@hibbertgroup.com

Information in this document is provided solely to enable system and software implementers to use Freescale Semiconductor products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits or integrated circuits based on the information in this document.

Freescale Semiconductor reserves the right to make changes without further notice to any products herein. Freescale Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Freescale Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters that may be provided in Freescale Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals", must be validated for each customer application by customer's technical experts. Freescale Semiconductor does not convey any license under its patent rights nor the rights of others. Freescale Semiconductor products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Freescale Semiconductor product could create a situation where personal injury or death may occur. Should Buyer purchase or use Freescale Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold Freescale Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Freescale Semiconductor was negligent regarding the design or manufacture of the part.

Freescale™ and the Freescale logo are trademarks of Freescale Semiconductor, Inc. The described product contains a PowerPC processor core. The PowerPC name is a trademark of IBM Corp. and used under license. All other product or service names are the property of their respective owners.

© Freescale Semiconductor, Inc. 2010–2012. All rights reserved.

MPC5645S
Rev. 8
08/2012

